

# BQ25960H I<sup>2</sup>C 制御、バイパス モードおよびデュアル入力選択機能搭載単一セル 8A スイッチト キャパシタ パラレル バッテリ チャージャ

## 1 特長

- 8A の高速充電をサポートするピーク効率 98.1% のスイッチト・キャパシタ・パラレル充電器
- 最高効率を実現するよう最適化されたデュアルフェーズ・スイッチト・キャパシタ・アーキテクチャ (特許出願中)
  - 入力電圧はバッテリー電圧の 2 倍
  - 出力電流は入力電流の 2 倍
  - 入力ケーブルの電源損失を低減
- 5A バイパス・モード高速充電機能を搭載
  - 5A 入力と 5A 出力充電電流をサポートする  $R_{\text{dson}}$  21m $\Omega$  の充電パス抵抗
- 高速充電中の電源選択と USB On-The-Go (OTG) / 逆方向 TX モードに対応可能なデュアル入力電源マルチプレクサ・コントローラ
- 外部 OVP (過電圧保護) GaN FET および OVP N-FET にゲート駆動信号を供給
- 最小 1.2V の I<sup>2</sup>C ブルアップをサポート
- 幅広い入力電圧をサポート
  - 最大 12.75V の動作時入力電圧
  - 最大 40V の入力電圧に加え、外付け ACFET および外付け ACFET なしの 20V をオプション追加可能
- 最大 13A の充電電流で、同期動作する 2 台の BQ25960H に並列充電が可能
- 安全な動作の実現に役立つ、プログラマブルな各種保護機能を統合
  - 入力過電圧保護 (BUSOVP) およびバッテリー過電圧保護 (BATOVP)
  - 入力過電流保護 (BUSOCP) およびバッテリー過電流保護 (BATOCP)
  - 出力過電圧保護 (VOOUTVP)
  - 入力低電流保護 (BUSUCP) と入力逆電流保護 (BUSRCP) によるアダプタの抜け検出およびブーストバック防止機能
  - バッテリーおよびコネクタ温度のモニタリング機能 (TSBAT\_FLT および TSBUS\_FLT)
  - 接合部過熱保護 (TDIE\_FLT)
- プログラム可能な設定によるシステム最適化
  - 割り込みおよび割り込みマスク
  - ADC の読み取りと構成
  - ホスト制御用アラーム機能
- 電圧、電流、温度モニタリングのための 16 ビット ADC を内蔵

## 2 アプリケーション

- スマートフォン
- タブレット

## 3 概要

BQ25960H は、1 セルのリチウムイオン バッテリ向けのスイッチ キャパシタ アーキテクチャを使用した、ピーク効率 98.1% の 8A バッテリ充電ソリューションです。スイッチト・キャパシタ・アーキテクチャにより、ケーブル電流は充電電流の半分になり、その結果、ケーブルの電源損失を低減して、温度上昇を抑えることができます。デュアルフェーズ・アーキテクチャにより、充電効率が上がり、入力と出力に必要な容量は減少します。BQ2561x または BQ2589x などのメイン充電器と組み合わせて使用すると、システムは定電流 (CC) および定電圧 (CV) モードにおける電力損失を低減することで、トリクル充電から終端までのフル充電サイクルを有効にすることが可能です。

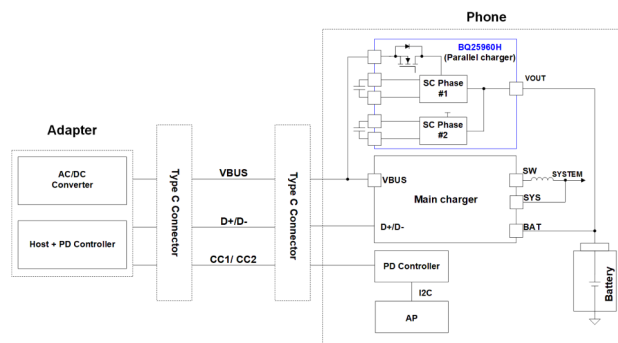
BQ25960H は、内蔵 MOSFET を経由する 5A バイパスモード充電 (旧名称はバッテリー スイッチ充電) に対応しています。バイパス・モード充電経路の  $R_{\text{dson}}$  は、大電流動作時で 21m $\Omega$  です。内蔵のバイパス・モードは 5V 高速充電アダプタとの下位互換性があり、1 セルのバッテリーを充電することが可能です。

このデバイスは、内蔵のマルチプレクサ制御と外付け N-FET 用ドライバを経由するデュアル入力構成に対応しています。また、外付け N-FET がない場合や、単一 N-FET におけるシングル入力も可能です。

### パッケージ情報

部品番号	パッケージ <sup>(1)</sup>	本体サイズ (公称)
BQ25960H	DSBGA (36)	2.55mm x 2.55mm

(1) 供給されているすべてのパッケージについては、[セクション 14](#) を参照してください。



概略回路図



## Table of Contents

<b>1 特長</b> .....	<b>1</b>	<b>9 Application and Implementation</b> .....	<b>64</b>
<b>2 アプリケーション</b> .....	<b>1</b>	9.1 Application Information.....	64
<b>3 概要</b> .....	<b>1</b>	9.2 Typical Application.....	64
<b>4 概要 (続き)</b> .....	<b>3</b>	<b>10 Power Supply Recommendations</b> .....	<b>70</b>
<b>5 Device Comparison Table</b> .....	<b>4</b>	<b>11 Layout</b> .....	<b>71</b>
<b>6 Pin Configuration and Functions</b> .....	<b>5</b>	11.1 Layout Guidelines.....	71
<b>7 Specifications</b> .....	<b>7</b>	11.2 Layout Example.....	71
7.1 Absolute Maximum Ratings.....	7	<b>12 Device and Documentation Support</b> .....	<b>72</b>
7.2 ESD Ratings.....	7	12.1 Device Support.....	72
7.3 Recommended Operating Conditions.....	7	12.2 Documentation Support.....	72
7.4 Thermal Information.....	8	12.3 ドキュメントの更新通知を受け取る方法.....	72
7.5 Electrical Characteristics.....	8	12.4 サポート・リソース.....	72
7.6 Timing Requirements.....	12	12.5 Trademarks.....	72
7.7 Typical Characteristics.....	13	12.6 静電気放電に関する注意事項.....	72
<b>8 Detailed Description</b> .....	<b>15</b>	12.7 用語集.....	72
8.1 Overview.....	15	<b>13 Revision History</b> .....	<b>72</b>
8.2 Functional Block Diagram.....	16	<b>14 Mechanical, Packaging, and Orderable Information</b> .....	<b>73</b>
8.3 Feature Description.....	17	14.1 Package Option Addendum.....	74
8.4 Programming.....	30	14.2 Tape and Reel Information.....	75
8.5 Register Maps.....	33		

## 4 概要 (続き)

このデバイスには、安全な充電をサポートするために必要なすべての保護機能が搭載されています。例として、入力過電圧および過電流保護、出力過電圧および過電流保護、入力低電流および逆電流保護、バッテリーとケーブルの温度センシング、スイッチト キャパシタとバイパス モードの両方に対応した接合部過熱保護機能が挙げられます。

このデバイスには **16 ビットのアナログ / デジタル コンバータ (ADC)** が内蔵されており、**VAC** 電圧、バス電圧、バス電流、出力電圧、バッテリー電圧、バッテリー電流、入力コネクタ温度、バッテリー温度、接合部温度、およびアダプタやワイヤレス入力やパワーバンクからのバッテリー充電を管理するために必要なその他の算出測定値を提供します。

## 5 Device Comparison Table

FUNCTION	BQ25960	BQ25960H
Package	YBG-36	YBG-36
Die size	6.5 mm <sup>2</sup>	6.5 mm <sup>2</sup>
Battery	1 cell	1 cell
Input MUX control	Dual input power MUX control	Dual input power MUX control
Bypass Mode	Yes	Yes
Minimum I2C voltage	1.8 V	1.2 V
GaN FET Support	No	Yes
Recommended charging current	8 A	8 A
Default VAC2OVP	6.5 V	14 V

## 6 Pin Configuration and Functions

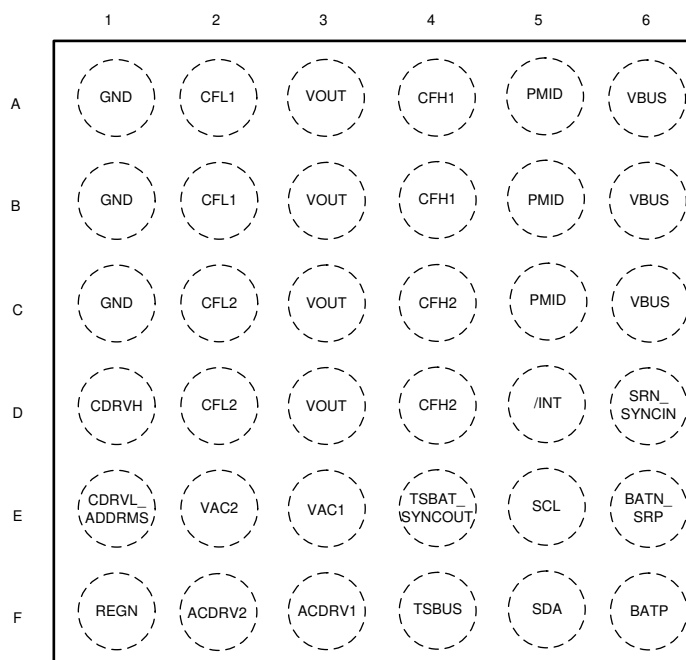


図 6-1. YBG Package - BQ25960H 36-Pin DSBGA Top View

表 6-1. Pin Functions

PIN		TYPE <sup>(1)</sup>	DESCRIPTION
NO.	NAME		
F3	ACDRV1	P	<b>Input FETs Driver Pin 1</b> - The charge pump output to drive the port #1 input N-channel MOSFET (ACFET1) and the reverse blocking N-channel MOSFET (RBFET1). ACDRV1 voltage becomes 5 V above the common drain connection of the ACFET1 and RBFET1, when the turn-on condition is met. If ACFET1 and RBFET1 are not used, connect ACDRV1 to ground.
F2	ACDRV2	P	<b>Input FETs Driver Pin 2</b> -The charge pump output to drive the port #2 input N-channel MOSFET (ACFET2) and the reverse blocking N-channel MOSFET (RBFET2). ACDRV2 voltage becomes 5 V above the common drain connection of the ACFET2 and RBFET2, when the turn-on condition is met. If ACFET2 and RBFET2 are not used, connect ACDRV2 to ground.
E6	BATN_SRP	AI	<b>Negative input for battery voltage sensing and positive input for battery current sensing</b> - Connect to negative terminal of battery pack. It is also used for battery current sensing. Place RSNS (2 mΩ or 5 mΩ) between BATN_SRP and SRN_SYNCIN. Short BATN_SRP to SRN_SYNCIN together and place 100-Ω series resistance between pin and negative terminal if RSNS is not being used.
F6	BATP	AI	<b>Positive input for battery voltage sensing</b> - Connect to positive terminal of battery pack. Place 100-Ω series resistance between pin and positive terminal.
D1	CDRVH	AIO	<b>Charge pump for gate drive</b> - Connect a 0.22-μF cap between CDRVH and CDRVL_ADDRMS.
E1	CDRVL_ADDRMS	AIO	<b>Charge pump for gate drive</b> - Connect a 0.22-μF cap between CDRVH and CDRVL_ADDRMS. During Power ON Reset (POR), this pin is used to assign the address of the device and the mode of the device as Standalone, Primary, or Secondary.
A4, B4	CFH1	P	<b>Switched cap flying cap connection</b> -Connect 1 to 3 22-μF caps in parallel between this pin and CFL1.
C4, D4	CFH2	P	<b>Switched cap flying cap connection</b> -Connect 1 to 3 22-μF caps in parallel between this pin and CFL2.
A2, B2	CFL1	P	<b>Switched cap flying cap connection</b> -Connect 1 to 3 22-μF caps in parallel between this pin and CFH1.

表 6-1. Pin Functions (続き)

PIN		TYPE <sup>(1)</sup>	DESCRIPTION
NO.	NAME		
C2, D2	CFL2	P	<b>Switched cap flying cap connection</b> -Connect 1 to 3 22-μF caps in parallel between this pin and CFH2.
D5	INT	DO	<b>Open drain, active low interrupt output</b> - Pull up to voltage with 10-kΩ resistor. Normally high, the device asserts low to report status and faults. INT is pulsed low for $t_{INT}$ .
A1, B1, C1	GND	P	<b>Ground return</b>
A5, B5, C5	PMID	P	<b>Input to the switched cap power stage</b> -Connect 10-μF cap to PMID.
F1	REGN	AO	<b>Charger internal LDO output</b> - Connect a 4.7-μF cap between this pin and GND. When in Primary/Secondary Mode, connect through 1-kΩ resistor to the TSBAT_SYNCOUT and SRN_SYNCIN pins. Do not use REGN for any other function.
E5	SCL	DI	<b>I<sup>2</sup>C interface clock</b> - Pull up to 3.3 V with 10-kΩ resistor.
F5	SDA	DIO	<b>I<sup>2</sup>C interface data</b> - Pull up to 3.3 V with 10-kΩ resistor.
D6	SRN_SYNCIN	AI	<b>Negative input for battery current sensing</b> - Place RSNS (2 mΩ or 5 mΩ) between SRN_SYNCIN and SRP. Short to SRP and SRN_SYNCIN together if not used. If configured as a secondary for dual charger configuration, this pin functions as SYNCIN, and connect to TSBAT_SYNCOUT of Primary, and connect a 1-kΩ pullup resistor to REGN.
E4	TSBAT_SYNCOUT	AI	<b>Battery temperature voltage input and Primary Mode SYNCOUT</b> - Requires external resistor divider, NTC, and voltage reference. See the TSBAT section for choosing the resistor divider values. If the device is in Primary Mode, connect this pin to SRN_SYNCIN of the Secondary device.
F4	TSBUS	AI	<b>BUS temperature voltage input</b> - Requires external resistor divider, NTC, and voltage reference. See the TSBUS section for choosing the resistor divider values.
A6, B6, C6	VBUS	P	<b>Device power input</b> - Connect 1-μF capacitor from VBUS to GND.
A3, B3, C3, D3	VOUT	P	<b>Device power output</b> - Connect 22-μF capacitor from VOUT to GND.
E3	VAC1	AI	<b>VAC1 input detection</b> - Connected to VBUS if ACFET1 and RBFET1 are not used.
E2	VAC2	AI	<b>VAC2 input detection</b> - Connected to VBUS if ACFET2 and RBFET2 are not used.

(1) Type: P = Power , AIO = Analog Input/Output , AI = Analog Input, DO = Digital Output, AO = Analog Output, DIO = Digital Input/Output

## 7 Specifications

### 7.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

		MIN	MAX	UNIT
Voltage	VAC1, VAC2 (converter not switching)	–2	40	V
	VBUS (converter not switching)	–2	20	V
	PMID (converter not switching)	–0.3	20	V
	ACDRV1, ACDRV2	–0.3	30	V
	CFL1, CFL2	–0.3	7	V
	CFH1 to VOUT, CFH2 to VOUT	–0.3	7	V
	VOUT	–0.3	7	V
	BATP, BATN_SRP	–0.3	6	V
	INT, SDA, SCL, CDRVL_ADDRMS, SRN_SYNCIN, TSBAT_SYNCOUT, TSBUS	–0.3	6	V
	CDRVH	–0.3	20	V
Output Sink Current	INT		6	mA
T <sub>J</sub>	Junction temperature	–40	150	°C
T <sub>stg</sub>	Storage temperature	–55	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 7.2 ESD Ratings

			VALUE	UNIT
V <sub>(ESD)</sub>	Electrostatic discharge	Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>	±2000	V
		Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup>	±250	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
VAC1, VAC2	Input voltage at VAC1 and VAC2			12	V
VBUS	Input voltage at VBUS			12	V
PMID	Input voltage at PMID			12	V
PMID-CFH1, PMID-CFH2	Voltage across QCH1, QCH2			6	V
CFH1-VOUT, CFH2-VOUT	Voltage across QDH1, QDH2			6	V
VOUT-CFL1, VOUT-CFL2	Voltage across QCL1, QCL2			6	V
CFL1, CFL2	Voltage across QDL1, QDL2			6	V
ICHG	Charging current			8	A
T <sub>A</sub>	Ambient temperature	–40		85	°C
T <sub>J</sub>	Junction temperature	–40		120	°C
C <sub>CFLY</sub>	Effective CFLY capacitance	6.6	20		μF
C <sub>VBUS</sub>	Effective VBUS capacitance	0.2	1		μF
C <sub>PMID</sub>	Effective PMID capacitance	2	10		μF

### 7.3 Recommended Operating Conditions (続き)

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
C <sub>OUT</sub>	Effective VOUT capacitance	2	10		μF
C <sub>REGN</sub>	Effective REGN capacitance	1	4.7		μF
C <sub>DRV</sub>	Effective DRV capacitance	44	220		nF

### 7.4 Thermal Information

THERMAL METRIC <sup>(1)</sup>		BQ25960	UNIT
		YBG (DSBGA)	
		36 PINS	
R <sub>θJA</sub>	Junction-to-ambient thermal resistance (JEDEC <sup>(1)</sup> )	54.8	°C/W
R <sub>θJC(top)</sub>	Junction-to-case (top) thermal resistance	0.2	°C/W
R <sub>θJB</sub>	Junction-to-board thermal resistance	12	°C/W
Ψ <sub>JT</sub>	Junction-to-top characterization parameter	0.1	°C/W
Ψ <sub>JB</sub>	Junction-to-board characterization parameter	11.9	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

### 7.5 Electrical Characteristics

VBUS=8V, VOUT=4V, T<sub>J</sub> = -40°C to +85°C, and T<sub>J</sub> = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
QUIESCENT CURRENTS							
I <sub>Q_BAT</sub>	Quiescent battery current	ADC disabled, charge disabled, VBUS, VAC1, and VAC2 not present, VBAT=4V		12	20	μA	
		ADC enabled (slowest mode), charge disabled, VBUS, VAC1, and VAC2 not present, VBAT=4V		480	750	μA	
I <sub>Q_VAC</sub>	Quiescent VAC current	ADC disabled, charge disabled, ACDRV disabled, EN_HIZ=1, VAC1 or VAC2 =8V		90		μA	
		ADC enabled, charge disabled, ACDRV enabled, VAC1 or VAC2= 8V		1330		μA	
INTERNAL THRESHOLD							
V <sub>VACUVLOZ</sub>	VAC rising threshold for active I <sup>2</sup> C, no VOUT, no VBUS	VAC1 or VAC2 rising		3.24	3.4	3.6	V
V <sub>VACUVLO</sub>	VAC falling threshold for I <sup>2</sup> C stop working	VAC1 or VAC2 falling		3.05	3.2	3.4	V
V <sub>VACPRESENT</sub>	VAC rising threshold to turn on ACFET-RBFET	VAC1 or VAC2 rising		3.3	3.4	3.5	V
	VAC falling threshold to turn off ACFET-RBFET	VAC1 or VAC2 falling		3.1	3.2	3.3	V
V <sub>VBUSUVLOZ</sub>	VBUS rising threshold for active I <sup>2</sup> C, no VOUT, no VAC	VBUS rising		3.24	3.4	3.6	V
V <sub>VBUSUVLO</sub>	VBUS falling threshold for I <sup>2</sup> C stop working	VBUS falling		2.65	2.8	2.95	V
V <sub>VBUSPRESENT</sub>	VBUS rising threshold to allow user set CHG_EN =1	VBUS rising		3.3	3.4	3.5	V
	VBUS falling	VBUS falling		3.1	3.2	3.3	V



## 7.5 Electrical Characteristics (続き)

VBUS=8V, VOUT=4V, T<sub>J</sub>= -40°C to +85°C, and T<sub>J</sub> = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>VOUTUVLOZ</sub>	VOUT rising threshold for active I <sup>2</sup> C, no VAC, no VBUS	VOUT rising	2.48	2.6	2.72	V
V <sub>VOUTUVLO</sub>	VOUT falling threshold for I <sup>2</sup> C stop working	VOUT falling	2.25	2.4	2.55	V
V <sub>VOUTPRESENT</sub>	VOUT rising to threshold allow user set CHG_EN =1	VOUT rising	3.0	3.1	3.2	V
	VOUT falling	VOUT falling	2.9	3.0	3.1	V
<b>RESISTANCE</b>						
R <sub>ON_BLK</sub>	VBUS to PMID resistance	VBUS=8V		6.1	10.5	mΩ
R <sub>ON_CH1</sub>	PMID to CFH1 resistance	PMID=8V		19.3	26.8	mΩ
R <sub>ON_DH1</sub>	CFH1 to VOUT resistance	CFLY=4V		11.4	16.8	mΩ
R <sub>ON_CL1</sub>	VOUT to CFL1 resistance	VOUT=4V		11.8	18	mΩ
R <sub>ON_DL1</sub>	CFL1 to GND resistance	CFLY=4V		12	18.3	mΩ
R <sub>ON_CH2</sub>	PMID to CFH2 resistance	PMID=8V		19.3	26.8	mΩ
R <sub>ON_DH2</sub>	CFH2 to VOUT resistance	CFLY=4V		11.4	16.8	mΩ
R <sub>ON_CL2</sub>	VOUT to CFL2 resistance	VOUT=4V		11.8	18	mΩ
R <sub>ON_DL2</sub>	CFL2 to GND resistance	CFLY=4V		12	18.3	mΩ
R <sub>VBUS_PD</sub>	VBUS pull down resistance			5		kΩ
R <sub>VAC_PD</sub>	VAC pull down resistance for both VAC1 and VAC2	VAC=10V		125		Ω
<b>PROTECTION AND ALARM THRESHOLD AND ACCURACY</b>						
V <sub>BATOVP_RANGE</sub>	Battery over-voltage range		3.491		4.759	V
V <sub>BATOVP_STEP</sub>	Typical battery over-voltage step			9.985		mV
I <sub>BATP</sub>	BATP leakage current				1.2	μA
I <sub>BATN</sub>	BATN leakage current				1	nA
V <sub>BATOVP_ACC</sub>	Battery over-voltage accuracy	VBATOVP = 4.390V	4.346	4.390	4.434	V
V <sub>OUTOVP_ACC</sub>	VOUT over-voltage accuracy	VOUTOVP= 5V	4.9	5	5.1	V
I <sub>BATOCP_RANGE</sub>	Battery over-current range		2.05		8.7125	A
I <sub>BATOCP_STEP</sub>	Typical battery over-current step			102.5		mA
I <sub>BATOCP_ACC</sub>	Battery over-current accuracy	IBATOCP=6.15A, RSNS=2mΩ T <sub>J</sub> = -20°C - 85°C	5.842	6.15	6.458	A
V <sub>BUSOVP_RANGE</sub>	VBUS over-voltage range	Switched Cap Mode	7		12.75	V
		Bypass Mode	3.5		6.5	
V <sub>BUSOVP_STEP</sub>	Typical VBUS over-voltage step	Switched Cap Mode		50		mV
		Bypass Mode		25		mV
V <sub>BUSOVP_ACC</sub>	VBUS over-voltage accuracy	VBUSOVP = 4.45V	4.39	4.45	4.488	V
		VBUSOVP = 9V	8.91	9	9.09	V
V <sub>BUS_ERRHI_RISING_SC</sub>	VBUS ERRHI rising threshold for switched cap mode stop switching	VOUT=4V		9.6		V
V <sub>BUS_ERRHI_FALLING_SC</sub>	VBUS ERRHI falling threshold for switched cap mode start switching	VOUT=4V		9.4		V
V <sub>BUS_ERRHI_RISING_BYPASS</sub>	VBUS ERRHI rising threshold for bypass mode stop switching	VOUT=4V		4.8		V
V <sub>BUS_ERRHI_FALLING_BYPASS</sub>	VBUS ERRHI falling threshold for bypass mode start switching	VOUT=4V		4.68		V

## 7.5 Electrical Characteristics (続き)

V<sub>BUS</sub>=8V, V<sub>OUT</sub>=4V, T<sub>J</sub>= -40°C to +85°C, and T<sub>J</sub> = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
V <sub>VACOV_P_RANGE</sub>	VAC over-voltage range		6.5		18	V
V <sub>VACOV_P_ACC</sub>	VAC over-voltage accuracy	VACOV_P=6.5V	6.3	6.5	6.6	V
		VACOV_P=10.5V	10.2	10.5	10.7	V
		VACOV_P=14V	13.6	14	14.3	V
V <sub>VACOV_P_HYS</sub>	VACOV_P hysteresis		3		%	
V <sub>ACDRV</sub>	ACDRV voltage to external FET	VAC=8V	4.5	5	5.5	V
I <sub>ACDRV</sub>	ACDRV current capability		20			μA
I <sub>BUSOCP_RANGE</sub>	Input over-current range	Switched Cap Mode	1.0175		4.579	A
		Bypass Mode	1.0475		6.809	A
I <sub>BUSOCP_STEP</sub>	Typical input over current step	Switched Cap Mode		254		mA
		Bypass Mode		262		mA
I <sub>BUSOCP_ACC</sub>	Input over current accuracy	IBUSOCP=3.05A, switched cap mode T <sub>J</sub> = −20°C - 85°C	2.897	3.05	3.206	A
		IBUSOCP=3.14A, bypass mode T <sub>J</sub> = −20°C - 85°C	2.983	3.14	3.297	A
I <sub>BUSUCP_ACC</sub>	Input under-current accuracy	BUSUCP=250mA, T <sub>J</sub> = −20°C - 85°C	100	250	450	mA
I <sub>BUSRCP_ACC</sub>	Input reverse-current accuracy	BUSRCP=300mA, T <sub>J</sub> = -20°C - 85°C	150	300	450	mA
TS <sub>BUS_FLT_RANGE</sub>	TSBUS fault % of V <sub>REGN</sub> range		0		50	%
TS <sub>BUS_FLT_STEP</sub>	TSBUS fault % of V <sub>REGN</sub> step size			0.1953		%
TS <sub>BUSFLT_ACC</sub>	TSBUS fault accuracy	TSBUS_FLT=20.12%	18.5	20.12	21.5	%
TS <sub>BAT_FLT_RANGE</sub>	TSBAT fault % of V <sub>REGN</sub> range		0		50	%
TS <sub>BAT_FLT_STEP</sub>	TSBAT fault % of V <sub>REGN</sub> step size			0.1953		%
TS <sub>BAT_FLT_ACC</sub>	TSBAT voltage accuracy	TSBAT_FLT=20.12%	18.5	20.12	21.5	%
T <sub>DIE_FLT_RANGE</sub>	TDIE over-temperature range		80		140	°C
T <sub>DIE_FLT_STEP</sub>	TDIE over-temperature step			20		°C
T <sub>DIE_ALM_RANGE</sub>	TDIE over-temperature alarm range		25		150	°C
T <sub>DIE_ALM_STEP</sub>	TDIE over-temperature alarm step			0.5		°C
ADC MEASUREMENT PERFORMANCE						
t <sub>ADC_CONV</sub>	Conversion-time, Each Measurement	ADC_SAMPLE[1:0] = 00		24		ms
		ADC_SAMPLE[1:0] = 01		12		ms
		ADC_SAMPLE[1:0] = 10		6		ms
		ADC_SAMPLE[1:0] = 11		3		ms
ADC <sub>RES</sub>	Effective Resolution	ADC_SAMPLE[1:0] = 00	14	15		bit
		ADC_SAMPLE[1:0] = 01	13	14		bit
		ADC_SAMPLE[1:0] = 10	12	13		bit
		ADC_SAMPLE[1:0] = 11	10	11		bit
ADC MEASUREMENT RANGES AND ACCURACY						
I <sub>BUSADC_RANGE</sub>	ADC BUS current range		0		7	A
I <sub>BUSADC_LSB</sub>	ADC BUS current LSB	Switched Cap Mode		0.9972		mA
	ADC BUS current LSB	Bypass Mode		1.0279		mA

## 7.5 Electrical Characteristics (続き)

VBUS=8V, VOUT=4V, T<sub>J</sub> = -40°C to +85°C, and T<sub>J</sub> = 25°C for typical values (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
I <sub>BUSADC_OFFSET</sub>	ADC BUS current offset	Switched Cap Mode		66		mA
	ADC BUS current offset	Bypass Mode		64		mA
I <sub>BUSADC_ACC</sub>	ADC BUS current accuracy	IBUS=2A, ADC_SAMPLE[1:0]=00, T <sub>J</sub> = -20°C - 85°C	1.9	2	2.1	A
		IBUS=3A, ADC_SAMPLE[1:0]=00, T <sub>J</sub> = -20°C - 85°C	2.85	3	3.15	A
V <sub>BUSADC_RANGE</sub>	ADC BUS voltage range		0		16.39	V
V <sub>BUSADC_LSB</sub>	ADC BUS voltage LSB			1.002		mV
V <sub>BUSADC_ACC</sub>	ADC BUS voltage accuracy	VBUS=4V, ADC_SAMPLE[1:0]=00	3.96	4	4.04	V
		VBUS=8V, ADC_SAMPLE[1:0]=00	7.92	8	8.08	V
V <sub>AC1ADC_RANGE</sub>	ADC VAC1 voltage range		0		14	V
V <sub>AC1ADC_STEP</sub>	ADC VAC1 voltage LSB			1.0008		mV
V <sub>AC1ADC_OFFSET</sub>	ADC VAC1 voltage offset			3		mV
V <sub>AC1ADC_ACC</sub>	ADC VAC1 voltage accuracy	VAC1=4V, ADC_SAMPLE[1:0]=00	3.96	4	4.04	V
		VAC1=8V, ADC_SAMPLE[1:0]=00	7.92	8	8.08	V
V <sub>AC2ADC_RANGE</sub>	ADC VAC2 voltage range		0		14	V
V <sub>AC2ADC_LSB</sub>	ADC VAC2 voltage LSB			1.0006		mV
V <sub>AC2ADC_OFFSET</sub>	ADC VAC2 voltage offset			5		mV
V <sub>AC2ADC_ACC</sub>	ADC VAC2 voltage accuracy	VAC2=4V, ADC_SAMPLE[1:0]=00	3.96	4	4.04	V
V <sub>AC2ADC_ACC</sub>	ADC VAC2 voltage accuracy	VAC2=8V, ADC_SAMPLE[1:0]=00	7.92	8	8.08	V
V <sub>BATADC_RANGE</sub>	ADC BAT voltage range		0		6	V
V <sub>BATADC_LSB</sub>	ADC BAT voltage LSB			1.017		mV
V <sub>BATADC_OFFSET</sub>	ADC BAT voltage offset			1		mV
V <sub>BATADC_ACC</sub>	ADC BAT voltage accuracy	VBAT=4V, ADC_SAMPLE[1:0]=00	3.96	4	4.04	V
		VBAT=4.4V, ADC_SAMPLE[1:0]=00	4.356	4.4	4.444	V
V <sub>OUTADC_RANGE</sub>	ADC VOUT voltage range		0		6	V
V <sub>OUTADC_LSB</sub>	ADC VOUT voltage LSB			1.0037		mV
V <sub>OUTADC_OFFSET</sub>	ADC VOUT voltage offset			2		mV
V <sub>OUTADC_ACC</sub>	ADC VOUT voltage accuracy	VOUT=4V, ADC_SAMPLE[1:0]=00	3.98	4	4.02	V
		VOUT=4.4V, ADC_SAMPLE[1:0]=00	4.378	4.4	4.422	V
I <sub>BATADC_RANGE</sub>	ADC battery current range		-12		12	A
I <sub>BATADC_LSB</sub>	ADC battery current LSB			0.999		mA
I <sub>BATADC_OFFSET</sub>	ADC battery current offset			-150		mA
I <sub>BATADC_ACC_2mOhm</sub>	ADC battery current accuracy through 2mOhm sense resistor	IBAT=4A, ADC_SAMPLE[1:0]=00, T <sub>J</sub> = -20°C - 85°C	3.92	4.00	4.08	A
		IBAT=6A, ADC_SAMPLE[1:0]=00, T <sub>J</sub> = -20°C - 85°C	5.88	6.00	6.12	A
TS <sub>BUSADC_RANGE</sub>	ADC TSBUS % of V <sub>REGN</sub> range		0		50	%
TS <sub>BUSADC_STEP</sub>	ADC TSBUS % of V <sub>REGN</sub> range LSB			0.0986		%
TS <sub>BUSADC_OFFSET</sub>	ADC TSBUS % of V <sub>REGN</sub> range offset			0.1		%
TS <sub>BUSADC_ACC</sub>	ADC TSBUS accuracy	TSBUS=20% of V <sub>REGN</sub> , ADC_SAMPLE[1:0]=00	19	20	21	%
TS <sub>BATADC_RANGE</sub>	ADC TSBAT % of V <sub>REGN</sub> range		0		50	%

## 7.5 Electrical Characteristics (続き)

VBUS=8V, VOUT=4V, T<sub>J</sub>= -40°C to +85°C, and T<sub>J</sub> = 25°C for typical values (unless otherwise noted)

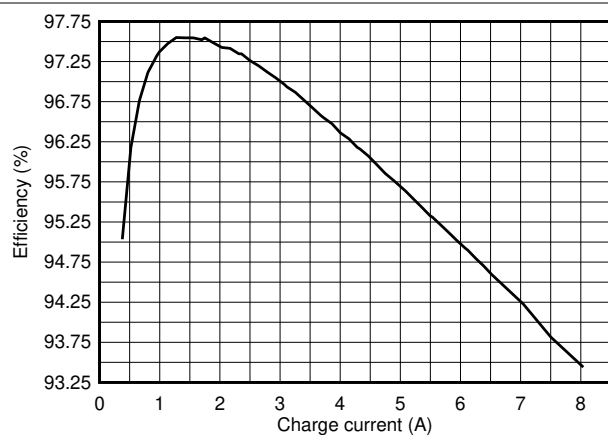
PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
TSBATADC_STEP	ADC TSBAT % of V <sub>REGN</sub> range LSB			0.0976		%
TSBATADC_OFFSET	ADC TSBAT % of V <sub>REGN</sub> range offset			0.065		%
TSBATADC_ACC	ADC TSBAT accuracy	TSBAT=20% of V <sub>REGN</sub> , ADC_SAMPLE[10]=00	19	20	21	%
TDIE_ADC_RANGE	ADC TDIE range		-40		150	°C
TDIE_ADC_STEP	ADC TDIE step			0.5079		°C
TDIE_ADC_OFFSET	ADC TDIE offset			-3.5		°C
<b>REGN LDO</b>						
V <sub>REGN</sub>	REGN LDO output voltage	V <sub>BUS</sub> =8V, I <sub>REGN</sub> =20mA		5.0		V
I <sub>REGN</sub>	REGN LDO current limit	V <sub>BUS</sub> =8V, V <sub>REGN</sub> =4.5V	40			mA
<b>I2C INTERFACE (SCL, SDA)</b>						
V <sub>IH</sub>	Input high threshold level, SDA and SCL	Pull up rail 1.2V	0.78			V
V <sub>IL</sub>	Input low threshold level	Pull up rail 1.2V			0.42	V
V <sub>OL</sub>	Output low threshold level	Sink current = 5mA			0.4	V
I <sub>BIAS</sub>	High-level leakage current	Pull up rail 1.2V			1	μA
<b>LOGIC OUTPUT PIN (INT, TSBAT_SYNCOUT)</b>						
V <sub>OL</sub>	Output low threshold level, INT pin	Sink current = 5mA			0.4	V
I <sub>OUT</sub>	High-level leakage current, INT pin	Pull up rail 1.8V			1	μA
<b>LOGIC INPUT PIN (SRN_SYNCIN)</b>						
V <sub>IH_SRN_SYNCIN</sub>	Input high threshold level, SRN_SYNCIN		1.3			V
V <sub>IL_SRN_SYNCIN</sub>	Input low threshold level, SRN_SYNCIN				0.4	V
I <sub>IN_SRN_SYNCIN</sub>	High level leakage current	Pull-up rail 1.8V			1	μA

## 7.6 Timing Requirements

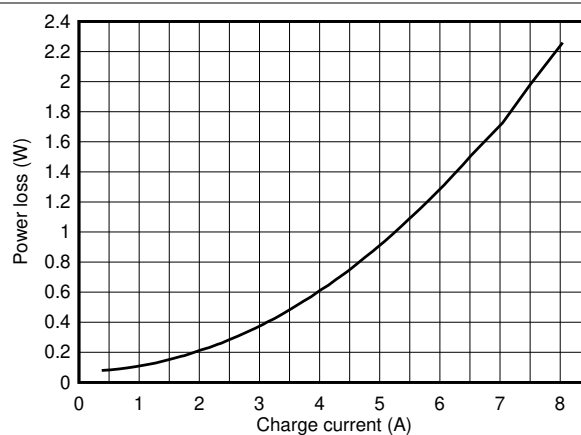
		MIN	NOM	MAX	UNIT
<b>TIMINGS</b>					
t <sub>VACOV</sub>	VAC OVP response time		100		ns
t <sub>BATOCP</sub>	IBAT OCP response time		640		μs
t <sub>INT</sub>	Duration that INT is pulled low when an event occurs		256		μs
t <sub>ALM_DEBOUNCE</sub>	Time between consecutive faults for ALM indication		120		ms
<b>I2C INTERFACE</b>					
f <sub>SCL</sub>	SCL clock frequency			1000	kHz

## 7.7 Typical Characteristics

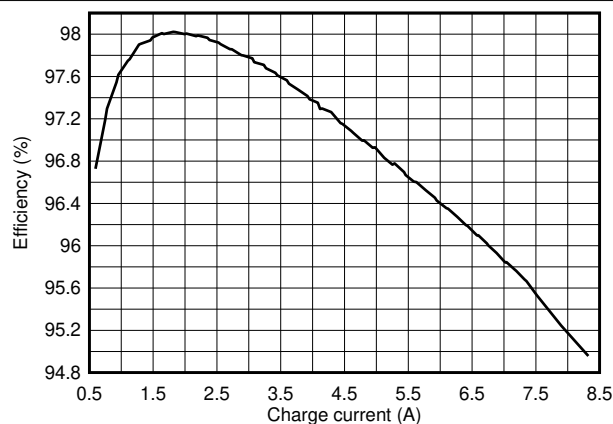
Typical characteristics are taken with the BMS041 for switching test and GRM188R61C226M is used as CFLY.



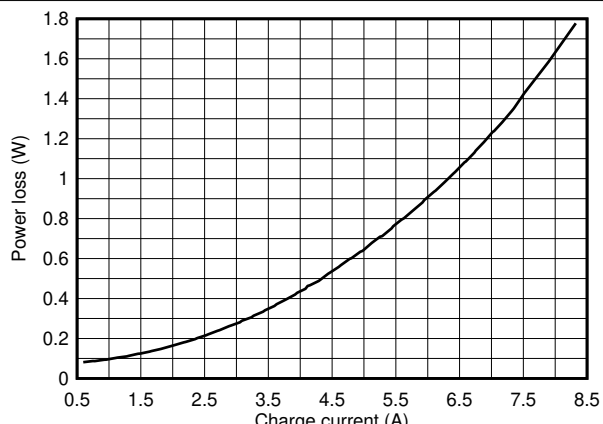
7-1. Battery Charge Efficiency vs. Charge Current, 1 x 22- $\mu$ F CFLY per Phase Switching Frequency



7-2. Battery Charge Power Loss vs. Charge Current, 1 x 22- $\mu$ F CFLY per Phase Switching Frequency



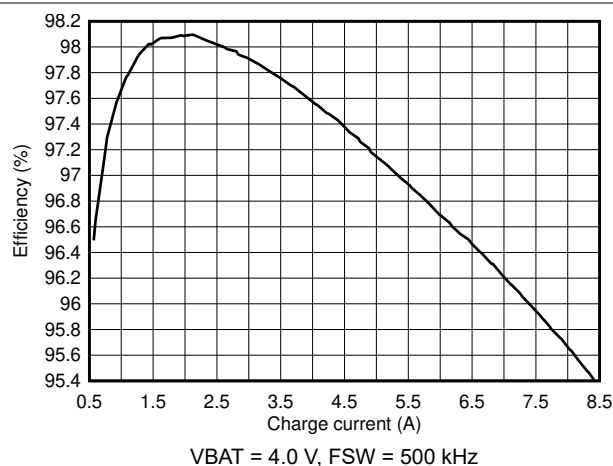
7-3. Battery Charge Efficiency vs. Charge Current, 2 x 22- $\mu$ F CFLY per Phase



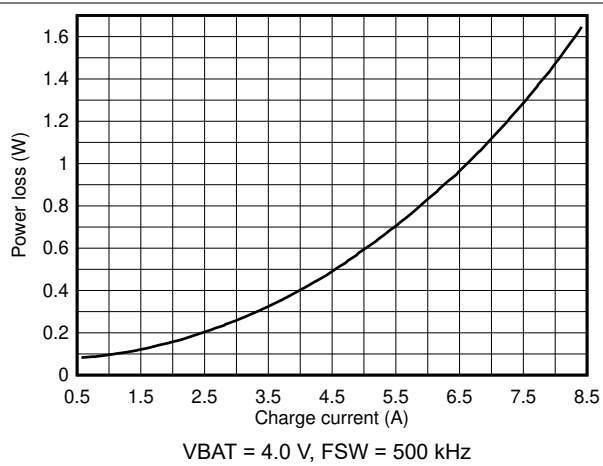
7-4. Battery Charge Power Loss vs. Charge Current, 2 x 22- $\mu$ F CFLY per Phase

## 7.7 Typical Characteristics (continued)

Typical characteristics are taken with the BMS041 for switching test and GRM188R61C226M is used as CFLY.



7-5. Battery Charge Efficiency vs. Charge Current, 3 x 22- $\mu$ F CFLY per Phase



7-6. Battery Charge Power Loss vs. Charge Current, 3 x 22- $\mu$ F CFLY per Phase

## 8 Detailed Description

### 8.1 Overview

The BQ25960H is a 98.1% peak efficiency, 8-A battery charging solution using a switched cap architecture for 1-cell Li-ion battery. This architecture allows the cable current to be half the charging current, reducing the cable power loss, and limiting temperature rise. The dual-phase architecture increases charging efficiency and reduces the input and output cap requirements. When used with a main charger such as BQ2561x or BQ2589x, the system enables full charging cycle from trickle charge to termination with low power loss at Constant Current (CC) and Constant Voltage (CV) mode.

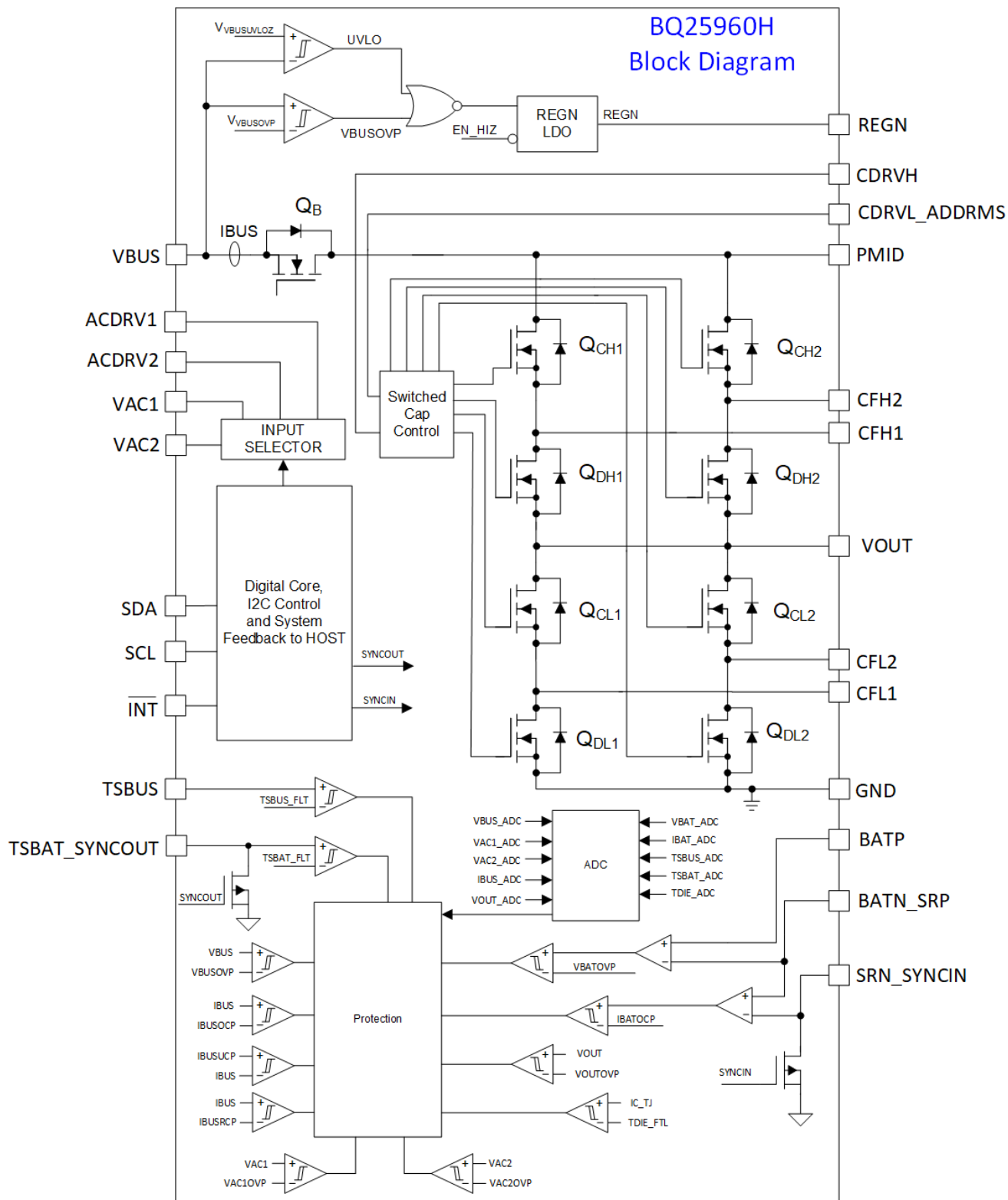
The device also operates in bypass mode charging the battery directly from VBUS through QB, QCH1 and QDH1 in parallel with QCH2 and QDH2. The impedance in bypass mode is limited to 21 mΩ for 5-A charging current.

The device supports dual input power path management which manages the power flowing from two different input sources. The inputs selection is controlled by host through I<sup>2</sup>C with default source #1 as the primary input and the source #2 as the secondary source.

The device integrates all the necessary protection features to ensure safe charging, including input overvoltage and overcurrent protection, output overvoltage and overcurrent protection, temperature sensing for the battery and cable, and monitoring the die temperature.

The device includes a 16-bit ADC to provide bus voltage, bus current, output voltage, battery voltage, battery current, input connector temperature, battery temperature, junction temperature, and other calculated measurements needed to manage the charging of the battery from the smart wall adapter or wireless input or power bank.

## 8.2 Functional Block Diagram





## 8.3 Feature Description

### 8.3.1 Charging System

BQ25960H is a single-cell high efficiency switched cap charger, used in parallel with a switching mode charger. A host must set up the protections and alarms on BQ25960H prior to enabling the BQ25960H. The host must monitor the alarms generated by BQ25960H and communicate with the smart adapter to control the current delivered to the charger.

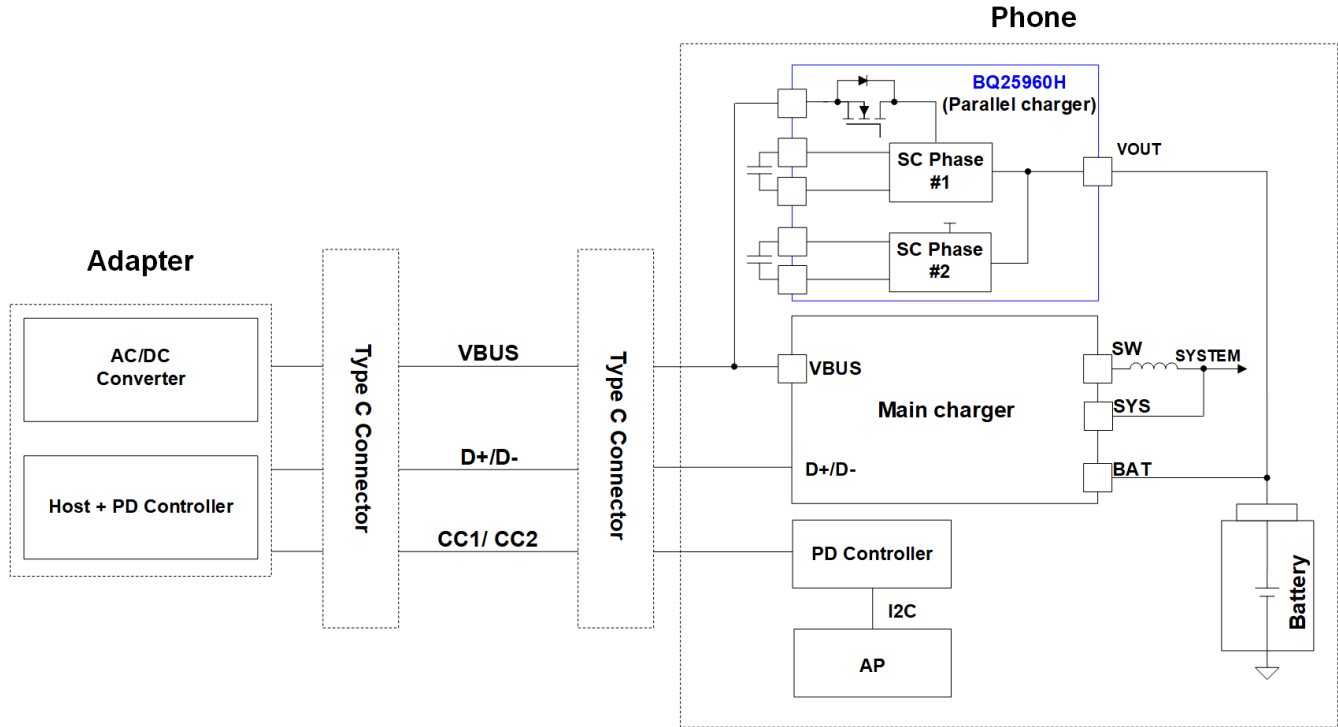
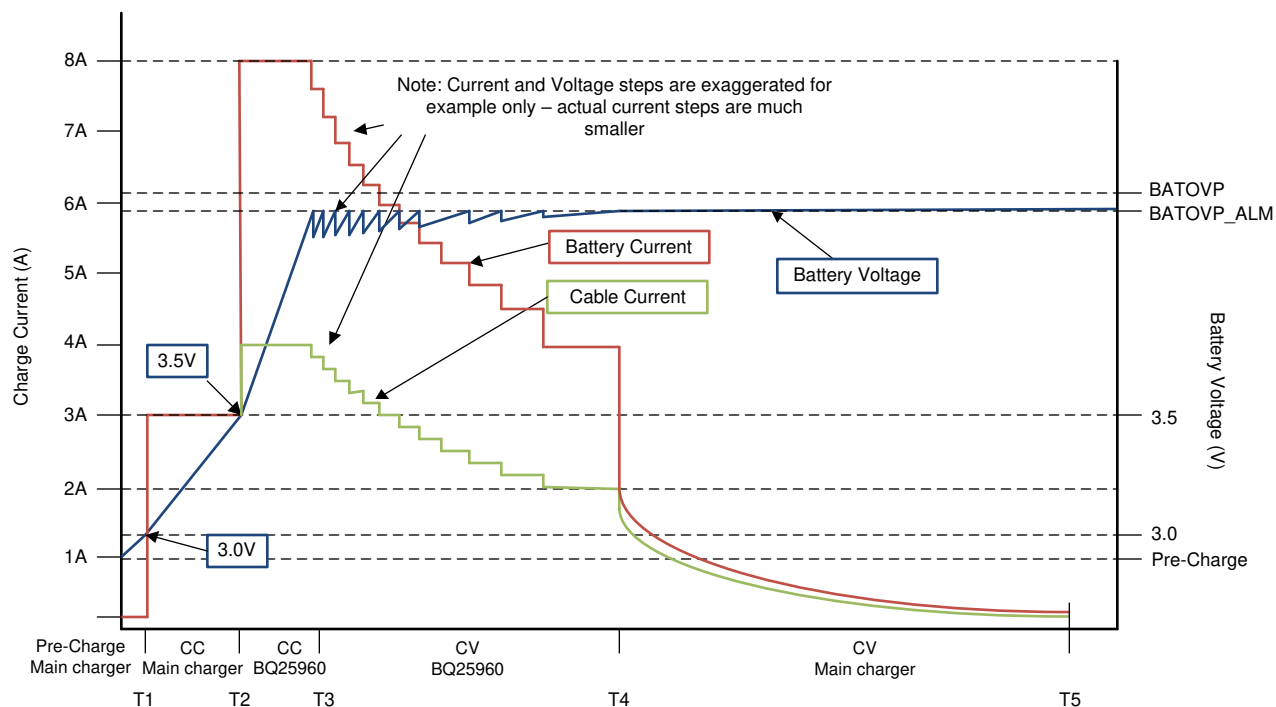


図 8-1. BQ25960H System Diagram

### 8.3.2 Battery Charging Profile

The system will have a specific battery charging profile that is unique due to the switched cap architecture. The charging will be controlled by the main charger such as the BQ2561x or BQ2589x until system voltage reaches minimum system regulation voltage  $V_{\text{SYSTEMIN}}$ . Once the battery voltage reaches  $V_{\text{SYSTEMIN}}$  (3.5 V), the adapter can negotiate for a higher bus voltage, enable BQ25960H charging, and regulate the current on VBUS to charge the battery. In the CC phase, the protection in BQ25960H will not regulate the battery voltage, but will provide feedback to the system to increase and decrease current as needed, as well as disable the blocking and switching FETs if the voltage is exceeded. Once the CV point is reached, the BQ25960H will provide feedback to the adapter to reduce the current, effectively tapering the current until a point where the main charger takes over again. The BQ25960H can operate as long as input current is above the BUSUCP threshold.



**8-2. BQ25960H System Charging Profile**

### 8.3.3 Device Power Up

The device is powered from the higher of VAC1 or VAC2 (with VAC1 being primary input), VBUS or VOUT (battery). The voltage must be greater than the  $V_{VACUVLOZ}$ ,  $V_{VBUSUVLOZ}$  or  $V_{VOUTUVLOZ}$  threshold to be a valid supply. When VAC1 or VAC2 rises above  $V_{VACUVLOZ}$  or VBUS rises above  $V_{VBUSUVLOZ}$  or VOUT rises above  $V_{VOUTUVLOZ}$ , I<sup>2</sup>C interface is ready for communication and all the registers are reset to default value. The host needs to wait VBUSPRESENT\_STAT and VOUTPRESENT\_STAT go high before setting CHG\_EN = 1 and start charging.

### 8.3.4 Device HIZ State

The device enters HIZ mode when EN\_HIZ bit is set to '1'. When device is in HIZ mode, the converter stops switching, ADC stops converting, ACDRV is turned off and REGN LDO is forced off even when the adapter is present and no fault condition is present. The device exits HIZ Mode when EN\_HIZ is set to '0' by host or device POR.

The faults conditions force the converter stop switching and clear CHG\_EN bit, but keep REGN on and EN\_HIZ bit = 0. More details can be found in the Device Protection section.

### 8.3.5 Dual Input Bi-Directional Power Path Management

The device has two ACDRV pins to drive two sets of N-channel ACFET-RBFET, which select and manage the input power from two different input sources. A single GaN FET can be used to replace an ACFET-RBFET combination and will be treated the same as an ACFET-RBFET combination. In the POR sequence, the device detects if the protection FET(s) are populated based on if ACDRV pin is shorted to ground or not, and then updates the status register ACRB1\_CONFIG\_STAT or ACRB2\_CONFIG\_STAT to indicate the presence of AC protection FETs. If the external ACFET-RBFET or GaN FET is not populated in the schematic, then tie VAC to VBUS and connect ACDRV to GND. The device supports:

1. single input without external FET
2. single input with one single ACFET
3. dual input with one set of ACFET-RBFET
4. dual input with two sets of ACFET-RBFET

The power-up sequences for different applications are described in detail below.

### 8.3.5.1 ACDRV Turn-On Condition

The ACDRV controls input power MUX for both BQ25960H and main charger. In order to turn the ACDRV, all of the following conditions must be valid:

1. The corresponding AC-RB FET is populated: VAC is not short to VBUS and ACDRV is not short to ground
2. VAC is above  $V_{VAC_{present}}$  threshold
3. VAC is below  $V_{VAC_{OVP}}$  threshold
4. DIS\_ACDRV\_BOTH is not set to '1'
5. EN\_HIZ is not set to '1'
6. VBUS is below  $V_{VBUS_{present}}$  threshold

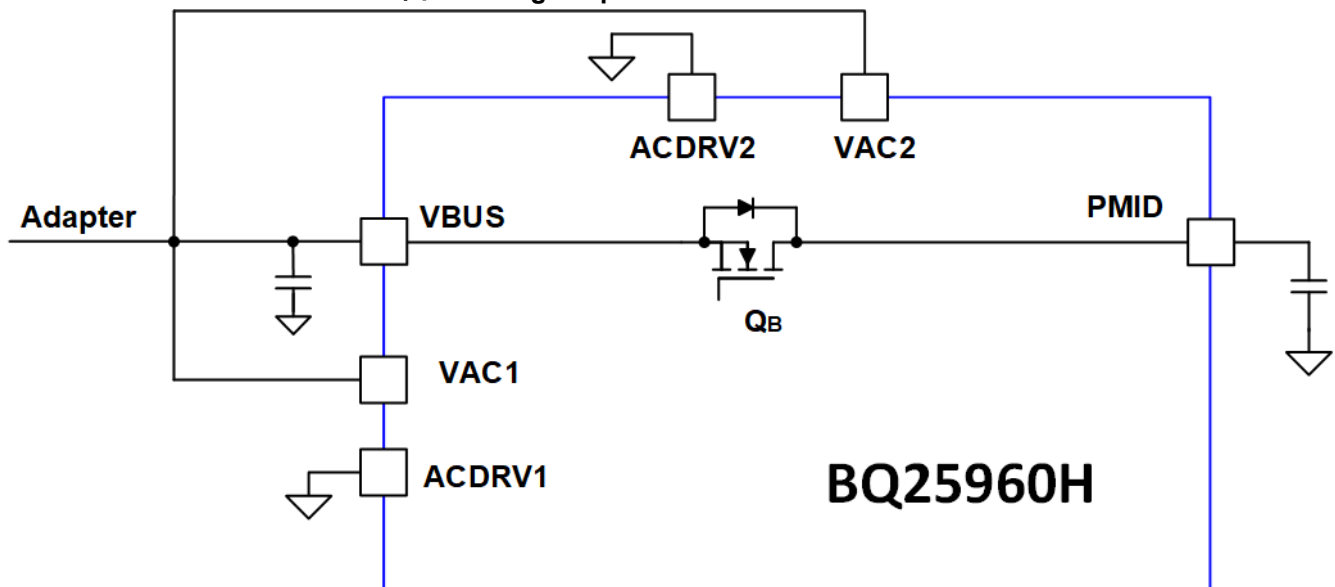
### 8.3.5.2 Single Input from VAC to VBUS without ACFET-RBFET

In this scenario, VAC1 and VAC2 are both shorted to VBUS, ACDRV1 and ACDRV2 are pulled down to ground. The table below summarizes the VAC1/VAC2, ACDRV1/ACDRV2 connection, register control, and status functions.

**表 8-1. Single Input without External FET Summary**

INPUT CONFIGURATION	SINGLE INPUT
External FET connection	No external FET
Input pin connection	VAC1 and VAC2 short to VBUS
ACDRV pin connection	ACDRV1 and ACDRV2 short to ground
ACDRV1_STAT	0
ACDRV2_STAT	0
DIS_ACDRV_BOTH	1
ACRB1_CONFIG_STAT	0
ACRB2_CONFIG_STAT	0
EN_HIZ	No impact on ACDRV

**図 8-3. Single input without ACFET-RBFET**



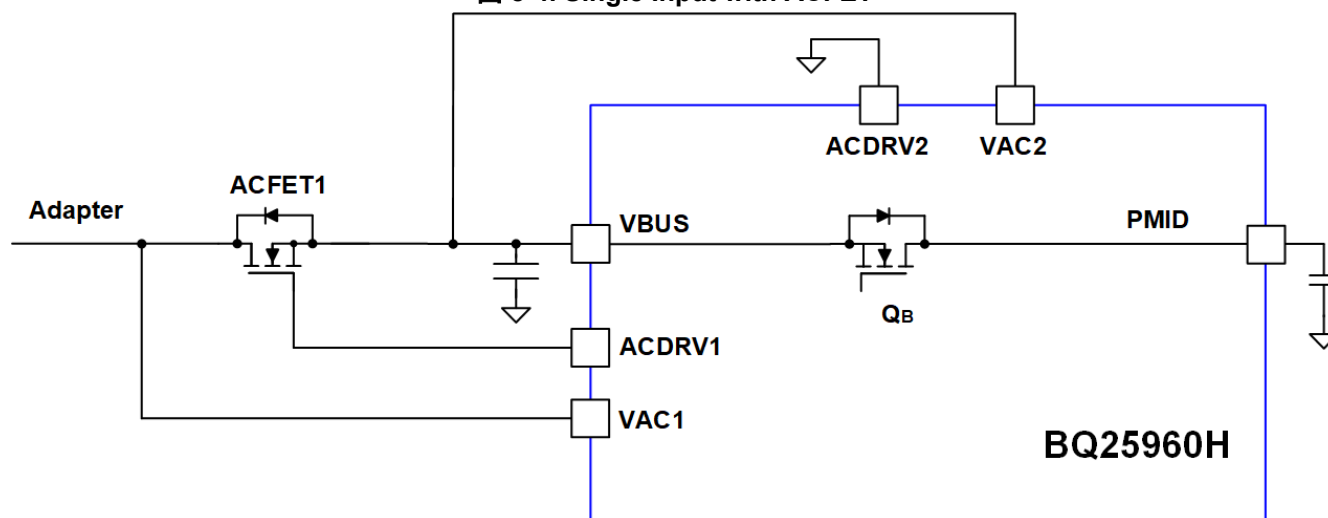
### 8.3.5.3 Single Input with ACFET1

In this scenario, ACFET1 without RBFET1 is populated, but ACFET2-RBFET2 is not. VAC2 is short to VBUS and ACDRV2 is pulled down to ground. The table below summarizes the VAC1/ VAC2, ACDRV1/ACDRV2 connection, register control, and status functions. Use VAC1 for single input configuration.

**表 8-2. Single Input with Single ACFET1**

INPUT CONFIGURATION	SINGLE INPUT
External FET connection	ACFET1, no ACFET2-RBFET2
Input pin connection	VAC1 connected to input source VAC2 short to VBUS
ACDRV pin connection	ACDRV1 active ACDRV2 tie to ground
ACDRV1_STAT	1: ACDRV1 is ON 0: ACDRV1 is OFF
ACDRV2_STAT	0
DIS_ACDRV_BOTH	0: Allow ACDRV1 to turn on if the conditions of ACDRV turn on are met. 1: Force ACDRV1 OFF
ACRB1_CONFIG_STAT	1
ACRB2_CONFIG_STAT	0
EN_HIZ	0: Allow ACDRV1 to turn on if the conditions of ACDRV turn on are met. 1: Force ACDRV1 OFF

**図 8-4. Single Input with ACFET**



### 8.3.5.4 Dual Input with ACFET1-RBFET1

In this scenario, ACFET1-RBFET1 is populated, but ACFET2-RBFET2 is not. VAC2 is short to VBUS and ACDRV2 is pulled down to ground. The table below summarizes the connection, register control and status functions. Use VAC1 for adapter input and VBUS for wireless input.

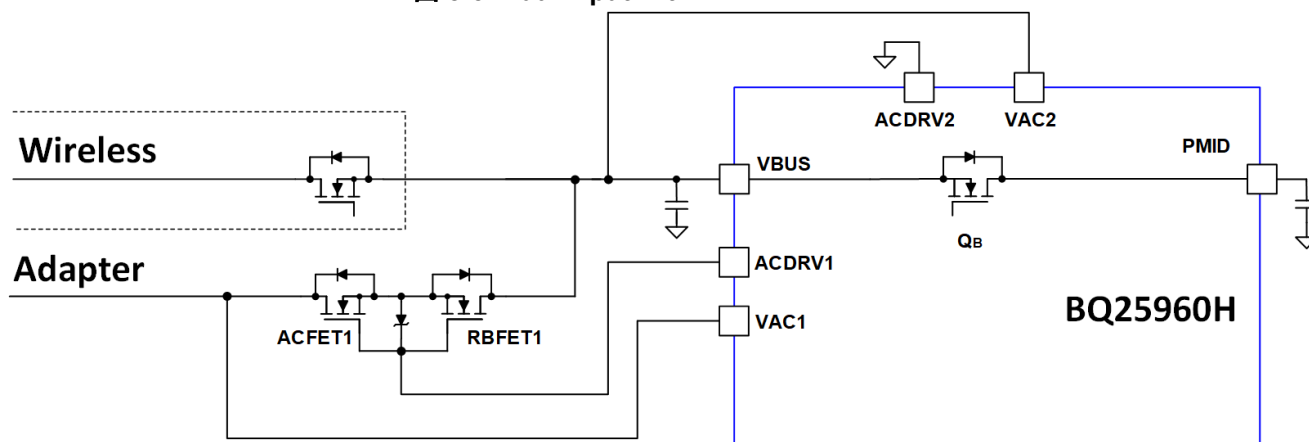
**表 8-3. Dual Input with ACFET1-RBFET1**

INPUT CONFIGURATION	DUAL INPUT
External FET connection	ACFET1-RBFET1, no ACFET2-RBFET2
Input pin connection	VAC1 connected to input source 1 VAC2 short to VBUS

表 8-3. Dual Input with ACFET1-RBFET1 (続き)

INPUT CONFIGURATION	DUAL INPUT
ACDRV pin connection	ACDRV1 active ACDRV2 short to ground
ACDRV1_STAT	0: ACDRV1 OFF 1: ACDRV1 ON
ACDRV2_STAT	0
DIS_ACDRV_BOTH	0: Allow ACDRV1 to turn on if other conditions of ACDRV turn on are met 1: Force ACDRV1 OFF
ACRB1_CONFIG_STAT	1
ACRB2_CONFIG_STAT	0
EN_HIZ	0: Allow ACDRV1 to turn on if other conditions of ACDRV turn on are met 1: Force ACDRV1 OFF

図 8-5. Dual Input with ACFET-RBFET1



### 8.3.5.5 Dual Input with ACFET1-RBFET1 and ACFET2-RBFET2

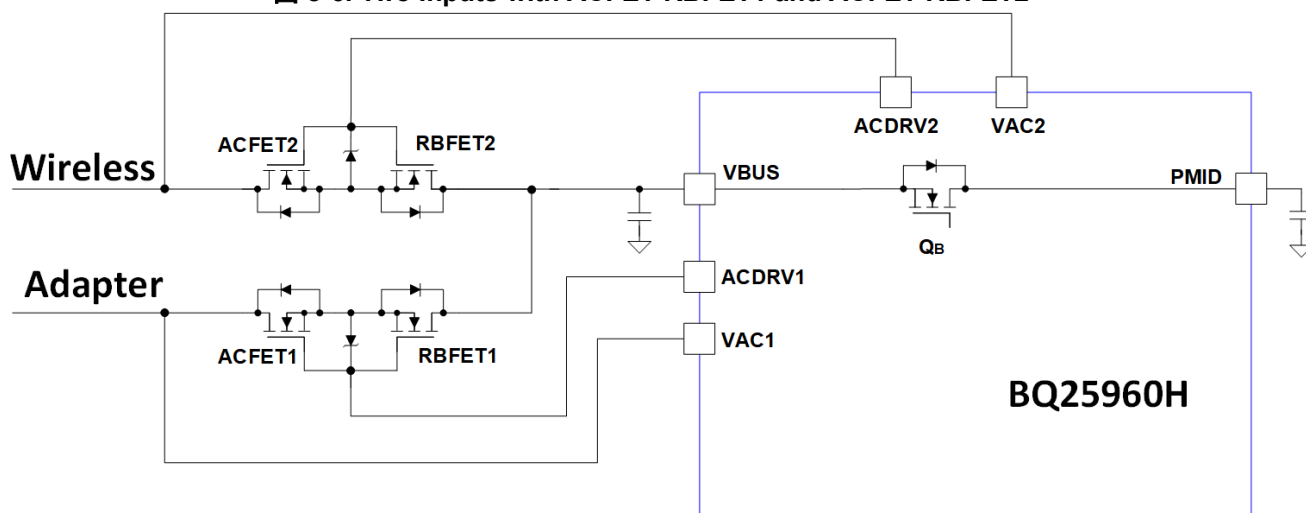
In this scenario, both ACFET1-RBFET1 and ACFET2-RBFET2 are populated and the device supports dual input. The table below summarizes the connection, register control and status functions. Connect input with high OVP threshold to VAC1.

表 8-4. Dual Input with Both ACFET1-RBFET1 and ACFET2-RBFET2 Summary

INPUT CONFIGURATION	DUAL INPUT
External FET connection	ACFET1-RBFET1, ACFET1-RBFET2
Input pin connection	VAC1 connected to input source 1 VAC2 connected to input source 2 <b>No input source allowed to connect to VBUS</b>
ACDRV pin connection	ACDRV1 and ACDRV2 active
ACDRV1_STAT	0: ACDRV1 OFF 1: ACDRV1 ON Once device is in dual input configuration with ACFET1-RBFET1 and ACFET2-RBFET2, the host can use this bit to swap the input between VAC1 and VAC2 if both VAC1 and VAC2 are valid.

**表 8-4. Dual Input with Both ACFET1-RBFET1 and ACFET2-RBFET2 Summary (続き)**

INPUT CONFIGURATION	DUAL INPUT
ACDRV2_STAT	0: ACDRV2 OFF 1: ACDRV2 ON Once device is in dual input configuration with ACFET1-RBFET1 and ACFET2-RBFET2, the host can use this bit to swap the input between VAC1 and VAC2 if both VAC1 and VAC2 are valid.
DIS_ACDRV_BOTH	0: Allow ACDRV to turn on. By default, ACDRV1 is turned on if the conditions of ACDRV turn on are met, ACDRV1_STAT=1 and ACDRV2_STAT=0. In On-The-GO (OTG) or Reverse TX Mode, refer to OTG and Reverse TX Mode Operation session for turn on precedence. 1: Force both ACDRV to turn off, both ACDRV1_STAT and ACDRV2_STAT become 0.
ACRB1_CONFIG_STAT	1
ACRB2_CONFIG_STAT	1
EN_HIZ	0: Allow ACDRV to turn on for the port w/ VAC present if the conditions of ACDRV turn on are met. ACDRV1 is turned on since VAC1 is the primary input source when both VAC1 and VAC2 present and the turn on conditions are met. 1: Turns off both ACDRV

**図 8-6. Two Inputs with ACFET-RBFET1 and ACFET-RBFET2****8.3.5.6 OTG and Reverse TX Mode Operation**

When the main charger is in OTG or reverse TX Mode, the input power MUX (ACFET-RBFET) also controls which port is desired for OTG output.

To enter OTG or reverse TX Mode, the host should follow the steps below:

1. Host writes EN\_OTG = 1
2. BQ25960H sets DIS\_ACDRV\_BOTH = 1
3. Host writes DIS\_ACDRV\_BOTH = 0, and then writes ACDRV1\_STAT = 1 or ACDRV2\_STAT = 1 depending on which port is desired for OTG or reverse TX output
4. Host enables OTG Mode on main charger
5. If VBUSOVP or VACOVP fault occurs, ACDRV will be disabled but EN\_OTG is still '1'. Host needs to write ACDRV1\_STAT high or ACDRV2\_STAT high when the fault is cleared. Set VAC1OVP and VAC2OVP to the same threshold in the OTG Mode
6. EN\_OTG is cleared when watchdog timer expires

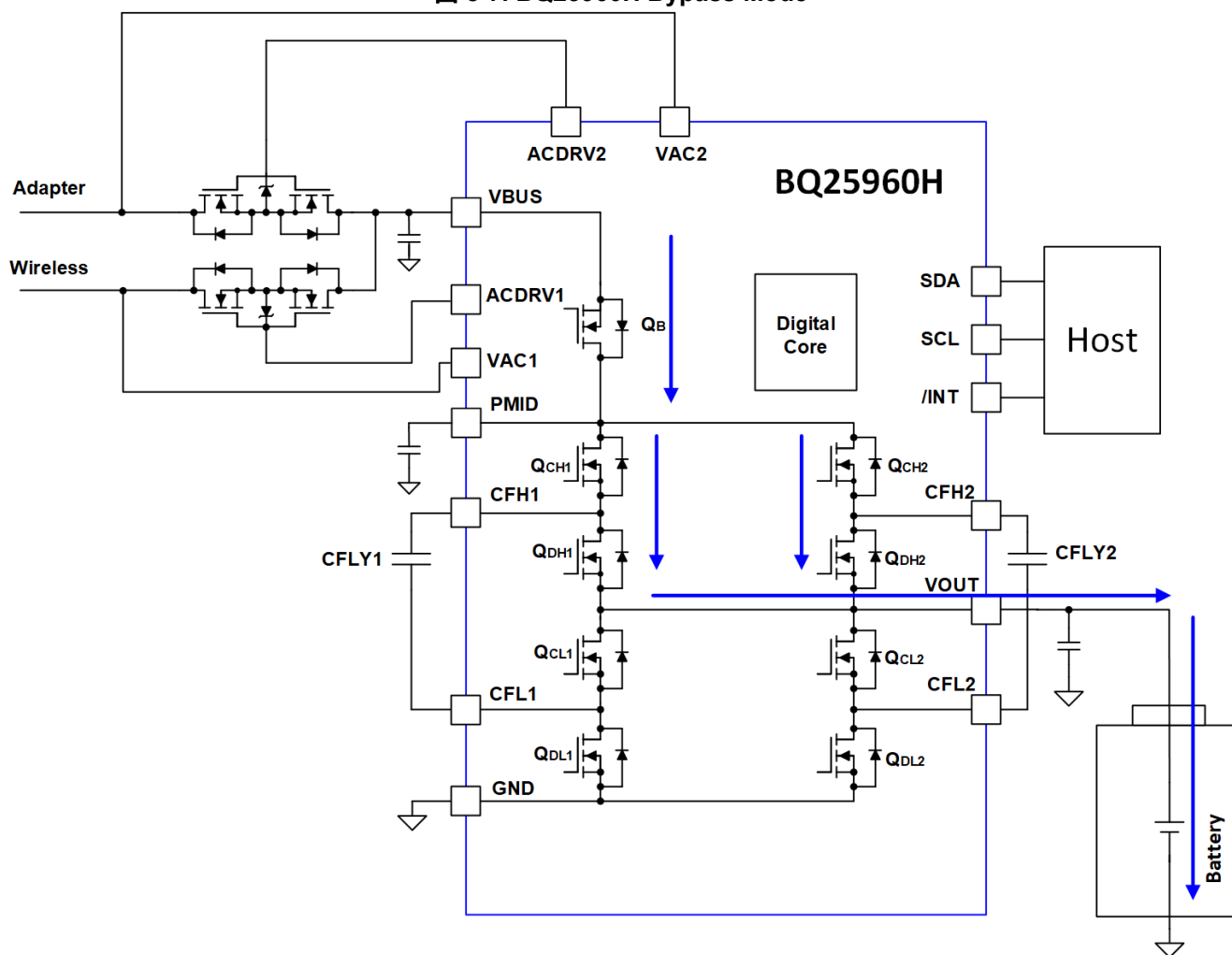
To exit OTG or Reverse TX Mode, the host should follow the steps below:

1. Turn off main OTG or reverse TX source
2. Turn on VBUS pulldown resistor ( $R_{VBUS\_PD}$ ) by setting  $BUS\_PD\_EN=1$  or VAC pulldown resistor  $R_{VAC\_PD}$  by setting  $VAC1\_PD\_EN=1$  or  $VAC2\_PD\_EN=1$ , depending on which port is to be discharged
3. Wait for VBUS and VAC to be discharged
4. Turn off ACDRV by setting  $ACDRV1\_STAT=0$  or  $ACDRV2\_STAT=0$
5. Exit OTG Mode by setting  $EN\_OTG=0$

### 8.3.6 Bypass Mode Operation

When host determines the adapter support bypass mode charging, the device can enable Bypass mode by setting  $EN\_BYPASS=1$ . Blocking FET ( $Q_B$ ) and four high side switching FET ( $Q_{CH1}$  and  $Q_{DH1}$ /  $Q_{CH2}$  and  $Q_{DH2}$ ) are turned on to charge from adapter to battery. During Bypass Mode, when fault occurs,  $CHG\_EN$  is cleared but  $EN\_BYPASS$  stays '1'.

8-7. BQ25960H Bypass Mode



To change from Bypass Mode to Switched Cap Mode or from Switched Cap to Bypass Mode, the host would first set  $CHG\_EN=0$  to stop the converter and then set  $EN\_BYPASS$  to desired value. The host sets desired protection threshold based on the selected operation modes and then host enables charge by setting  $CHG\_EN=1$ .

### 8.3.7 Charging Start-Up

The host can start Switched Cap or Bypass Mode charging follow the steps below:

1. Both VBUS and VOUT need to be present. Host can check the status through VBUSPRESENT\_STAT (REG15[2]) and VOUTPRESENT\_STAT (REG15[5]). Both of them need to be '1'.
2. Host sets all the protections to the desired thresholds. Refer to the [Device Modes and Protection Status](#) section for proper setting.
3. Host sets either Switched Cap Mode or Bypass Mode through EN\_BYPASS bit (REG0F[3]) based on adapter type.
4. Host sets the desired switching frequency in Switched Cap Mode through FSW\_SET [2:0] bits (REG10[7:5]).
5. Host sets BUS under current protection (BUSUCP) to 250 mA though BUSUCP bit (REG05[6])=1
6. Host sets charger configuration bits: CHG\_CONFIG\_1 (REG05[3])=1.
7. Host can enable charge by setting CHG\_EN=1.
8. Once charge has been enabled, the CONV\_ACTIVE\_STAT bit is set to '1' to indicate either switched cap or bypass is active, and current starts to flow to the battery.
9. When watchdog timer expires, CHG\_EN is reset to '0' and charging stops. Host needs to read or write any register bit before watchdog expires, or disable watchdog timer (set REG10[2]=1) to prevent watchdog timer from expiring.

### 8.3.8 Adapter Removal

If adapter is removed during soft start timer, CHG\_EN will be cleared after soft-start timer expires. The user can program the soft-start timer in SS\_TIMEOUT register. If adapter is removed after soft-start timer expires, converter stops switching and CHG\_EN is cleared after the deglitch time programmed in IBUSUCP\_FALL\_DG\_SEL register. The device prevents boost back when the adapter is removed during and after the soft-start timer. To accelerate VBUS or VAC discharge after adapter removal, the user to turn on the VBUS pulldown resistor ( $R_{VBUS\_PD}$ ) and VAC pulldown current resistor ( $R_{VAC\_PD}$ ) by setting BUS\_PD\_EN or VAC1\_PD\_EN or VAC2\_PD\_EN to '1'.

### 8.3.9 Integrated 16-Bit ADC for Monitoring and Smart Adapter Feedback

The integrated 16-bit ADC of the device allows the user to get critical system information for optimizing the behavior of the charger control. The control of the ADC is done through the ADC control register. The ADC\_EN bit provides the ability to enable and disable the ADC to conserve power. The ADC\_RATE bit allows continuous conversion or one-shot behavior. The ADC\_AVG bit enables or disables (default) averaging. ADC\_AVG\_INIT starts average using the existing (default) or using a new ADC value.

To enable the ADC, the ADC\_EN bit must be set to '1'. The ADC is allowed to operate if the  $V_{VAC} > V_{VACPRESENT}$ ,  $V_{VBUS} > V_{VBUSPRESENT}$  or  $V_{VOUT} > V_{VOUTPRESENT}$  is valid. If ADC\_EN is set to '1' before VAC, VBUS or VOUT reach their respective PRESENT threshold, then the ADC conversion will be postponed until one of the power supplies reaches the threshold.

The ADC\_SAMPLE bits control the sample speed of the ADC, with conversion times of  $t_{ADC\_CONV}$ . The integrated ADC has two rate conversion options: a 1-shot mode and a continuous conversion mode set by the ADC\_RATE bit. By default, all ADC parameters will be converted in 1-shot or continuous conversion mode unless disabled in the ADC CONTROL 1 and ADC\_CONTROL 2 register. If an ADC parameter is disabled by setting the corresponding bit in the ADC CONTROL 1 and ADC\_CONTROL 2 register, then the value in that register will be from the last valid ADC conversion or the default POR value (all zeros if no conversions have taken place). If an ADC parameter is disabled in the middle of an ADC measurement cycle, the device will finish the conversion of that parameter, but will not convert the parameter starting the next conversion cycle. Even though no conversion takes place when all ADC measurement parameters are disabled, the ADC circuitry is active and ready to begin conversion as soon as one of the bits in the ADC CONTROL 1 and ADC\_CONTROL 2 register is set to '0'.

The ADC\_DONE\_\* bits signal when a conversion is complete in 1-shot mode only. During continuous conversion mode, the ADC\_DONE\_\* bits have no meaning and will be '0'.



ADC conversion operates independently of the faults present in the device. ADC conversion will continue even after a fault has occurred (such as one that causes the power stage to be disabled), and the host must set `ADC_EN = '0'` to disable the ADC. ADC readings are only valid for DC states and not for transients. When host writes `ADC_EN=0`, the ADC stops immediately. If the host wants to exit ADC more gracefully, it is possible to do either of the following:

1. Write `ADC_RATE` to one-shot, and the ADC will stop at the end of a complete cycle of conversions, or
2. Write all the `DIS` bits low, and the ADC will stop at the end of the current measurement.

When external sense resistor (`RSNS`) is placed and `IBATADC` is used, it is recommended to use 375-kHz switching frequency.

### 8.3.10 Device Modes and Protection Status

表 8-5 shows the features and modes of the device depending on the conditions of the device.

**表 8-5. Device Modes and Protection Status**

FUNCTIONS AVAILABLE	STATE			
	BATTERY ONLY VAC1/ VAC2/ VBUS NOT PRESENT	INPUT PRESENT	INPUT PRESENT	INPUT PRESENT
		CHARGE DISABLED	DURING SOFTSTART TIMER	AFTER SOFTSTART TIMER
I <sup>2</sup> C allowed	X	X	X	X
ADC	X	X	X	X
ACDRV gate drive		X	X	X
VACOV <sub>P</sub>		X	X	X
TDIE_ALM		X	X	X
TDIE_TFL		X	X	X
BUSOV <sub>P</sub> _ALM			X	X
BUSOC <sub>P</sub> _ALM			X	X
BATO <sub>V</sub> _ALM			X	X
BATOC <sub>P</sub> _ALM			X	X
BATUC <sub>P</sub> _ALM			X	X
VOUOV <sub>P</sub>		X	X	X
TSBUS_FLT		X	X	X
TSBAT_FLT		X	X	X
BUSOV <sub>P</sub>		X	X	X
BATO <sub>V</sub>		X	X	X
BATOC <sub>P</sub>			X	X
BUSOC <sub>P</sub>			X	X
BUSUC <sub>P</sub>				X
BUSRC <sub>P</sub>			X	X

Tripping any of these protections causes  $Q_B$  to be off and converter stops switching. Masking the fault or alarm does NOT disable the protection, but only keeps an  $\overline{INT}$  from being triggered by the event. Disabling the fault or alarm protection other than `BUSUCP` holds that `STAT` and `FLAG` bits in reset, and also prevents an interrupt from occurring. Disable `BUSUCP` protection still sets `STAT` and `FLAG` bits and sends interrupt to alert host but keeps converter running when triggered.

When any `OVP`, `OCP`, `RCP` or overtemperature fault event is triggered, the `CHG_EN` bit is set to '0' to disable charging, and the charging start-up sequence must be followed to begin charging again.

### 8.3.10.1 Input Overvoltage, Overcurrent, Undercurrent, Reverse-Current and Short-Circuit Protection

**Input overvoltage protection with external single or back-to-back N-channel FET(s):** The device integrates the functionality of an input overvoltage protector. With external single or back-to-back N-channel FET(s), the device blocks high input voltage exceeding VACOV<sub>P</sub> threshold (VAC1OVP or VAC2OVP). This eliminates the need for a separate OVP device to protect the overall system. The integrated VACOV<sub>P</sub> feature has a response time of t<sub>VACOV<sub>P</sub></sub> (the actual time to turn off external FET(s) will be longer and depends upon the FET(s) gate capacitance). The VAC1OVP and VAC2OVP setting is adjustable in the VAC control register. The part allows the user to have different VAC1OVP and VAC2OVP settings. Always put the high VACOV<sub>P</sub> threshold input to VAC1.

When VAC1OVP or VAC2OVP is tripped, corresponding ACDRV is turned off and VAC1OVP\_STAT or VAC2OVP\_STAT and VAC1OVP\_FLAG or VAC2OVP\_FLAG is set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by VAC1OVP\_MASK or VAC2OVP\_MASK). When VAC2OVP is triggered, the device sends multiple interrupts when the fault persists. Use VAC1 as input unless both VAC1 and VAC2 are needed.

**Input overvoltage protection (BUSOVP):** The BUSOVP threshold is adjustable in the BUSOVP register. When BUSOVP is tripped, switched cap or bypass mode is disabled and CHG\_EN is set to '0'. BUSOVP\_STAT and BUSOVP\_FLAG is set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by BUSOVP\_MASK). The start-up sequence must be followed to resume charging.

**Input overcurrent protection (BUSOCP):** Input overcurrent protection monitors the current flow into VBUS. The overcurrent protection threshold is adjustable in the BUSOCP register. When BUSOCP is tripped, Switched Cap or Bypass Mode is disabled and CHG\_EN is set to '0'. BUSOCP\_STAT and BUSOCP\_FLAG is set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by BUSOCP\_MASK). The start-up sequence must be followed to resume charging.

**Input undercurrent protection (BUSUCP):** BUS undercurrent protection (UCP) is implemented to detect adapter unplug. Set BUSUCP = 1 (REG05[6]) before enable charge. When BUSUCP is enabled (BUSUCP\_DIS=0), if the current is below BUSUCP after soft start timer (programmable in SS\_TIMEOUT[2:0]) expires, Switched Cap or Bypass Mode is disabled and CHG\_EN is set to '0'. BUSUCP\_STAT and BUSUCP\_FLAG is set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by BUSUCP\_MASK). The start-up sequence must be followed to resume charging. The deglitch time for BUSUCP is programmable in IBUSUCP\_FALL\_DG\_SET[1:0] register. Please note that BUSUCP deglitch time needs to be set shorter than soft start timer in order for BUSUCP to be effective.

When BUSUCP is disabled (BUSUCP\_DIS=1), if the current is below BUSUCP after soft-start timer expires, CHG\_EN is not set to '0', BUSUCP\_STAT and BUSUCP\_FLAG is set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by BUSUCP\_MASK). The host can determine if charge needs to be stopped in this case.

**Input reverse-current protection (BUSRCP):** The device monitors the current flow from VBUS to VBAT to ensure there is no reverse current (current flow from VBAT to VBUS). In an event that a reverse current flow is detected when BUSRCP\_DIS is set to '0', the Switched Cap or Bypass is disabled and CHG\_EN is set to '0'. The start-up sequence must be followed to resume charging. To disable BUSRCP, set REG05[1:0] to '00' and then set BUSRCP\_DIS=1.

RCP is always active when converter is switching and BUSRCP\_DIS is set to '0'. When RCP is tripped, BUSRCP\_STAT and BUSRCP\_FLAG is set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by BUSRCP\_MASK).

**Input overvoltage and overcurrent protection alarm (BUSOVP\_ALM and BUSOCP\_ALM):** In addition to input overvoltage and overcurrent, the device also integrates alarm function BUSOVP\_ALM and BUSOCP\_ALM. When alarm is triggered, the corresponding STAT and FLAG bit is set to '1' and  $\overline{\text{INT}}$  is asserted low to alert the host (unless it is masked by the MASK bit). However, CHG\_EN is not cleared and host can reduce input voltage or input current to prevent VBUS reaching VBUSOVP threshold or IBUS reaching IBUSOCP threshold.

**VBUS\_ERRHI:** the device monitors VBUS to VOUT voltage ratio. If VBUS/VOUT is greater than V<sub>BUS\_ERRHI\_RISING</sub> threshold, the converter does not switch but CHG\_EN is kept at '1'. The converter automatically starts switching when the VBUS/VOUT drops below V<sub>BUS\_ERRHI\_FALLING</sub> threshold.

### 8.3.10.2 Battery Overvoltage and Overcurrent Protection

**BATOVP and BATOVP\_ALM:** The device integrates both overcurrent and overvoltage protection for the battery. The device monitors the battery voltage on BATP and BATN\_SRP. In order to reduce the possibility of battery terminal shorts during manufacturing, 100-Ω series resistors on BATP is required. If external sense resistor is not used, place 100-Ω series resistors on BATN as well. The device is intended to be operated within the window formed by the BATOVP and BATOVP\_ALM. When the BATOVP\_ALM is reached, an interrupt is sent to the host to reduce the charge current and thereby not reaching the BATOVP threshold. If BATOVP is reached, the switched cap or bypass is disabled and CHG\_EN is set to '0', and the start-up sequence must be followed to resume charging. At the same time, BATOVP\_STAT and BATOVP\_FLAG are set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by BATOVP\_MASK). BATOVP and BATOVP\_ALM is disabled when BATOVP\_DIS and BATOVP\_ALM\_DIS is set to '1'.

**BATOCPP and BATOCPP\_ALM:** The device monitors current through the battery by monitoring the voltage across the external series battery sense resistor. The differential voltage of this sense resistor is measured on BATN\_SRP and SRN\_SYNCIN. The device is intended to be operated within the window formed by the BATOCPP and BATOCPP\_ALM. When the BATOCPP\_ALM is reached, an interrupt is sent to the host to reduce the charge current from reaching the BATOCPP threshold. If BATOCPP is reached, the Switched Cap or Bypass is disabled after a deglitch time of  $t_{\text{BATOCPP}}$  and CHG\_EN is set to '0', and the start-up sequence must be followed to resume charging. At the same time, BATOCPP\_STAT and BATOCPP\_FLAG are set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by BATOCPP\_MASK). BATOCPP and BATOCPP\_ALM is disabled when BATOCPP\_DIS and BATOCPP\_ALM\_DIS is set to '1'.

**VOUTOVP:** The device also monitors output voltage between VOUT and ground in case of battery removal to protect the system. If VOUTOVP is reached and VOUTOVP\_DIS=0, the Switched Cap or Bypass is disabled and CHG\_EN is set to '0', and the start-up sequence must be followed to resume charging. At the same time, VOUTOVP\_STAT and VOUTOVP\_FLAG is set to '1', and  $\overline{\text{INT}}$  is asserted low to alert the host (unless masked by VOUTOVP\_MASK). If VOUTOVP\_DIS =1, the protection is disabled.

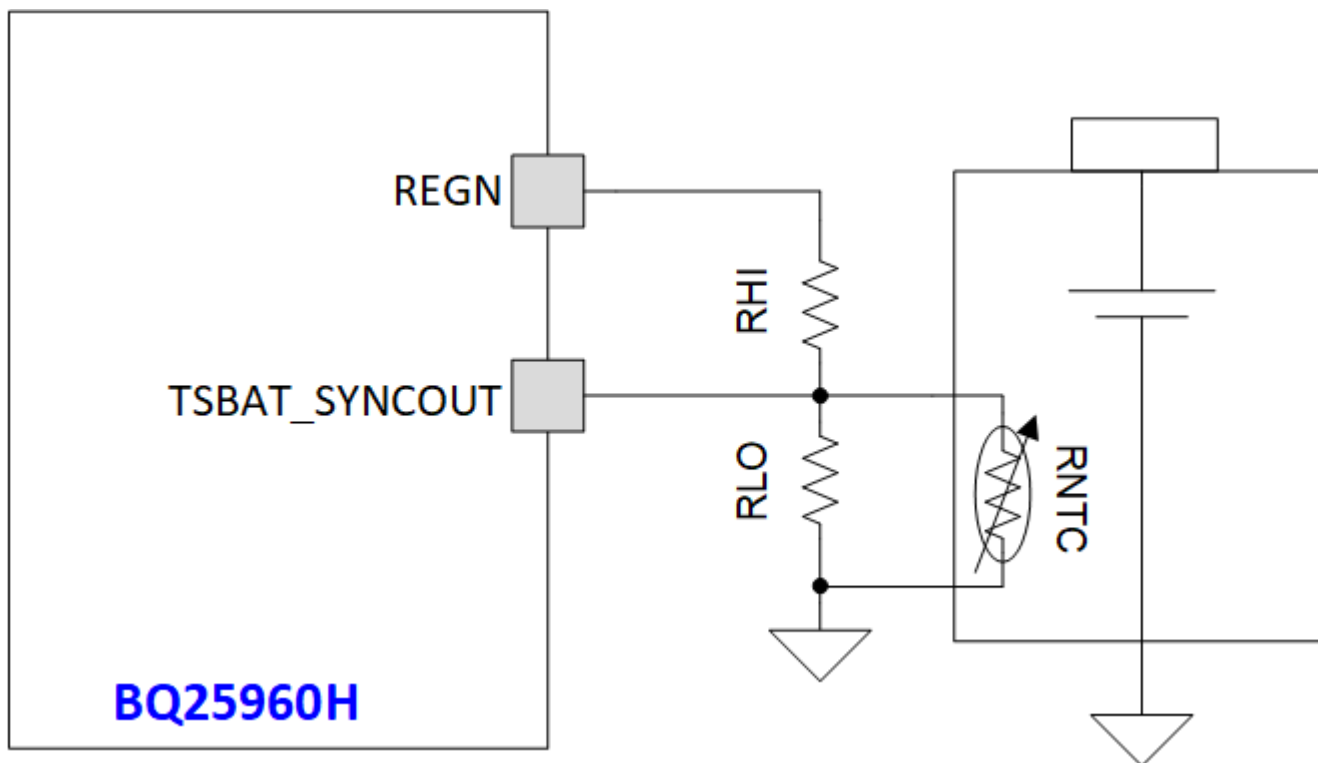
### 8.3.10.3 IC Internal Thermal Shutdown, TSBUS, and TSBAT Temperature Monitoring

The device has three temperature sensing mechanisms to protect the device and system during charging:

1. TSBUS for monitoring the cable connector temperature
2. TSBAT for monitoring the battery temperature
3. TDIE for monitoring the internal junction temperature of the device

The TSBUS and TSBAT both rely on a resistor divider that has an external pullup voltage to REGN. Place a negative coefficient thermistor (NTC) in parallel to the low-side resistor. A fault on the TSBUS and TSBAT pin is triggered on the falling edge of the voltage threshold, signifying a "hot" temperature. The threshold is adjusted using the TSBUS\_FLT and TSBAT\_FLT registers.

The typical TS resistor network on TSBAT\_SYNCOUT is illustrated in [Figure 8-8](#). The resistor network on TSBUS is the same.



**8-8. TSBAT\_SYNCOUT Resistor Network**

The RLO and RHI resistors should be chosen depending on the NTC used. If a 10-kΩ NTC is used, use 10-kΩ resistors for RLO and RHI. If a 100-kΩ NTC is used, use 100-kΩ resistors for RLO and RHI. The ratio of VTS/REGN can be from 0% to 50%, and the voltage at the TS pin is determined by the following equation.

$$TSBUS \text{ or } TSBAT (V) = \frac{\frac{1}{\left(\frac{1}{R_{NTC}} + \frac{1}{R_{LO}}\right)}}{R_{HI} + \frac{1}{\left(\frac{1}{R_{NTC}} + \frac{1}{R_{LO}}\right)}} \times V_{REGN} \quad (1)$$

The percentage of the TS pin voltage is determined by the following equation.

$$TSBUS \text{ or } TSBAT (\%) = \frac{\frac{1}{\left(\frac{1}{R_{NTC}} + \frac{1}{R_{LO}}\right)}}{R_{HI} + \frac{1}{\left(\frac{1}{R_{NTC}} + \frac{1}{R_{LO}}\right)}} \quad (2)$$

Additionally, the device measures internal junction temperature, with adjustable threshold TDIE\_FLT in TDIE\_FLT register.

If the TSBUS\_FLT, TSBAT\_FLT, and TDIE\_FLT thresholds are reached, the Switched Cap or Bypass Mode is disabled and CHG\_EN is set to '0', and the start-up sequence must be followed to resume charging. The corresponding STAT and FLAG bit is set to '1' unless it is masked by the MASK bit. If TSBUS, TSBAT, or TDIE protections are not used, the functions can be disabled in the register by setting the TSBUS\_FLT\_DIS, TSBAT\_FLT\_DIS, or TDIE\_FLT\_DIS bit to '1'.

TSBUS\_TSBAT\_ALM\_STAT and FLAG is set to '1' unless it is masked by corresponding mask bit when one of the following conditions is met: 1) TSBUS is within 5% of TSBUS\_FLT threshold or 2) TSBAT is within of TSBAT\_FLT. If the TSBUS\_FLT or TSBAT\_FLT is disabled, it will not trigger a TSBUS\_TSBAT\_ALM interrupt. Using the TDIE\_ALM register, an alarm can be set to notify the host when the device die temperature exceeds a threshold. The TDIE\_ALM\_STAT and TDIE\_ALM\_FLAG bit is set to '1' unless it is masked by TDIE\_ALM\_MASK bit. The device will not automatically stop switching when reaching the alarm threshold and the host may decide on the steps to take to lower the temperature, such as reducing the charge current.

### 8.3.11 $\overline{\text{INT}}$ Pin, STAT, FLAG, and MASK Registers

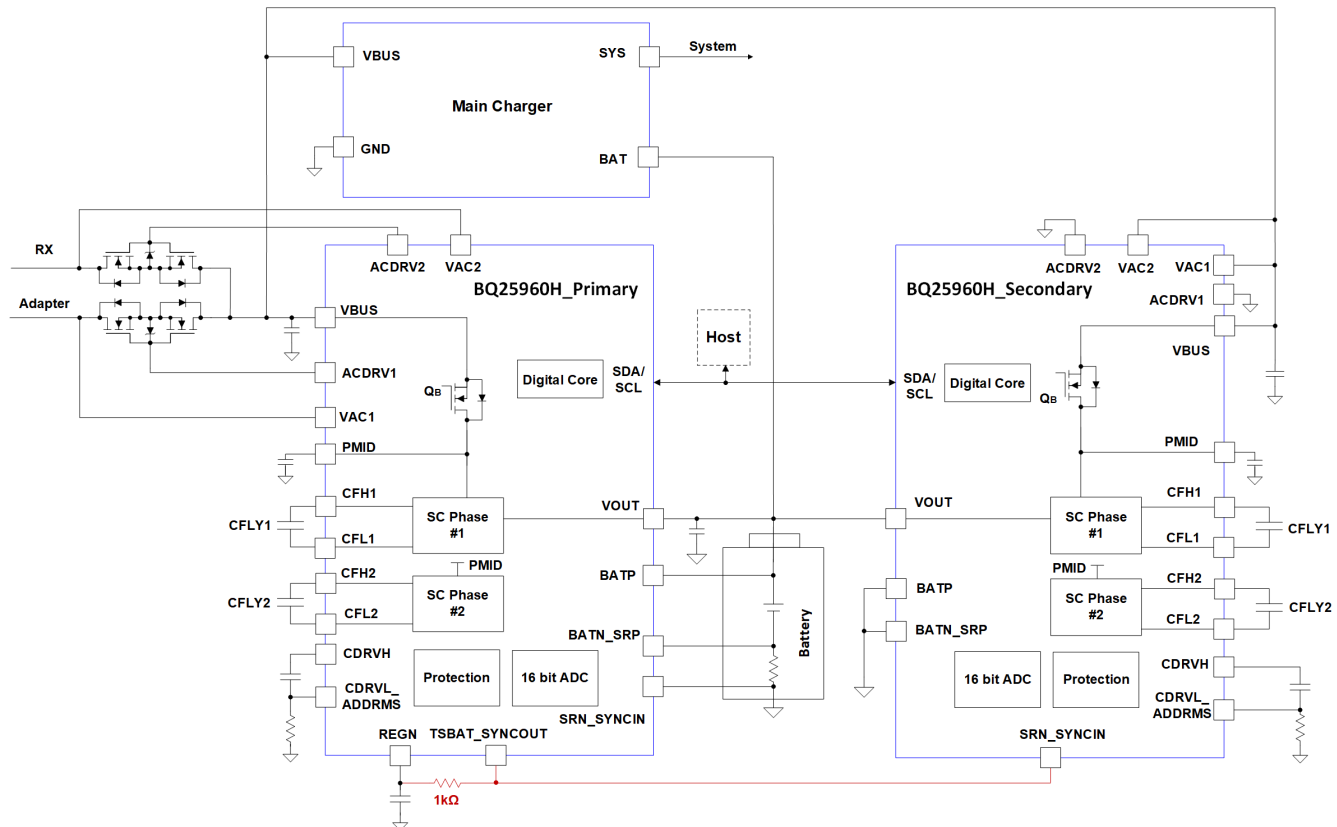
The  $\overline{\text{INT}}$  pin is an open drain pin that needs to be pulled up to a voltage with a pullup resistor.  $\overline{\text{INT}}$  is normally high and will assert low for  $t_{\text{INT}}$  when the device needs to alert the host of a fault or status change.

The fields in the STAT registers show the current status of the device, and are updated as the status changes. The fields in the FLAG registers indicate that the event has occurred, and the field is cleared when read. If the event persists after the FLAG register has been read and cleared, another  $\overline{\text{INT}}$  signal is not sent to prevent host keep receiving interrupts. The fields in the MASK registers allow the user to disable the interrupt on the  $\overline{\text{INT}}$  pin, but the STAT and FLAG registers are still updated even though  $\overline{\text{INT}}$  is not pulled low.

### 8.3.12 Dual Charger Operation Using Primary and Secondary Modes

For higher power systems, it is possible to use two devices in dual charger configuration. This allows each device to operate at lower charging current with higher efficiency compared with single device operating at the same total charging current. The CDRVL\_ADDRMS pin is used to configure the functionality of the device as Standalone, Primary or Secondary during POR. Refer to [セクション 8.3.13](#) for proper setting. When configured as a primary, the TSBAT\_SYNCOUT pin functions as SYNCOUT, and the SRN\_SYNCIN pin functions as SRN. When configured as a Secondary, the TSBAT\_SYNCOUT pin functions as TSBAT, and the SRN\_SYNCIN pin functions as SYNCIN. ACDRV1 and ACDRV2 are controlled by the primary, and ACDRV1 and ACDRV2 on the secondary should be grounded. Pull the SYNCIN/SYNCOUT pins to REGN on the primary BQ25960H through a 1-k $\Omega$  resistor. The maximum switching frequency in primary and secondary mode is 500 kHz.

The dual charger can operate in Primary and Secondary Mode in Bypass Mode as well. In both Bypass and Switched Cap Mode, the current distribution between the two devices depends on loop impedance and the chargers do not balance it. In order balance the current, the board layout needs to be as symmetrical as possible.



**図 8-9. Parallel Operation of BQ25960H**

### 8.3.13 CDRVH and CDRVL\_ADDRMS Functions

The device requires a cap between the CDRVH and CDRVL\_ADDRMS pin to operate correctly. The CDRVL\_ADDRMS pin also allows setting the default I<sup>2</sup>C address and device operation mode. Pull to GND with a resistor for the desired setting shown in 表 8-6. The surface mount resistor with  $\pm 1\%$  tolerance is recommended. After POR, the host can read back the device's configuration from MS register (REG12[1:0]).

**表 8-6. I<sup>2</sup>C Address and Mode Selection**

R <sub>ADDRMS</sub> (kΩ)	I <sup>2</sup> C ADDRESS	CONFIGURATION
>75.0	0x65	Standalone
6.19	0x67	Standalone
8.06	0x66	Dual charger (Secondary)
10.5	0x66	Dual charger (Primary)
14.0	0x66	Standalone
18.2	0x67	Dual charger (Secondary)
27.4	0x65	Dual charger (Primary)

## 8.4 Programming

The device uses an I<sup>2</sup>C compatible interface to program and read many parameters. I<sup>2</sup>C is a 2-wire serial interface developed by NXP (formerly Philips Semiconductor, see I<sup>2</sup>C BUS Specification, Version 5, October 2012). The BUS consists of a data line (SDA) and a clock line (SCL) with pullup structures. When the BUS is idle, both SDA and SCL lines are pulled high. All the I<sup>2</sup>C compatible devices connect to the I<sup>2</sup>C BUS through open drain I/O terminals, SDA and SCL. A master device, usually a microcontroller or digital signal processor, controls the BUS. The master is responsible for generating the SCL signal and device addresses. The master

also generates specific conditions that indicate the START and STOP of data transfer. A slave device receives and/or transmits data on the BUS under control of the master device.

The device works as a slave and supports the following data transfer modes, as defined in the I<sup>2</sup>C BUS™ Specification: standard mode (100 kbps) and fast mode (400 kbps). The interface adds flexibility to the battery management solution, enabling most functions to be programmed to new values depending on the instantaneous application requirements. The I<sup>2</sup>C circuitry is powered from the battery in active battery mode. The battery voltage must stay above VBATUVLO when no VIN is present to maintain proper operation.

The data transfer protocol for standard and fast modes is exactly the same; therefore, they are referred to as the F/S-mode in this document. The device only supports 7-bit addressing. The device 7-bit address is determined by the ADDR pin on the device.

#### 8.4.1 F/S Mode Protocol

The master initiates data transfer by generating a start condition. The start condition is when a high-to-low transition occurs on the SDA line while SCL is high, as shown in the figure below. All I<sup>2</sup>C-compatible devices should recognize a start condition.

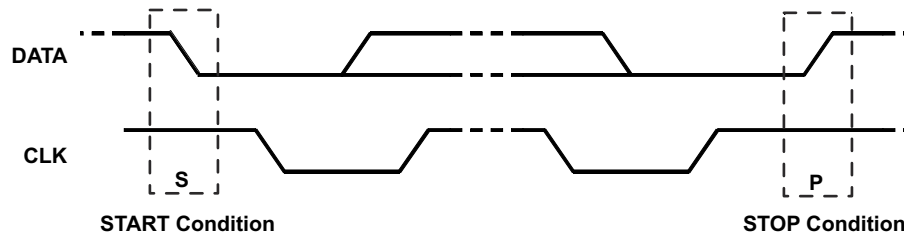


図 8-10. START and STOP Condition

The master then generates the SCL pulses, and transmits the 8-bit address and the read/write direction bit R/W on the SDA line. During all transmissions, the master ensures that data is valid. A valid data condition requires the SDA line to be stable during the entire high period of the clock pulse (see 図 8-11). All devices recognize the address sent by the master and compare it to their internal fixed addresses. Only the slave device with a matching address generates and acknowledge (see 図 8-12) by pulling the SDA line low during the entire high period of the ninth SCL cycle. Upon detecting this acknowledge, the master knows that communication link with a slave has been established.

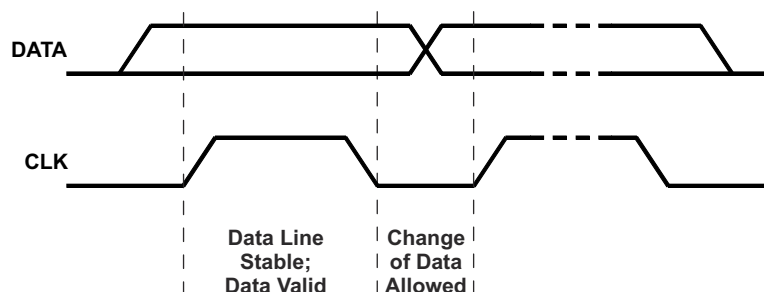


図 8-11. Bit Transfer on the Serial Interface



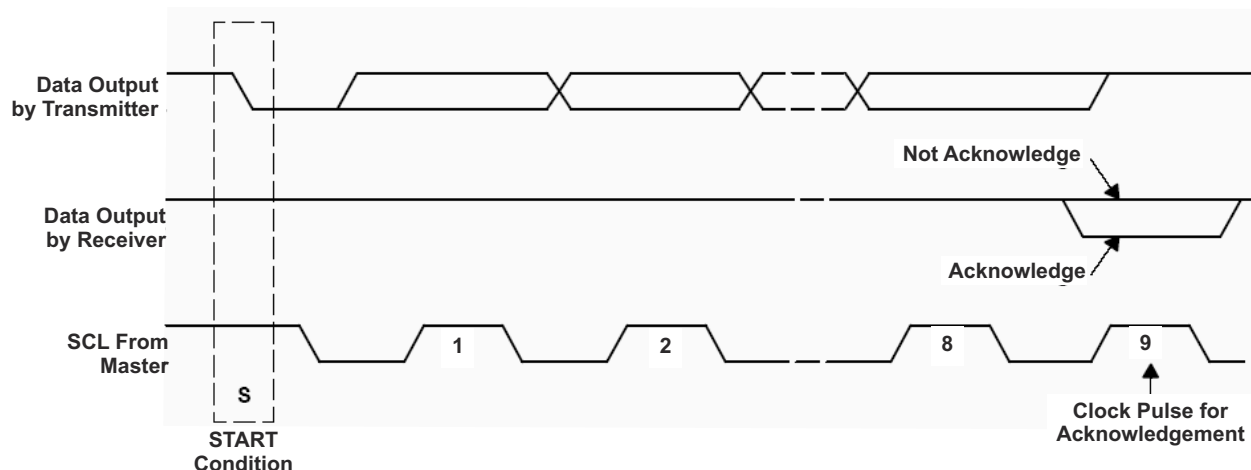


図 8-12. Acknowledge on the I<sup>2</sup>C BUS

The master generates further SCL cycles to either transmit data to the slave (R/W bit 0) or receive data from the slave (R/W bit 1). In either case, the receiver needs to acknowledge the data sent by the transmitter. An acknowledge signal can either be generated by the master or by the slave, depending on which one is the receiver. The 9-bit valid data sequences consisting of 8-bit data and 1-bit acknowledge can continue as long as necessary. To signal the end of the data transfer, the master generates a stop condition by pulling the SDA line from low to high while the SCL line is high (see 図 8-13). This releases the BUS and stops the communication link with the addressed slave. All I<sup>2</sup>C compatible devices must recognize the stop condition. Upon the receipt of a stop condition, all devices know that the BUS is released, and wait for a start condition followed by a matching address. If a transaction is terminated prematurely, the master needs to send a STOP condition to prevent the slave I<sup>2</sup>C logic from remaining in an incorrect state. Attempting to read data from register addresses not listed in this section will result in 0xFFh being read out.

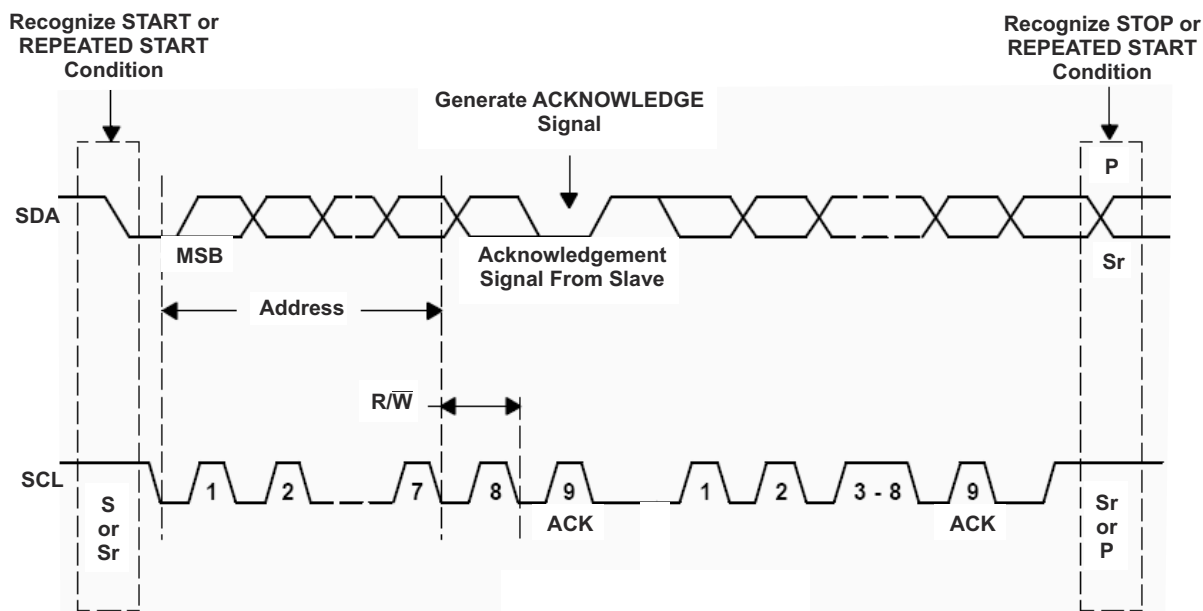


図 8-13. BUS Protocol



## 8.5 Register Maps

### 8.5.1 I<sup>2</sup>C Registers

表 8-7 lists the I<sup>2</sup>C registers. All register offset addresses not listed in 表 8-7 should be considered as reserved locations and the register contents should not be modified. All register bits marked 'RESERVED' in Field column should not be modified.

**表 8-7. I<sup>2</sup>C Registers**

Offset	Acronym	Register Name	Section
0h	REG00_BATOV_P	BATOV_P	<a href="#">Go</a>
1h	REG01_BATOV_P_ALM	BATOV_P_ALM	<a href="#">Go</a>
2h	REG02_BATOC_P	BATOC_P	<a href="#">Go</a>
3h	REG03_BATOC_P_ALM	BATOC_P_ALM	<a href="#">Go</a>
4h	REG04_BATUC_P_ALM	BATUC_P_ALM	<a href="#">Go</a>
5h	REG05_CHARGER_CONTROL 1	CHARGER_CONTROL 1	<a href="#">Go</a>
6h	REG06_BUSOV_P	BUSOV_P	<a href="#">Go</a>
7h	REG07_BUSOV_P_ALM	BUSOV_P_ALM	<a href="#">Go</a>
8h	REG08_BUSOC_P	BUSOC_P	<a href="#">Go</a>
9h	REG09_BUSOC_P_ALM	BUSOC_P_ALM	<a href="#">Go</a>
Ah	REG0A_TEMP_CONTROL	TEMP CONTROL	<a href="#">Go</a>
Bh	REG0B_TDIE_ALM	TDIE_ALM	<a href="#">Go</a>
Ch	REG0C_TSBUS_FLT	TSBUS_FLT	<a href="#">Go</a>
Dh	REG0D_TSBAT_FLT	TSBAT_FLT	<a href="#">Go</a>
Eh	REG0E_VAC_CONTROL	VAC CONTROL	<a href="#">Go</a>
Fh	REG0F_CHARGER_CONTROL 2	CHARGER CONTROL 2	<a href="#">Go</a>
10h	REG10_CHARGER_CONTROL 3	CHARGER CONTROL 3	<a href="#">Go</a>
11h	REG11_CHARGER_CONTROL 4	CHARGER CONTROL 4	<a href="#">Go</a>
12h	REG12_CHARGER_CONTROL 5	CHARGER CONTROL 5	<a href="#">Go</a>
13h	REG13_STAT 1	STAT 1	<a href="#">Go</a>
14h	REG14_STAT 2	STAT 2	<a href="#">Go</a>
15h	REG15_STAT 3	STAT 3	<a href="#">Go</a>
16h	REG16_STAT 4	STAT 4	<a href="#">Go</a>
17h	REG17_STAT 5	STAT 5	<a href="#">Go</a>
18h	REG18_FLAG 1	FLAG 1	<a href="#">Go</a>
19h	REG19_FLAG 2	FLAG 2	<a href="#">Go</a>
1Ah	REG1A_FLAG 3	FLAG 3	<a href="#">Go</a>
1Bh	REG1B_FLAG 4	FLAG 4	<a href="#">Go</a>
1Ch	REG1C_FLAG 5	FLAG 5	<a href="#">Go</a>
1Dh	REG1D_MASK 1	MASK 1	<a href="#">Go</a>
1Eh	REG1E_MASK 2	MASK 2	<a href="#">Go</a>
1Fh	REG1F_MASK 3	MASK 3	<a href="#">Go</a>
20h	REG20_MASK 4	MASK 4	<a href="#">Go</a>
21h	REG21_MASK 5	MASK 5	<a href="#">Go</a>
22h	REG22_DEVICE_INFO	DEVICE INFO	<a href="#">Go</a>
23h	REG23_ADC_CONTROL 1	ADC_CONTROL 1	<a href="#">Go</a>
24h	REG24_ADC_CONTROL 2	ADC_CONTROL 2	<a href="#">Go</a>
25h	REG25_IBUS_ADC	IBUS_ADC	<a href="#">Go</a>
27h	REG27_VBUS_ADC	VBUS_ADC	<a href="#">Go</a>

表 8-7. I<sup>2</sup>C Registers (続き)

Offset	Acronym	Register Name	Section
29h	REG29_VAC1_ADC	VAC1_ADC	<a href="#">Go</a>
2Bh	REG2B_VAC2_ADC	VAC2_ADC	<a href="#">Go</a>
2Dh	REG2D_VOUT_ADC	VOUT_ADC	<a href="#">Go</a>
2Fh	REG2F_VBAT_ADC	VBAT_ADC	<a href="#">Go</a>
31h	REG31_IBAT_ADC	IBAT_ADC	<a href="#">Go</a>
33h	REG33_TSBUS_ADC	TSBUS_ADC	<a href="#">Go</a>
35h	REG35_TSBAT_ADC	TSBAT_ADC	<a href="#">Go</a>
37h	REG37_TDIE_ADC	TDIE_ADC	<a href="#">Go</a>

Complex bit access types are encoded to fit into small table cells. 表 8-8 shows the codes that are used for access types in this section.

表 8-8. I2C Access Type Codes

Access Type	Code	Description
Read Type		
R	R	Read
Write Type		
W	W	Write
Reset or Default Value		
-n		Value after reset or the default value

#### 8.5.1.1 REG00\_BATOVP Register (Offset = 0h) [reset = 5Ah]

REG00\_BATOVP is shown in 表 8-9

Return to the [Summary Table](#).

BATOVP

表 8-9. REG00\_BATOVP Register Field Descriptions

Bit	Field	Type	Reset	Note	Description
7	BATOVP_DIS	R/W	0h	Reset by: REG_RST	Disable BATOVP Type : R/W POR: 0b 0h = Enable 1h = Disable
6-0	BATOVP_6:0	R/W	5Ah	Reset by: REG_RST	Battery Overvoltage Setting. When the battery voltage reaches the programmed threshold, Q <sub>B</sub> and switching FETs are turned off and CHG_EN is set to '0'. The host controller should monitor the bus voltage to ensure that the adapter keeps the voltage under the BATOVP threshold for proper operation. Type : R/W POR: 4390 mV (5Ah) Range : 3491 mV - 4759 mV Fixed Offset : 3491 mV Bit Step Size : 9.985 mV

#### 8.5.1.2 REG01\_BATOVP\_ALM Register (Offset = 1h) [reset = 46h]

REG01\_BATOVP\_ALM is shown in 表 8-10.

Return to the [Summary Table](#).

BATOVP\_ALM

**表 8-10. REG01\_BATOVP\_ALM Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BATOVP_ALM_DIS	R/W	0h	Reset by: REG_RST	Disable BATOVP_ALM Type : R/W POR: 0b 0h = Enable 1h = Disable
6-0	BATOVP_ALM_6:0	R/W	46h	Reset by: REG_RST	When battery voltage goes above the programmed threshold, an INT is sent. The BATOVP_ALM should be set lower than BATOVP and the host controller should monitor the battery voltage to ensure that the adapter keeps the voltage under BATOVP threshold for proper operation. Type : R/W POR: 4200 mV (46h) Range : 3500 mV - 4770 mV Fixed Offset : 3500 mV Bit Step Size : 10 mV

#### 8.5.1.3 REG02\_BATOCPP Register (Offset = 2h) [reset = 47h]

REG02\_BATOCPP is shown in [表 8-11](#).

Return to the [Summary Table](#).

BATOCPP

**表 8-11. REG02\_BATOCPP Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BATOCPP_DIS	R/W	0h	Reset by: REG_RST	Disable BATOCPP Type : R/W POR: 0b 0h = Enable 1h = Disable
6-0	BATOCPP_6:0	R/W	47h	Reset by: REG_RST	Battery Overcurrent Protection Setting. When battery current reaches the programmed threshold, the Q <sub>B</sub> and switching FETs are disabled and CHG_EN is set to '0'. The host controller should monitor the battery current to ensure that the adapter keeps the current under the threshold for proper operation. Type : R/W POR: 7277.5 mA (47h) Range : 2050 mA - 8712.5 mA Fixed Offset : 0 mA Bit Step Size : 102.5 mA

#### 8.5.1.4 REG03\_BATOCPP\_ALM Register (Offset = 3h) [reset = 46h]

REG03\_BATOCPP\_ALM is shown in [表 8-12](#).

Return to the [Summary Table](#).

BATOCPP\_ALM

**表 8-12. REG03\_BATOC\_P\_ALM Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BATOC_P_ALM_DIS	R/W	0h	Reset by: REG_RST	Disable BATOC_P_ALM Type : R/W POR: 0b 0h = Enable 1h = Disable
6-0	BATOC_P_ALM_6:0	R/W	46h	Reset by: REG_RST	Battery Overcurrent Alarm Setting. When battery current reaches the programmed threshold, an INT is sent. The BATOC_P_ALM should be set lower than BATOC_P and the host controller should monitor the battery current to ensure that the adapter keeps the current under BATOC_P threshold for proper operation. Type : R/W POR: 7000 mA (46h) Range : 0 mA - 12700 mA Fixed Offset : 0 mA Bit Step Size : 100 mA

**8.5.1.5 REG04\_BATUC\_P\_ALM (Offset = 4h) [reset = 28h]**

REG04\_BATUC\_P\_ALM is shown in [表 8-13](#).

Return to the [Summary Table](#).

BATUC\_P\_ALM

**表 8-13. REG04\_BATUC\_P\_ALM Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BATUC_P_ALM_DIS	R/W	0h	Reset by: REG_RST	Disable BATUC_P_ALM Type : R/W POR: 0b 0h = Enable 1h = Disable
6-0	BATUC_P_ALM_6:0	R/W	28h	Reset by: REG_RST	Battery Undercurrent Alarm setting. When battery current falls below the programmed threshold, an INT is sent. The host controller should monitor the battery current to determine when to disable the device and hand over charging to the main charger. Type : R/W POR: 2000 mA (28h) Range : 0 mA - 4500 mA Fixed Offset : 0 mA Bit Step Size : 50 mA

**8.5.1.6 REG05\_CHARGER\_CONTROL 1 Register (Offset = 5h) [reset = 2h]**

REG05\_CHARGER\_CONTRL 1 is shown in [表 8-14](#).

Return to the [Summary Table](#).

CHARGER\_CONTROL 1

**表 8-14. REG05\_CHARGER\_CONTROL 1 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BUSUCP_DIS	R/W	0h	Reset by: REG_RST	Disable BUSUCP Type : R/W POR: 0b 0h = Enable, BUSUCP turns off Q <sub>B</sub> and switching FETs, BUSUCP_STAT and FLAG is set to '1', and INT is sent to host. 1h = Disable, BUSUCP does not turn off Q <sub>B</sub> or switching FETs, but BUSUCP_STAT and FLAG is set to '1', and INT is sent to host.
6	BUSUCP	R/W	0h	Reset by: REG_RST	BUSUCP Setting. If input current is below BUSUCP threshold after soft start timer expires, the Q <sub>B</sub> and switching FETs are turned off and CHG_EN is set to '0' and INT is sent if BUSUCP_DIS=0. If BUSUCP_DIS=1, INT is sent to host but converter keeps running. Change this bit to '1' before CHG_EN is set to '1' in order for BUSUCP to be effective. Type : R/W POR: 0b 0h = RESERVED 1h = 250 mA
5	BUSRCP_DIS	R/W	0h	Reset by: REG_RST	Disable BUSRCP Type : R/W POR: 0b 0h = Enable 1h = Disable
4	BUSRCP	R/W	0h	Reset by: REG_RST	BUSRCP Setting, if IBUS is below BUSRCP threshold, the Q <sub>B</sub> and switching FETs are turned off and CHG_EN is set to '0' and INT is sent. Keep this bit set to '0' in order for BUSRCP to be effective. Type : R/W POR: 0b 0h = 300 mA 1h = RESERVED
3	CHG_CONFIG_1	R/W	0h	Reset by: REG_RST	Charger Configuration 1. Set this bit to '1' before CHG_EN is set to '1'. Type : R/W POR: 0h
2	VBUS_ERRHI_DIS	R/W	0h	Reset by: REG_RST	Disable VBUS_ERRHI Type : R/W POR: 0b 0h = Enable, converter does not switching, but Q <sub>B</sub> is turned on when device is in VBUS_ERRHI 1h = Disable, both converter and Q <sub>B</sub> is turned on when device is in VBUS_ERRHI
1-0	RESERVED	R/W	2h	Reset by: REG_RST	RESERVED Type : R/W POR: 10b

#### 8.5.1.7 REG06\_BUSOVP Register (Offset = 6h) [reset = 26h]

REG06\_BUSOVP is shown in [表 8-15](#).

Return to the [Summary Table](#).

BUSOVP

**表 8-15. REG06\_BUSOVP Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BUS_PD_EN	R/W	0h	Reset by: REG_RST	VBUS Pulldown Resistor Control Type : R/W POR: 0b 0h = Disable 1h = Enable
6-0	BUSOVP_6:0	R/W	26h	Reset by: REG_RST	Bus Overvoltage Setting. When the bus voltage reaches the programmed threshold, Q <sub>B</sub> and switching FETs are turned off and CHG_EN is set to '0'. The host controller should monitor the bus voltage to ensure that the adapter keeps the voltage under the BUSOVP threshold for proper operation. Switched cap mode: Type : R/W POR: 8900 mV (26h) Range : 7000 mV - 12750 mV Fixed Offset : 7000 mV Bit Step Size : 50 mV Bypass Mode: Type : R/W POR: 4450 mV (26h) Range : 3500 mV - 6500 mV Fixed Offset : 3500 mV Bit Step Size : 25 mV

**8.5.1.8 REG07\_BUSOVP\_ALM Register (Offset = 7h) [reset = 22h]**

REG07\_BUSOVP\_ALM is shown in [表 8-16](#).

Return to the [Summary Table](#).

BUSOVP\_ALM

**表 8-16. REG07\_BUSOVP\_ALM Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BUSOVP_ALM_DIS	R/W	0h	Reset by: REG_RST	Disable BUSOVP_ALM Type : R/W POR: 0b 0h = Enable 1h = Disable
6-0	BUSOVP_ALM_6:0	R/W	22h	Reset by: REG_RST	Bus Overvoltage Alarm Setting. When the bus voltage reaches the programmed threshold, an INT is sent. The host controller should monitor the bus voltage to ensure that the adapter keeps the voltage under the BUSOVP threshold for proper operation. Switched Cap Mode: Type : R/W POR: 8700 mV (22h) Range : 7000 mV - 13350 mV Fixed Offset : 7000 mV Bit Step Size : 50 mV Bypass Mode: Type : R/W POR: 4350 mV (22h) Range : 3500 mV - 6675 mV Fixed Offset : 3500 mV Bit Step Size : 25 mV

### 8.5.1.9 REG08\_BUSOCP Register (Offset = 8h) [reset = Bh]

REG08\_BUSOCP is shown in 表 8-17.

Return to the [Summary Table](#).

BUSOCP

**表 8-17. REG08\_BUSOCP Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7-5	RESERVED	R	0h		RESERVED
4-0	BUSOCP_4:0	R/W	Bh	Reset by: REG_RST	BUS Overcurrent Protection Setting. When the bus current reaches the programmed threshold, the output is disabled. The host controller should monitor the bus current to ensure that the adapter keeps the current under this threshold for proper operation. Type : R/W Switched Cap Mode: POR: 3816 mA (Bh) Range: 1017.5 mA - 4579 mA Fixed Offset : 1017.5 mA Bit Step Size : 254 mA Bypass Mode: POR: 3928 mA (Bh) Range: 1047.5 mA - 6809 mA Fixed Offset : 1047.5 mA Bit Step Size : 262 mA

### 8.5.1.10 REG09\_BUSOCP\_ALM Register (Offset = 9h) [reset = Ch]

REG09\_BUSOCP\_ALM is shown in 表 8-18.

Return to the [Summary Table](#).

BUSOCP\_ALM

**表 8-18. REG09\_BUSOCP\_ALM Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BUSOCP_ALM_DIS	R/W	0h	Reset by: REG_RST	Disable BUSOCP_ALM Type : R/W POR: 0b 0h = Enable 1h = Disable
6-5	RESERVED	R	0h		RESERVED
4-0	BUSOCP_ALM_4:0	R/W	Ah	Reset by: REG_RST	Bus Overvoltage Alarm Setting. When the bus current reaches the programmed threshold, an $\overline{\text{INT}}$ is sent. The host controller should monitor the bus current to ensure that the adapter keeps the current under the BUSOCP threshold for proper operation. Type : R/W POR: 3500 mA (Ah) Range : 1000 mA - 8750 mA Fixed Offset : 1000 mA Bit Step Size : 250 mA

### 8.5.1.11 REG0A\_TEMP\_CONTROL Register (Offset = Ah) [reset = 60h]

REG0A\_TEMP\_CONTROL is shown in 表 8-19.

Return to the [Summary Table](#).

## TEMP\_CONTROL

表 8-19. REG0A\_TEMP\_CONTROL Register Field Descriptions

Bit	Field	Type	Reset	Note	Description
7	TDIE_FLT_DIS	R/W	0h	Reset by: REG_RST	Disable TDIE Overtemperature Protection Type : R/W POR: 0b 0h = TDIE_FLT enable 1h = TDIE_FLT disable
6-5	TDIE_FLT_1:0	R/W	3h	Reset by: REG_RST	TDIE Overtemperature Setting. When the junction temperature reaches the programmed threshold, the Q <sub>B</sub> and switching FETs are turned off and CHG_EN is set to '0'. Type : R/W POR: 11b 0h = 80C 1h = 100C 2h = 120C 3h = 140C
4	TDIE_ALM_DIS	R/W	0h	Reset by: REG_RST	Disable TDIE Overtemperature Alarm Type : R/W POR: 0b 0h = TDIE_ALM enable 1h = TDIE_ALM disable
3	TSBUS_FLT_DIS	R/W	0h	Reset by: REG_RST	Disable TSBUS_FLT Type : R/W POR: 0b 0h = TSBUS_FLT enable 1h = TSBUS_FLT disable
2	TSBAT_FLT_DIS	R/W	0h	Reset by: REG_RST	Disable TSBAT_FLT Type : R/W POR: 0b 0h = TSBAT_FLT enable 1h = TSBAT_FLT disable
1-0	RESERVED	R	0h		RESERVED Type : R POR: 00b

## 8.5.1.12 REG0B\_TDIE\_ALM Register (Offset = Bh) [reset = C8h]

REG0B\_TDIE\_ALM is shown in 表 8-20.

Return to the [Summary Table](#).

TDIE\_ALM

表 8-20. REG0B\_TDIE\_ALM Register Field Descriptions

Bit	Field	Type	Reset	Note	Description
7-0	TDIE_ALM_7:0	R/W	C8h	Reset by: REG_RST	Die Overtemperature Alarm Setting. When the junction temperature reaches the programmed threshold, an INT is sent. Type : R/W POR: 125°C (C8h) Range : 25°C - 150°C Fixed Offset : 25°C Bit Step Size : 0.5°C



### 8.5.1.13 REG0C\_TSBUS\_FLT Register (Offset = Ch) [reset = 15h]

REG0C\_TSBUS\_FLT is shown in 表 8-21.

Return to the [Summary Table](#).

TSBUS\_FLT

**表 8-21. REG0C\_TSBUS\_FLT Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7-0	TSBUS_FLT_7:0	R/W	15h	Reset by: REG_RST	TSBUS Percentage Fault Threshold. When the TSBUS/REGN ratio drops below the programmed threshold, the Q <sub>B</sub> and switching FETs are turned off and CHG_EN is set to '0'. Type : R/W POR: 4.10151% (15h) Range : 0% - 49.8041% Fixed Offset : 0% Bit Step Size : 0.19531%

### 8.5.1.14 REG0D\_TSBAT\_FLT Register (Offset = Dh) [reset = 15h]

REG0D\_TSBAT\_FLG is shown in 表 8-22.

Return to the [Summary Table](#).

TSBAT\_FLG

**表 8-22. REG0D\_TSBAT\_FLT Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7-0	TSBAT_FLT_7:0	R/W	15h	Reset by: REG_RST	TSBAT Percentage Fault Threshold. When the TSBAT/REGN ratio drops below the programmed threshold, the Q <sub>B</sub> and switching FETs are turned off and CHG_EN is set to '0'. Type : R/W POR: 4.10151% (15h) Range : 0% - 49.8041% Fixed Offset : 0% Bit Step Size : 0.19531%

### 8.5.1.15 REG0E\_VAC\_CONTROL Register (Offset = Eh) [reset = Ch]

REG0E\_VAC\_CONTROL is shown in 表 8-23.

Return to the [Summary Table](#).

VAC\_CONTROL

**表 8-23. REG0E\_VAC\_CONTROL Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7-5	VAC1OVP_2:0	R/W	0h	Reset by: REG_RST	VAC1OVP Setting. When VAC1 voltage reaches the programmed threshold, ACDRV1 is turned off. Type : R/W POR: 000b 0h = 6.5 V 1h = 10.5 V 2h = 12 V 3h = 14 V 4h = 16 V 5h = 18 V

**表 8-23. REG0E\_VAC\_CONTROL Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Note	Description
4-2	VAC2OVP_2:0	R/W	3h	Reset by: REG_RST	VAC2OVP Setting. When VAC2 voltage reaches the programmed threshold, ACDRV2 is turned off. Type : R/W POR: 011b 0h = 6.5 V 1h = 10.5 V 2h = 12 V 3h = 14 V 4h = 16 V 5h = 18 V
1	VAC1_PD_EN	R/W	0h	Reset by: REG_RST	Enable VAC1 Pulldown Resistor Type : R/W POR: 0b 0h = Disable 1h = Enable
0	VAC2_PD_EN	R/W	0h	Reset by: REG_RST	Enable VAC2 Pulldown Resistor Type : R/W POR: 0b 0h = Disable 1h = Enable

**8.5.1.16 REG0F\_CHARGER\_CONTROL 2 Register (Offset = Fh) [reset = 0h]**

REG0F\_CHARGER\_CONTROL 2 is shown in [表 8-24](#).

Return to the [Summary Table](#).

**CHARGER CONTROL 2****表 8-24. REG0F\_CHARGER\_CONTROL 2 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	REG_RST	R/W	0h	Reset by: REG_RST	Register Reset. Reset registers to default values and reset timer. This bit automatically goes back to '0' after reset. Type : R/W POR: 0b 0h = Not reset register 1h = Reset register
6	EN_HIZ	R/W	0h	Reset by: REG_RST	Enable HIZ Mode. When device is in HIZ mode, converter stops switching, ADC stops converting, ACDRV is turned off and the REGN LDO is forced off. Type : R/W POR: 0b 0h = Disable HIZ mode 1h = Enable HIZ mode
5	EN_OTG	R/W	0h	Reset by: WATCHDOG REG_RST	Power Path Control During the OTG and Reverse TX Mode Type : R/W POR: 0b 0h = Don't allow host to control ACDRV(s) 1h = Allow host to control ACDRV(s)
4	CHG_EN	R/W	0h	Reset by: WATCHDOG REG_RST	Charge Enable Type : R/W POR: 0b 0h = Disable charge 1h = Enable charge

**表 8-24. REG0F\_CHARGER\_CONTROL 2 Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Note	Description
3	EN_BYPASS	R/W	0h	Reset by: WATCHDOG REG_RST	Enable Bypass Mode Type : R/W POR: 0b 0h = Disable Bypass Mode 1h = Enable Bypass Mode
2	DIS_ACDRV_BOTH	R/W	0h		Disable Both ACDRV. When this bit is set, the device forces both ACDRV off. It is not reset by the REG_RST or the WATCHDOG. Type : R/W POR: 0b 0h = ACDRV1 and ACDRV2 can be turned on 1h = ACDRV1 and ACDRV2 are forced off
1	ACDRV1_STAT	R/W	0h		External ACFET1-RBFET1 Gate Driver Status. For dual input with two sets ACFET-RBFET, this bit can be used to swap input. It is not reset by the REG_RST or the WATCHDOG. Type : R/W POR: 0b 0h = ACDRV1 is OFF 1h = ACDRV1 is ON
0	ACDRV2_STAT	R/W	0h		External ACFET2-RBFET2 Gate Driver Status. For dual input with two sets ACFET-RBFET, this bit can be used to swap input. It is not reset by the REG_RST or the WATCHDOG. Type : R/W POR: 0b 0h = ACDRV2 is OFF 1h = ACDRV2 is ON

#### 8.5.1.17 REG10\_CHARGER\_CONTROL 3 Register (Offset = 10h) [reset = 83h]

REG10\_CHARGER\_CONTROL 3 is shown in [表 8-25](#).

Return to the [Summary Table](#).

#### CHARGER CONTROL 3

**表 8-25. REG10\_CHARGER\_CONTROL 3 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7-5	FSW_SET_2:0	R/W	4h		Set Switching Frequency in Switched Cap Mode. It is not reset by the REG_RST or the WATCHDOG. Type : R/W POR: 100b 0h = 187.5 kHz 1h = 250 kHz 2h = 300 kHz 3h = 375 kHz 4h = 500 kHz 5h = 750 kHz The maximum switching frequency is 500 kHz in dual charger configuration.

**表 8-25. REG10\_CHARGER\_CONTROL 3 Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Note	Description
4-3	WATCHDOG_1:0	R/W	0h	Reset by: REG_RST	Watchdog Timer Type : R/W POR: 00b 0h = 0.5 s 1h = 1 s 2h = 5 s 3h = 30 s
2	WATCHDOG_DIS	R/W	0h	Reset by: REG_RST	Watchdog Timer Control Type : R/W POR: 0b 0h = Enable 1h = Disable
1-0	RESERVED	R	3h		RESERVED

**8.5.1.18 REG11\_CHARGER\_CONTROL 4 Register (Offset = 11h) [reset = 71h]**

REG11\_CHARGER\_CONTROL 4 is shown in [表 8-26](#).

Return to the [Summary Table](#).

**CHARGER CONTROL 4****表 8-26. REG11\_CHARGER\_CONTROL 4 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	RSNS	R/W	0h	Reset by: REG_RST	Battery Current Sense Resistor Value Type : R/W POR: 0b 0h = 2 mΩ 1h = 5 mΩ
6-4	SS_TIMEOUT_2:0	R/W	7h		Soft Start Timeout to Check if Input Current is Above BUSUCP Threshold. It is not reset by the REG_RST or the WATCHDOG. Type : R/W POR: 111b 0h = 6.25 ms 1h = 12.5 ms 2h = 25 ms 3h = 50 ms 4h = 100 ms 5h = 400 ms 6h = 1.5 s 7h = 10 s
3-2	IBUSUCP_FALL_DG_SEL_1:0	R/W	0h	Reset by: REG_RST	BUSUCP Deglitch Timer Type : R/W POR: 00b 0h = 0.01 ms 1h = 5 ms 2h = 50 ms 3h = 150 ms
1-0	RESERVED	R/W	1h	Reset by: REG_RST	RESERVED Type : R/W POR: 1b

### 8.5.1.19 REG12\_CHARGER\_CONTROL 5 Register (Offset = 12h) [reset = 60h]

REG12\_CHARGER\_CONTROL 5 is shown in 表 8-27.

Return to the [Summary Table](#).

#### CHARGER CONTROL 5

**表 8-27. REG12\_CHARGER\_CONTROL 5 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	VOUTOVP_DIS	R/W	0h	Reset by: REG_RST	Disable VOUTOVP Type : R/W POR: 0b 0h = Enable 1h = Disable
6-5	VOUTOVP_1:0	R/W	3h	Reset by: REG_RST	VOUTOVP Protection. When output voltage is above the programmed threshold, Q <sub>B</sub> and switching FETs are turned off and CHG_EN is set to '0'. Type : R/W POR: 11b 0h = 4.7 V 1h = 4.8 V 2h = 4.9 V 3h = 5.0 V
4-3	FREQ_SHIFT_1:0	R/W	0h	Reset by: REG_RST	Adjust Switching Frequency Type : R/W POR: 00b 0h = Nominal switching frequency set in REG10[7:5] 1h = Set switching frequency 10% higher than normal 2h = Set switching frequency 10% lower than normal
2	RESERVED	R/W	0h	Reset by: REG_RST	RESERVED Type : R/W POR: 0b
1-0	MS_1:0	R	0h		Primary, Secondary, Standalone Operation Type : R POR: 00b 0h = Standalone 1h = Secondary 2h = Primary

### 8.5.1.20 REG13\_STAT 1 Register (Offset = 13h) [reset = 0h]

REG13\_STAT 1 is shown in 表 8-28.

Return to the [Summary Table](#).

#### STAT 1

**表 8-28. REG13\_STAT 1 Register Field Descriptions**

Bit	Field	Type	Reset	Description
7	BATOVP_STAT	R	0h	BATOVP Status Type : R POR: 0b 0h = Not in BATOVP 1h = In BATOVP

表 8-28. REG13\_STAT 1 Register Field Descriptions (続き)

Bit	Field	Type	Reset	Description
6	BATOVP_ALM_STAT	R	0h	BATOVP_ALM Status Type : R POR: 0b 0h = Not in BATOVP_ALM 1h = In BATOVP_ALM
5	VOUTOVP_STAT	R	0h	VOUTOVP Status Type : R POR: 0b 0h = Not in VOUTOVP 1h = in VOUTOVP
4	BATOCP_STAT	R	0h	BATOCP Status Type : R POR: 0b 0h = Not in BATOCP 1h = In BATOCP
3	BATOCP_ALM_STAT	R	0h	BATOCP_ALM Status Type : R POR: 0b 0h = Not in BATOCP_ALM 1h = In BATOCP_ALM
2	BATUCP_ALM_STAT	R	0h	BATUCP_ALM Status Type : R POR: 0b 0h = Not in BATUCP_ALM 1h = In BATUCP_ALM
1	BUSOVP_STAT	R	0h	VBUSOVP Status Type : R POR: 0b 0h = Not in VBUS OVP 1h = In VBUS OVP
0	BUSOVP_ALM_STAT	R	0h	BUSOVP_ALM Status Type : R POR: 0b 0h = Not in BUSOVP_ALM 1h = In BUSOVP_ALM

## 8.5.1.21 REG14\_STAT 2 Register (Offset = 14h) [reset = 0h]

REG14\_STAT 2 is shown in 表 8-29.

Return to the [Summary Table](#).

STAT 2

表 8-29. REG14\_STAT 2 Register Field Descriptions

Bit	Field	Type	Reset	Description
7	BUSOCP_STAT	R	0h	BUSOCP Status Type : R POR: 0b 0h = Not in BUSOCP 1h = In BUSOCP

**表 8-29. REG14\_STAT 2 Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Description
6	BUSOCP_ALM_STAT	R	0h	BUSOCP_ALM Status Type : R POR: 0b 0h = Not in BUSOCP_ALM 1h = In BUSOCP_ALM
5	BUSUCP_STAT	R	0h	BUSUCP Status Type : R POR: 0b 0h = Not in BUSUCP 1h = In BUSUCP
4	BUSRCP_STAT	R	0h	BUSRCP Status Type : R POR: 0b 0h = Not in BUSRCP 1h = In BUSRCP
3	RESERVED	R	0h	RESERVED
2	CFLY_SHORT_STAT	R	0h	CFLY Short Detection Status Type : R POR: 0b 0h = CFLY not shorted 1h = CFLY shorted
1-0	RESERVED	R	0h	RESERVED

#### 8.5.1.22 REG15\_STAT 3 Register (Offset = 15h) [reset = 0h]

REG15\_STAT 3 is shown in [表 8-30](#).

Return to the [Summary Table](#).

STAT 3

**表 8-30. REG15\_STAT 3 Register Field Descriptions**

Bit	Field	Type	Reset	Description
7	VAC1OVP_STAT	R	0h	VAC1 OVP Status Type : R POR: 0b 0h = Not in VAC1 OVP 1h = In VAC1 OVP
6	VAC2OVP_STAT	R	0h	VAC2 OVP Status Type : R POR: 0b 0h = Not in VAC2 OVP 1h = In VAC2 OVP
5	VOUTPRESENT_STAT	R	0h	VOUT Present Status Type : R POR: 0b 0h = VOUT not present 1h = VOUT present
4	VAC1PRESENT_STAT	R	0h	VAC1 Present Status Type : R POR: 0b 0h = VAC1 not present 1h = VAC1 present

表 8-30. REG15\_STAT 3 Register Field Descriptions (続き)

Bit	Field	Type	Reset	Description
3	VAC2PRESENT_STAT	R	0h	VAC2 Present Status Type : R POR: 0b 0h = VAC2 not present 1h = VAC2 present
2	VBUSPRESENT_STAT	R	0h	VBUS Present Status Type : R POR: 0b 0h = VBUS not present 1h = VBUS present
1	ACRB1_CONFIG_STAT	R	0h	ACFET1-RBFET1 Status Type : R POR: 0b 0h = ACFET1-RBFET1 is not placed 1h = ACFET1-RBFET1 is placed
0	ACRB2_CONFIG_STAT	R	0h	ACFET2-RBFET2 Status Type : R POR: 0b 0h = ACFET2-RBFET2 is not placed 1h = ACFET2-RBFET2 is placed

## 8.5.1.23 REG16\_STAT 4 Register (Offset = 16h) [reset = 0h]

REG16\_STAT 4 is shown in 表 8-31.

Return to the [Summary Table](#).

STAT 4

表 8-31. REG16\_STAT 4 Register Field Descriptions

Bit	Field	Type	Reset	Description
7	ADC_DONE_STAT	R	0h	ADC Conversion Status (in One-Shot Mode only) Note: Always reads 0 in continuous mode Type : R POR: 0b 0h = Conversion not complete 1h = Conversion complete
6	SS_TIMEOUT_STAT	R	0h	Soft-Start Timeout Status Type : R POR: 0b 0h = Device not in soft timeout 1h = Device in soft timeout
5	TSBUS_TSBAT_ALM_STAT	R	0h	TSBUS and TSBAT ALM Status Type : R POR: 0b 0h = TSBUS or TSBAT threshold is NOT within 5% of the TSBUS_FLT or TSBAT_FLT set threshold 1h = TSBUS or TSBAT threshold is within 5% of the TSBUS_FLT or TSBAT_FLT set threshold
4	TSBUS_FLT_STAT	R	0h	TSBUS_FLT Status Type : R POR: 0b 0h = Not in TSBUS_FLT 1h = In TSBUS_FLT



**表 8-31. REG16\_STAT 4 Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Description
3	TSBAT_FLT_STAT	R	0h	TSBAT_FLT Status Type : R POR: 0b 0h = Not in TSBAT_FLT 1h = In TSBAT_FLT
2	TDIE_FLT_STAT	R	0h	TDIE Fault Status Type : R POR: 0b 0h = Not in TDIE fault 1h = In TDIE fault
1	TDIE_ALM_STAT	R	0h	TDIE_ALM Status Type : R POR: 0b 0h = Not in TDIE_ALM 1h = In TDIE_ALM
0	WD_STAT	R	0h	I <sup>2</sup> C Watch Dog Status Type : R POR: 0b 0h = Normal 1h = WD timer expired

#### 8.5.1.24 REG17\_STAT 5 Register (Offset = 17h) [reset = 0h]

REG17\_STAT 5 is shown in [表 8-32](#).

Return to the [Summary Table](#).

STAT 5

**表 8-32. REG17\_STAT 5 Register Field Descriptions**

Bit	Field	Type	Reset	Description
7	REGN_GOOD_STAT	R	0h	REGN_GOOD Status Type : R POR: 0b 0h = REGN not good 1h = REGN good
6	CONV_ACTIVE_STAT	R	0h	Converter Active Status Type : R POR: 0b 0h = Converter not running 1h = Converter running
5	RESERVED	R	0h	RESERVED
4	VBUS_ERRHI_STAT	R	0h	VBUS_ERRHI Status Type : R POR: 0b 0h = Not in VBUS_ERRHI status 1h = In VBUS_ERRHI status
3-0	RESERVED	R	0h	RESERVED

#### 8.5.1.25 REG18\_FLAG 1 Register (Offset = 18h) [reset = 0h]

REG18\_FLAG 1 is shown in [表 8-33](#).

Return to the [Summary Table](#).

FLAG 1

**表 8-33. REG18\_FLAG 1 Register Field Descriptions**

Bit	Field	Type	Reset	Description
7	BATOV_P_FLAG	R	0h	BATOV_P Flag Type : R POR: 0b 0h = Normal 1h = BATOV_P status changed
6	BATOV_P_ALM_FLAG	R	0h	BATOV_P_ALM Flag Type : R POR: 0b 0h = Normal 1h = BATOV_P_ALM status changed
5	VOUOV_P_FLAG	R	0h	VOUOV_P Flag Type : R POR: 0b 0h = Normal 1h = VOUOV_P status changed
4	BATOC_P_FLAG	R	0h	BATOC_P Flag Type : R POR: 0b 0h = Normal 1h = BATOC_P status changed
3	BATOC_P_ALM_FLAG	R	0h	BATOC_P_ALM Flag Type : R POR: 0b 0h = Normal 1h = BATOC_P_ALM status changed
2	BATUC_P_ALM_FLAG	R	0h	BATUC_P_ALM Flag Type : R POR: 0b 0h = Normal 1h = BATUC_P_ALM status changed
1	BUSOV_P_FLAG	R	0h	BUSOV_P Flag Type : R POR: 0b 0h = Normal 1h = BUSOV_P status changed
0	BUSOV_P_ALM_FLAG	R	0h	BUSOV_P_ALM Flag Type : R POR: 0b 0h = Normal 1h = BUSOV_P_ALM status changed

#### 8.5.1.26 REG19\_FLAG 2 Register (Offset = 19h) [reset = 0h]

REG19\_FLAG 2 is shown in [表 8-34](#).

Return to the [Summary Table](#).

FLAG 2

**表 8-34. REG19\_FLAG 2 Register Field Descriptions**

Bit	Field	Type	Reset	Description
7	BUSOCP_FLAG	R	0h	BUSOCP Flag Type : R POR: 0b 0h = Normal 1h = BUSOCP status changed
6	BUSOCP_ALM_FLAG	R	0h	BUSOCP_ALM Flag Type : R POR: 0b 0h = Normal 1h = BUSOCP_ALM status changed
5	BUSUCP_FLAG	R	0h	BUSUCP Flag Type : R POR: 0b 0h = Normal 1h = BUSUCP status changed
4	BUSRCP_FLAG	R	0h	BUSRCP Flag Type : R POR: 0b 0h = Normal 1h = BUSRCP status changed
3	RESERVED	R	0h	RESERVED
2	CFLY_SHORT_FLAG	R	0h	CFLY Short Flag Type : R POR: 0b 0h = Normal 1h = CFLY_SHORT status changed
1-0	RESERVED	R	0h	RESERVED

#### 8.5.1.27 REG1A\_FLAG 3 Register (Offset = 1Ah) [reset = 0h]

REG1A\_FLAG 3 is shown in [表 8-35](#).

Return to the [Summary Table](#).

FLAG 3

**表 8-35. REG1A\_FLAG 3 Register Field Descriptions**

Bit	Field	Type	Reset	Description
7	VAC1OVP_FLAG	R	0h	VAC1OVP Flag Type : R POR: 0b 0h = Normal 1h = VAC1 OVP status changed
6	VAC2OVP_FLAG	R	0h	VAC2OVP Flag Type : R POR: 0b 0h = Normal 1h = VAC2 OVP status changed
5	VOUTPRESENT_FLAG	R	0h	VOUT Present Flag Type : R POR: 0b 0h = Normal 1h = VOUT present status changed

表 8-35. REG1A\_FLAG 3 Register Field Descriptions (続き)

Bit	Field	Type	Reset	Description
4	VAC1PRESENT_FLAG	R	0h	VAC1 Present Flag Type : R POR: 0b 0h = Normal 1h = VAC1 present status changed
3	VAC2PRESENT_FLAG	R	0h	VAC2 Present Flag Type : R POR: 0b 0h = Normal 1h = VAC2 present status changed
2	VBUSPRESENT_FLAG	R	0h	VBUS Present Flag Type : R POR: 0b 0h = Normal 1h = VBUS present status changed
1	ACRB1_CONFIG_FLAG	R	0h	ACFET1-RBFET1_CONFIG Flag Type : R POR: 0b 0h = Normal 1h = ACFET1-RBFET1_CONFIG status changed
0	ACRB2_CONFIG_FLAG	R	0h	ACFET2-RBFET2_CONFIG Flag Type : R POR: 0b 0h = Normal 1h = ACFET2-RBFET2_CONFIG status changed

## 8.5.1.28 REG1B\_FLAG 4 Register (Offset = 1Bh) [reset = 0h]

REG1B\_FLAG 4 is shown in 表 8-36.

Return to the [Summary Table](#).

FLAG 4

表 8-36. REG1B\_FLAG 4 Register Field Descriptions

Bit	Field	Type	Reset	Description
7	ADC_DONE_FLAG	R	0h	ADC Conversion Flag (in One-Shot Mode only) Type : R POR: 0b 0h = Normal 1h = ADC conversion done status changed
6	SS_TIMEOUT_FLAG	R	0h	Soft-Start Timeout Flag Type : R POR: 0b 0h = Normal 1h = Soft start timeout status changed
5	TSBUS_TSBAT_ALM_FLAG	R	0h	TSBUS_TSBAT_ALM Flag Type : R POR: 0b 0h = Normal 1h = Converter active status changed

**表 8-36. REG1B\_FLAG 4 Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Description
4	TSBUS_FLT_FLAG	R	0h	TSBUS_FLT Flag Type : R POR: 0b 0h = Normal 1h = TSBUS_FLT status changed
3	TSBAT_FLT_FLAG	R	0h	TSBAT_FLT Flag Type : R POR: 0b 0h = Normal 1h = TSBAT_FLT status changed
2	TDIE_FLT_FLAG	R	0h	TDIE_FLT Flag Type : R POR: 0b 0h = Normal 1h = TDIE_FLT status changed
1	TDIE_ALM_FLAG	R	0h	TDIE_ALM Flag Type : R POR: 0b 0h = Normal 1h = TDIE_ALM status changed
0	WD_FLAG	R	0h	I <sup>2</sup> C Watch Dog Timer Flag Type : R POR: 0b 0h = Normal 1h = WD timer status changed

#### 8.5.1.29 REG1C\_FLAG 5 Register (Offset = 1Ch) [reset = 0h]

REG1C\_FLAG 5 is shown in [表 8-37](#).

Return to the [Summary Table](#).

FLAG 5

**表 8-37. REG1C\_FLAG 5 Register Field Descriptions**

Bit	Field	Type	Reset	Description
7	REGN_GOOD_FLAG	R	0h	REGN_GOOD Flag Type : R POR: 0b 0h = Normal 1h = REGN_GOOD status changed
6	CONV_ACTIVE_FLAG	R	0h	Converter Active Flag Type : R POR: 0b 0h = Normal 1h = Converter active status changed
5	RESERVED	R	0h	RESERVED
4	VBUS_ERRHI_FLAG	R	0h	VBUS_ERRHI Flag Type : R POR: 0b 0h = Normal 1h = VBUS_ERRHI status changed
3-0	RESERVED	R	0h	RESERVED

### 8.5.1.30 REG1D\_MASK 1 Register (Offset = 1Dh) [reset = 0h]

REG1D\_MASK 1 is shown in [表 8-38](#).

Return to the [Summary Table](#).

MASK 1

**表 8-38. REG1D\_MASK 1 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BATOVP_MASK	R/W	0h	Reset by: REG_RST	BATOVP Mask Type : R/W POR: 0b 0h = BATOVP flag produce $\overline{\text{INT}}$ 1h = BATOVP flag does not produce $\overline{\text{INT}}$
6	BATOVP_ALM_MASK	R/W	0h	Reset by: REG_RST	BATOVP_ALM Mask Type : R/W POR: 0b 0h = BATOVP_ALM flag produce $\overline{\text{INT}}$ 1h = BATOVP_ALM flag does not produce $\overline{\text{INT}}$
5	VOUTOVP_MASK	R/W	0h	Reset by: REG_RST	VOUTOVP Mask Type : R/W POR: 0b 0h = VOUTOVP flag produce $\overline{\text{INT}}$ 1h = VOUTOVP flag does not produce $\overline{\text{INT}}$
4	BATOC_P_MASK	R/W	0h	Reset by: REG_RST	BATOC_P Mask Type : R/W POR: 0b 0h = BATOC_P flag produce $\overline{\text{INT}}$ 1h = BATOC_P flag does not produce $\overline{\text{INT}}$
3	BATOC_P_ALM_MASK	R/W	0h	Reset by: REG_RST	BATOC_P_ALM Mask Type : R/W POR: 0b 0h = BATOC_P_ALM flag produce $\overline{\text{INT}}$ 1h = BATOC_P_ALM flag does not produce $\overline{\text{INT}}$
2	BATUC_P_ALM_MASK	R/W	0h	Reset by: REG_RST	BATUC_P_ALM Mask Type : R/W POR: 0b 0h = BATUC_P_ALM flag produce $\overline{\text{INT}}$ 1h = BATUC_P_ALM flag does not produce $\overline{\text{INT}}$
1	BUSOVP_MASK	R/W	0h	Reset by: REG_RST	BUSOVP Mask Type : R/W POR: 0b 0h = BUSOVP flag produce $\overline{\text{INT}}$ 1h = BUSOVP flag does not produce $\overline{\text{INT}}$
0	BUSOVP_ALM_MASK	R/W	0h	Reset by: REG_RST	BUSOVP_ALM Mask Type : R/W POR: 0b 0h = BUSOVP_ALM flag produce $\overline{\text{INT}}$ 1h = BUSOVP_ALM flag does not produce $\overline{\text{INT}}$

### 8.5.1.31 REG1E\_MASK 2 Register (Offset = 1Eh) [reset = 0h]

REG1E\_MASK 2 is shown in [表 8-39](#).

Return to the [Summary Table](#).

MASK 2

**表 8-39. REG1E\_MASK 2 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	BUSOCP_MASK	R/W	0h	Reset by: REG_RST	BUSOCP Mask Type : R/W POR: 0b 0h = BUSOCP flag produce INT 1h = BUSOCP flag does not produce INT
6	BUSOCP_ALM_MASK	R/W	0h	Reset by: REG_RST	BUSOCP_ALM Mask Type : R/W POR: 0b 0h = BUSOCP_ALM flag produce INT 1h = BUSOCP_ALM flag does not produce INT
5	BUSUCP_MASK	R/W	0h	Reset by: REG_RST	BUSUCP Mask Type : R/W POR: 0b 0h = BUSUCP flag produce INT 1h = BUSUCP flag does not produce INT
4	BUSRCP_MASK	R/W	0h	Reset by: REG_RST	BUSRCP Mask Type : R/W POR: 0b 0h = BUSRCP flag produce INT 1h = BUSRCP flag does not produce INT
3	RESERVED	R/W	0h	Reset by: REG_RST	RESERVED
2	CFLY_SHORT_MASK	R/W	0h	Reset by: REG_RST	CFLY_SHORT Mask Type : R/W POR: 0b 0h = CFLY_SHORT flag produce INT 1h = CFLY_SHORT flag does not produce INT
1	RESERVED	R/W	0h	Reset by: REG_RST	RESERVED Type : R/W POR: 0h
0	RESERVED	R	0h		RESERVED

#### 8.5.1.32 REG1F\_MASK 3 Register (Offset = 1Fh) [reset = 0h]

REG1F\_MASK 3 is shown in [表 8-40](#).

Return to the [Summary Table](#).

MASK 3

**表 8-40. REG1F\_MASK 3 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	VAC1OVP_MASK	R/W	0h	Reset by: REG_RST	VAC1OVP Mask Type : R/W POR: 0b 0h = VAC1OVP flag produce INT 1h = VAC1OVP flag does not produce INT
6	VAC2OVP_MASK	R/W	0h	Reset by: REG_RST	VAC2OVP Mask Type : R/W POR: 0b 0h = VAC2OVP flag produce INT 1h = VAC2OVP flag does not produce INT

表 8-40. REG1F\_MASK 3 Register Field Descriptions (続き)

Bit	Field	Type	Reset	Note	Description
5	VOUTPRESENT_MASK	R/W	0h	Reset by: REG_RST	VOUTPRESENT Mask Type : R/W POR: 0b 0h = VOUTPRESENT flag produce INT 1h = VOUTPRESENT flag does not produce INT
4	VAC1PRESENT_MASK	R/W	0h	Reset by: REG_RST	VAC1PRESENT Mask Type : R/W POR: 0b 0h = VAC1PRESENT flag produce INT 1h = VAC1PRESENT flag does not produce INT
3	VAC2PRESENT_MASK	R/W	0h	Reset by: REG_RST	VAC2PRESENT Mask Type : R/W POR: 0b 0h = VAC2PRESENT flag produce INT 1h = VAC2PRESENT flag does not produce INT
2	VBUSPRESENT_MASK	R/W	0h	Reset by: REG_RST	VBUSPRESENT Mask Type : R/W POR: 0b 0h = VBUSPRESENT flag produce INT 1h = VBUSPRESENT flag does not produce INT
1	ACRB1_CONFIG_MASK	R/W	0h	Reset by: REG_RST	ACFET1-RBFET1 CONFIG Mask Type : R/W POR: 0b 0h = ACRB1_CONFIG flag produce INT 1h = ACRB1_CONFIG flag does not produce INT
0	ACRB2_CONFIG_MASK	R/W	0h	Reset by: REG_RST	ACFET2-RBFET2 CONFIG Mask Type : R/W POR: 0b 0h = ACRB2_CONFIG flag produce INT 1h = ACRB2_CONFIG flag does not produce INT

## 8.5.1.33 REG20\_MASK 4 Register (Offset = 20h) [reset = 0h]

REG20\_MASK 4 is shown in 表 8-41.

Return to the [Summary Table](#).

MASK 4

表 8-41. REG20\_MASK 4 Register Field Descriptions

Bit	Field	Type	Reset	Note	Description
7	ADC_DONE_MASK	R/W	0h	Reset by: REG_RST	ADC_DONE Mask Type : R/W POR: 0b 0h = ADC_DONE flag produce INT 1h = ADC_DONE flag does not produce INT
6	SS_TIMEOUT_MASK	R/W	0h	Reset by: REG_RST	SS_TIMEOUT Mask Type : R/W POR: 0b 0h = SS_TIMEOUT flag produce INT 1h = SS_TIMEOUT flag does not produce INT



**表 8-41. REG20\_MASK 4 Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Note	Description
5	TSBUS_TSBAT_ALM_MASK	R/W	0h	Reset by: REG_RST	TSBUS_TSBAT_ALM Mask Type : R/W POR: 0b 0h = TSBUS_TSBAT_ALM flag produce $\overline{\text{INT}}$ 1h = TSBUS_TSBAT_ALM flag does not produce $\overline{\text{INT}}$
4	TSBUS_FLT_MASK	R/W	0h	Reset by: REG_RST	TSBUS_FLT Mask Type : R/W POR: 0b 0h = TSBUS_FLT flag produce $\overline{\text{INT}}$ 1h = TSBUS_FLT flag does not produce $\overline{\text{INT}}$
3	TSBAT_FLT_MASK	R/W	0h	Reset by: REG_RST	TSBAT_FLT Mask Type : R/W POR: 0b 0h = TSBAT_FLT flag produce $\overline{\text{INT}}$ 1h = TSBAT_FLT flag does not produce $\overline{\text{INT}}$
2	TDIE_FLT_MASK	R/W	0h	Reset by: REG_RST	TDIE_FLT Mask Type : R/W POR: 0b 0h = TDIE_FLT flag produce $\overline{\text{INT}}$ 1h = TDIE_FLT flag does not produce $\overline{\text{INT}}$
1	TDIE_ALM_MASK	R/W	0h	Reset by: REG_RST	TDIE_ALM Mask Type : R/W POR: 0b 0h = TDIE_ALM flag produce $\overline{\text{INT}}$ 1h = TDIE_ALM flag does not produce $\overline{\text{INT}}$
0	WD_MASK	R/W	0h	Reset by: REG_RST	Watchdog Mask Type : R/W POR: 0b 0h = WD flag produce $\overline{\text{INT}}$ 1h = WD flag does not produce $\overline{\text{INT}}$

#### 8.5.1.34 REG21\_MASK 5 Register (Offset = 21h) [reset = 0h]

REG21\_MASK 5 is shown in [表 8-42](#).

Return to the [Summary Table](#).

MASK 5

**表 8-42. REG21\_MASK 5 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	REGN_GOOD_MASK	R/W	0h	Reset by: REG_RST	REGN_GOOD Mask Type : R/W POR: 0b 0h = REGN_GOOD flag produce $\overline{\text{INT}}$ 1h = REGN_GOOD flag does not produce $\overline{\text{INT}}$
6	CONV_ACTIVE_MASK	R/W	0h	Reset by: REG_RST	CONV_ACTIVE Mask Type : R/W POR: 0b 0h = CONV_ACTIVE flag produce $\overline{\text{INT}}$ 1h = CONV_ACTIVE flag does not produce $\overline{\text{INT}}$
5	RESERVED	R/W	0h	Reset by: REG_RST	RESERVED Type : R/W POR: 0h

表 8-42. REG21\_MASK 5 Register Field Descriptions (続き)

Bit	Field	Type	Reset	Note	Description
4	VBUS_ERRHI_MASK	R/W	0h	Reset by: REG_RST	VBUS_ERRHI Mask Type : R/W POR: 0b 0h = VBUS_ERRHI flag produce INT 1h = VBUS_ERRHI flag does not produce INT
3-0	RESERVED	R	0h		RESERVED

## 8.5.1.35 REG22\_DEVICE\_INFO Register (Offset = 22h) [reset = 0h]

REG22\_DEVICE\_INFO is shown in 表 8-43.

Return to the [Summary Table](#).

DEVICE INFO

表 8-43. REG22\_DEVICE\_INFO Register Field Descriptions

Bit	Field	Type	Reset	Description
7-4	DEVICE_REV_3:0	R	0h	Device Revision Type : R POR: 0h
3-0	DEVICE_ID_3:0	R	0h	Device ID Type : R POR: 0h

## 8.5.1.36 REG23\_ADC\_CONTROL 1 Register (Offset = 23h) [reset = 0h]

REG23\_ADC\_CONTROL 1 is shown in 表 8-44.

Return to the [Summary Table](#).

ADC\_CONTROL 1

表 8-44. REG23\_ADC\_CONTROL 1 Register Field Descriptions

Bit	Field	Type	Reset	Note	Description
7	ADC_EN	R/W	0h	Reset by: WATCHDOG REG_RST	ADC Enable Type : R/W POR: 0b 0h = Disable 1h = Enable
6	ADC_RATE	R/W	0h	Reset by: REG_RST	ADC Rate Type : R/W POR: 0b 0h = Continuous conversion 1h = 1 shot
5	ADC_AVG	R/W	0h	Reset by: REG_RST	ADC Average Type : R/W POR: 0b 0h = Single value 1h = Running average
4	ADC_AVG_INIT	R/W	0h	Reset by: REG_RST	ADC Average Initial Value Type : R/W POR: 0b 0h = Start average using the existing register value 1h = Start average using a new conversion

**表 8-44. REG23\_ADC\_CONTROL 1 Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Note	Description
3-2	ADC_SAMPLE_1:0	R/W	0h	Reset by: REG_RST	ADC Sample Speed Type : R/W POR: 00b 0h = 15 bit 1h = 14 bit 2h = 13 bit 3h = 11 bit
1	IBUS_ADC_DIS	R/W	0h	Reset by: REG_RST	IBUS ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable
0	VBUS_ADC_DIS	R/W	0h	Reset by: REG_RST	VBUS ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable

#### 8.5.1.37 REG24\_ADC\_CONTROL 2 Register (Offset = 24h) [reset = 0h]

REG24\_ADC\_CONTROL 2 is shown in [表 8-45](#).

Return to the [Summary Table](#).

ADC\_CONTROL 2

**表 8-45. REG24\_ADC\_CONTROL 2 Register Field Descriptions**

Bit	Field	Type	Reset	Note	Description
7	VAC1_ADC_DIS	R/W	0h	Reset by: REG_RST	VAC1 ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable
6	VAC2_ADC_DIS	R/W	0h	Reset by: REG_RST	VAC2 ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable
5	VOUT_ADC_DIS	R/W	0h	Reset by: REG_RST	VOUT ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable
4	VBAT_ADC_DIS	R/W	0h	Reset by: REG_RST	VBAT ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable
3	IBAT_ADC_DIS	R/W	0h	Reset by: REG_RST	IBAT ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable

**表 8-45. REG24\_ADC\_CONTROL 2 Register Field Descriptions (続き)**

Bit	Field	Type	Reset	Note	Description
2	TSBUS_ADC_DIS	R/W	0h	Reset by: REG_RST	TSBUS ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable
1	TSBAT_ADC_DIS	R/W	0h	Reset by: REG_RST	TSBAT ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable
0	TDIE_ADC_DIS	R/W	0h	Reset by: REG_RST	TDIE ADC Control Type : R/W POR: 0b 0h = Enable 1h = Disable

**8.5.1.38 REG25\_IBUS\_ADC Register (Offset = 25h) [reset = 0h]**

REG25\_IBUS\_ADC is shown in [表 8-46](#).

Return to the [Summary Table](#).

IBUS\_ADC

**表 8-46. REG25\_IBUS\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	IBUS_ADC_15:0	R	0h	IBUS ADC Reading Type : R POR: 0 mA (0h) Range : 0 mA - 7000 mA Switched Cap Mode: Fixed Offset : 66 mA Bit Step Size : 0.9972 mA Bypass Mode: Fixed Offset : 64 mA Bit Step Size : 1.0279 mA

**8.5.1.39 REG27\_VBUS\_ADC Register (Offset = 27h) [reset = 0h]**

REG27\_VBUS\_ADC is shown in [表 8-47](#).

Return to the [Summary Table](#).

VBUS\_ADC

**表 8-47. REG27\_VBUS\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	VBUS_ADC_15:0	R	0h	VBUS ADC Reading Type : R POR: 0 mV (0h) Range : 0 mV - 16385 mV Fixed Offset : 0 mV Bit Step Size : 1.002 mV

#### 8.5.1.40 REG29\_VAC1\_ADC Register (Offset = 29h) [reset = 0h]

REG29\_VAC1\_ADC is shown in 表 8-48.

Return to the [Summary Table](#).

VAC1\_ADC

**表 8-48. REG29\_VAC1\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	VAC1_ADC_15:0	R	0h	VAC1 ADC Reading Type : R POR: 0 mV (0h) Range : 0 mV - 14000 mV Fixed Offset : 3 mV Bit Step Size : 1.0008 mV

#### 8.5.1.41 REG2B\_VAC2\_ADC Register (Offset = 2Bh) [reset = 0h]

REG2B\_VAC2\_ADC is shown in 表 8-49.

Return to the [Summary Table](#).

VAC2\_ADC

**表 8-49. REG2B\_VAC2\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	VAC2_ADC_15:0	R	0h	VAC2 ADC Reading Type : R POR: 0 mV (0h) Range : 0 mV - 14000 mV Fixed Offset : 5 mV Bit Step Size : 1.0006 mV

#### 8.5.1.42 REG2D\_VOUT\_ADC Register (Offset = 2Dh) [reset = 0h]

REG2D\_VOUT\_ADC is shown in 表 8-50.

Return to the [Summary Table](#).

VOUT\_ADC

**表 8-50. REG2D\_VOUT\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	VOUT_ADC_15:0	R	0h	VOUT ADC Reading Type : R POR: 0 mV (0h) Range : 0 mV - 6000 mV Fixed Offset : 2 mV Bit Step Size : 1.0037 mV

#### 8.5.1.43 REG2F\_VBAT\_ADC Register (Offset = 2Fh) [reset = 0h]

REG2F\_VBAT\_ADC is shown in 表 8-51.

Return to the [Summary Table](#).

VBAT\_ADC

**表 8-51. REG2F\_VBAT\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	VBAT_ADC_15:0	R	0h	VBAT ADC Reading Type : R POR: 0 mV (0h) Range : 0 mV - 6000 mV Fixed Offset : 1 mV Bit Step Size : 1.017 mV

**8.5.1.44 REG31\_IBAT\_ADC Register (Offset = 31h) [reset = 0h]**

REG31\_IBAT\_ADC is shown in [表 8-52](#).

Return to the [Summary Table](#).

IBAT\_ADC

**表 8-52. REG31\_IBAT\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	IBAT_ADC_15:0	R	0h	IBAT ADC Reading Type : R POR: 0 mA (0h) Range : 0 mA - 12000 mA Fixed Offset : -150 mA Bit Step Size : 0.999 mA

**8.5.1.45 REG33\_TSBUS\_ADC Register (Offset = 33h) [reset = 0h]**

REG33\_TSBUS\_ADC is shown in [表 8-53](#).

Return to the [Summary Table](#).

TSBUS\_ADC

**表 8-53. REG33\_TSBUS\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	TSBUS_ADC_15:0	R	0h	TSBUS ADC Reading Type : R POR: 0% (0h) Range : 0% - 50% Fixed Offset : 0.1% Bit Step Size : 0.09860%

**8.5.1.46 REG35\_TSBAT\_ADC Register (Offset = 35h) [reset = 0h]**

REG35\_TSBAT\_ADC is shown in [表 8-54](#).

Return to the [Summary Table](#).

TSBAT\_ADC

**表 8-54. REG35\_TSBAT\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	TSBAT_ADC_15:0	R	0h	TSBAT ADC Reading Type : R POR: 0% (0h) Range : 0% - 50% Fixed Offset : 0.065% Bit Step Size : 0.09762%

### 8.5.1.47 REG37\_TDIE\_ADC Register (Offset = 37h) [reset = 0h]

REG37\_TDIE\_ADC is shown in 表 8-55.

Return to the [Summary Table](#).

TDIE\_ADC

**表 8-55. REG37\_TDIE\_ADC Register Field Descriptions**

Bit	Field	Type	Reset	Description
15-0	TDIE_ADC_15:0	R	0h	TDIE ADC Reading Type : R POR: 0°C (0h) Range : -40°C - 150°C Fixed Offset : -3.5°C Bit Step Size : 0.5079°C

## 9 Application and Implementation

---

### 注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

---

### 9.1 Application Information

A typical application consists of the device configured as an I<sup>2</sup>C controlled parallel charger along with a standard switching charger, however, it can also be used with a linear charger or PMIC with integrated charger as well. BQ25960H can start fast charging after the main charger completes pre-charging. BQ25960H will then hand back charging to the main charger when final current tapering is desired. This point is usually where the efficiency of the main charger is acceptable for the application. The device can be used to charge Li-Ion and Li-polymer batteries used in a wide range of smartphones and other portable devices. To take advantage of the high charge current capabilities of the BQ25960H, it may be necessary to charge in excess of 1C. In this case, be sure to follow the battery manufacturers recommendations closely.

### 9.2 Typical Application

A typical schematic is shown below with all the optional and required components shown.



## 9.2.1 Standalone Application Information (for use with main charger)

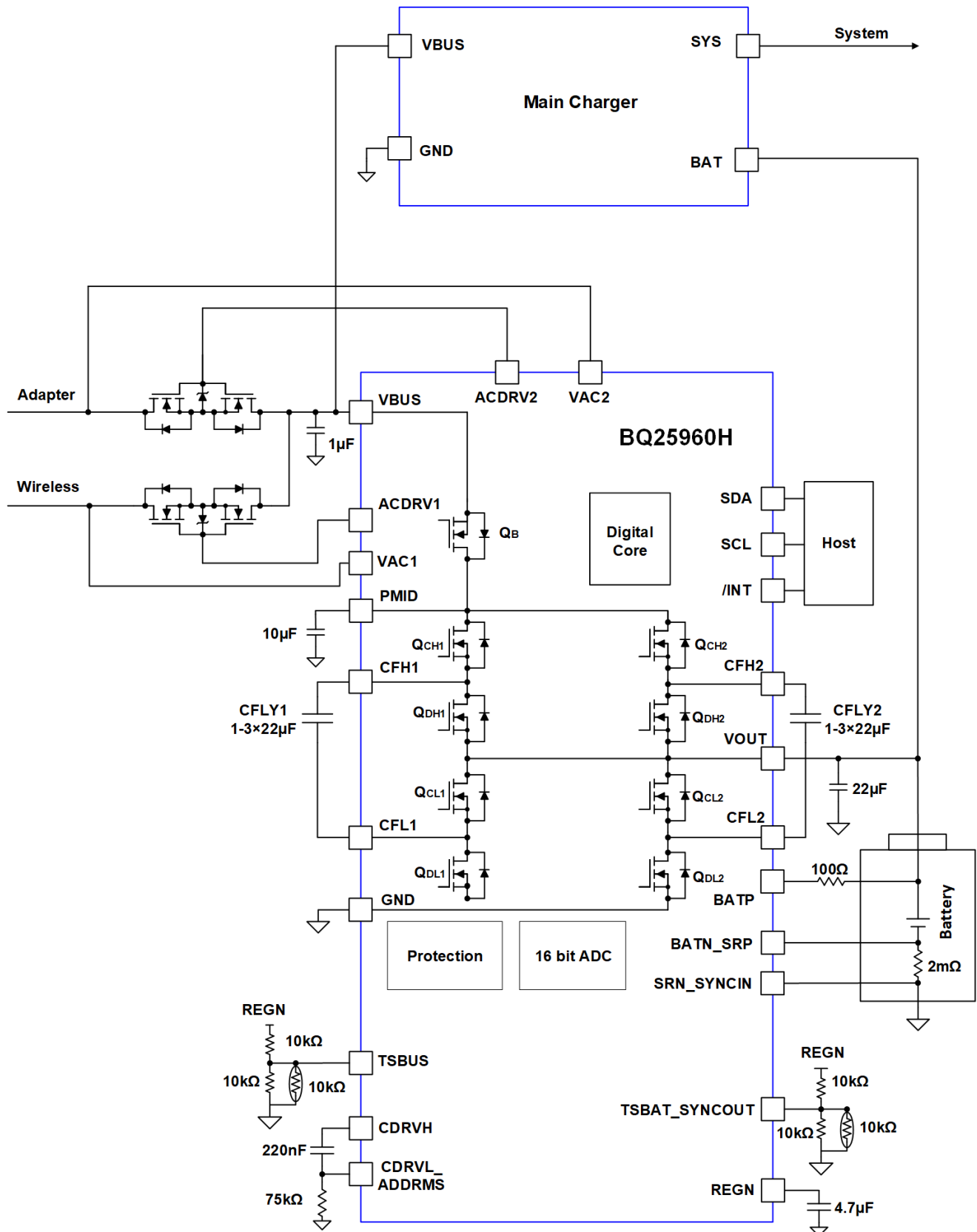
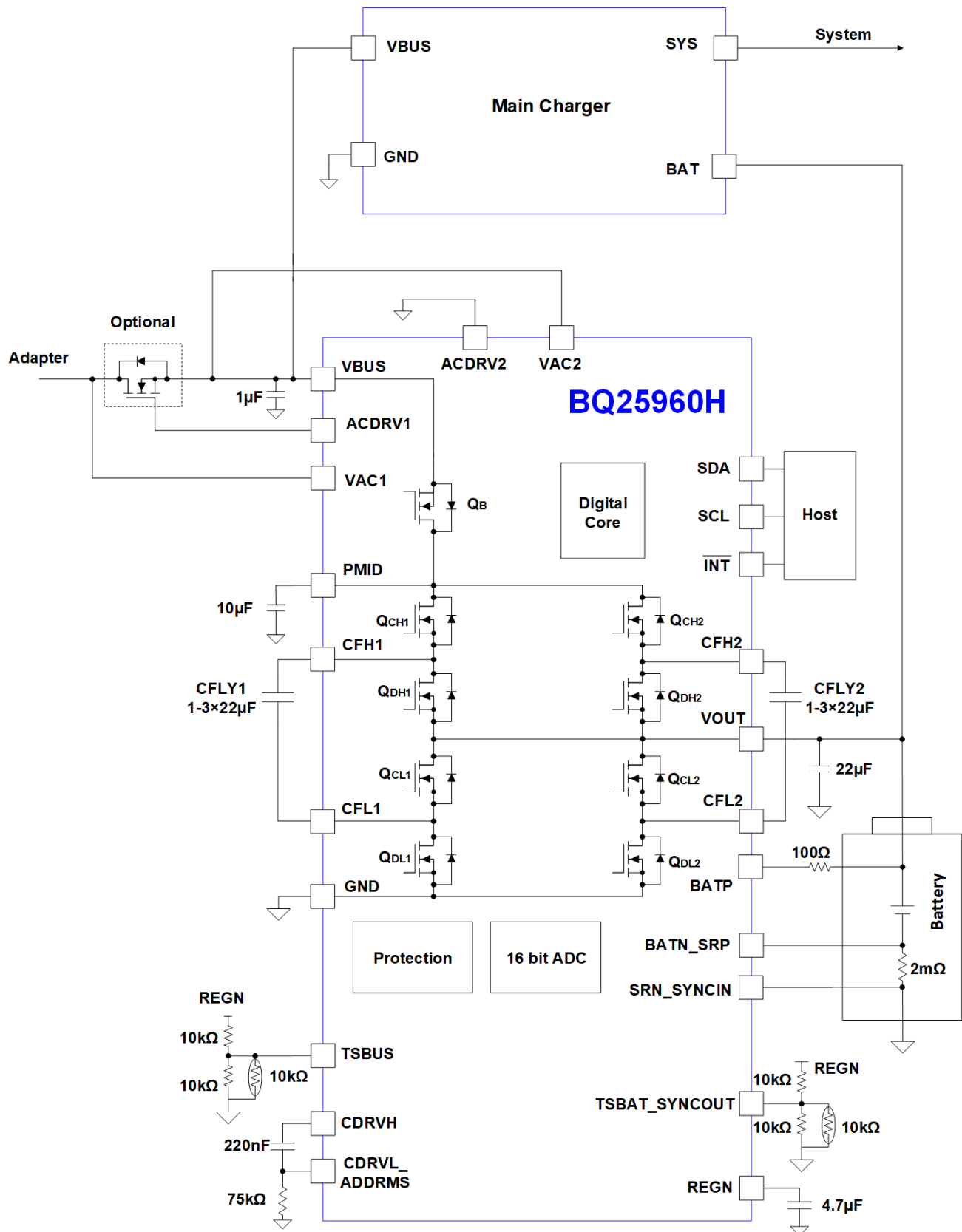


Figure 9-4. BQ25960H Typical Application Diagram with Dual Input



### 9-2. BQ25960H Typical Application Diagram with Single Input

### 9.2.1.1 Design Requirements

The design requires a smart wall adapter to provide the proper input voltage and input current to the BQ25960H, following the USB\_PD Programmable Power Supply (PPS) voltage steps and current steps. The design shown is capable of charging up to 8 A, although this may not be practical for some applications due to the total power loss at this operating point. Careful consideration of the thermal constraints, space constraints, and operating conditions should be done to ensure acceptable performance.

### 9.2.1.2 Detailed Design Procedure

The first step is to determine the number of CFLY caps to put on each phase of the design. It is important to consider the current rating of the caps, their ESR, and the capacitance rating. Be sure to consider the bias voltage derating for the caps, as the CFLY caps are biased to half of the input voltage, and this will affect their effective capacitance. An optimal system will have 3 22- $\mu$ F caps per phase, for a total of 6 caps per device. It is possible to use fewer caps if the board space is limited. Using fewer caps will result in higher voltage and current ripple on the output, as well as lower efficiency.

The default switching frequency,  $f_{SW}$ , for the power stage is 500 kHz. The switching frequency can be adjusted in register 0x10h using the FSW\_SET bits. It is recommended to select 500 kHz if IBATADC is not used and 375 kHz if IBATADC is used.

It is recommended to use 1- $\mu$ F cap on VBUS, 10- $\mu$ F cap on PMID and 22- $\mu$ F cap on VOUT.

### 9.2.1.3 Application Curves

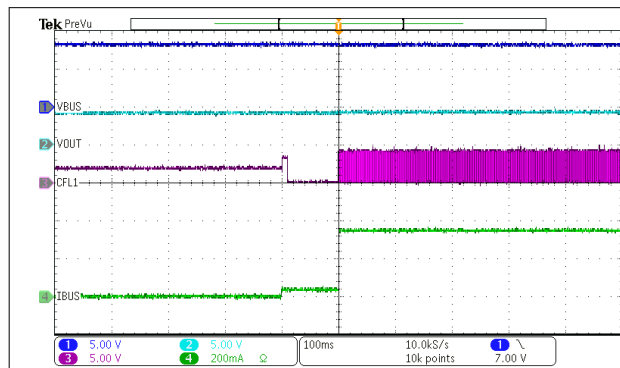


図 9-3. Switched Cap Mode Power Up

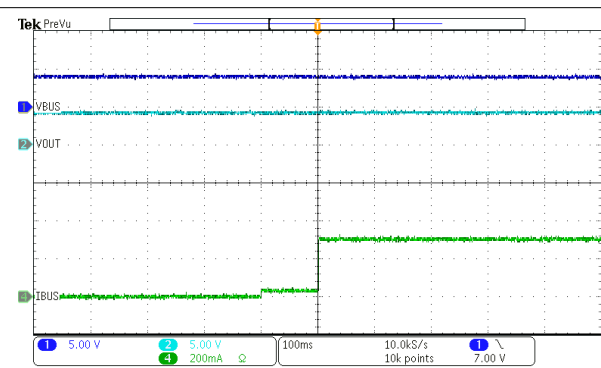


図 9-4. Bypass Mode Power Up

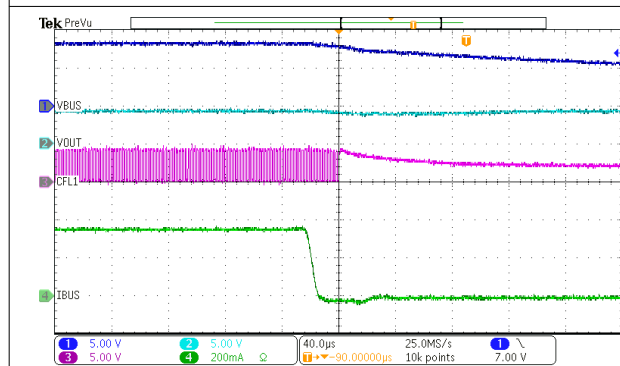


図 9-5. Adapter Unplug in Switched Cap Mode

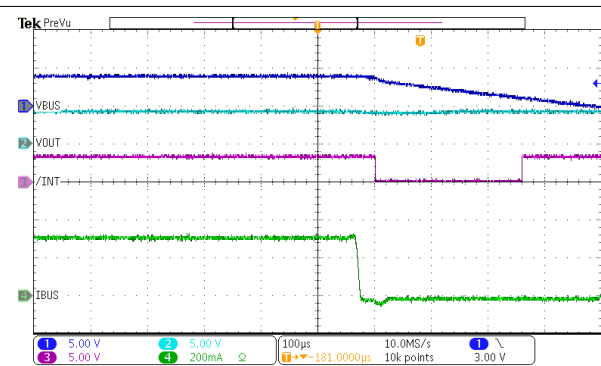


図 9-6. Adapter Unplug in Bypass Mode

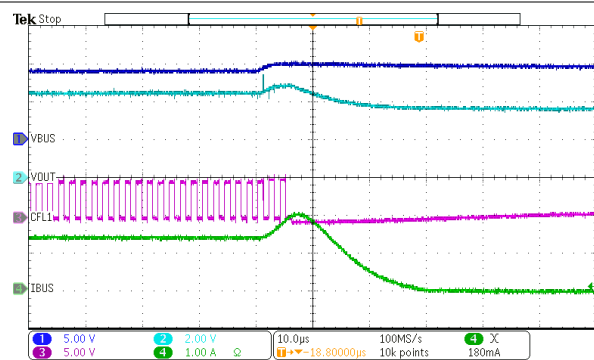


図 9-7. VBUSOVP in Switched Cap Mode

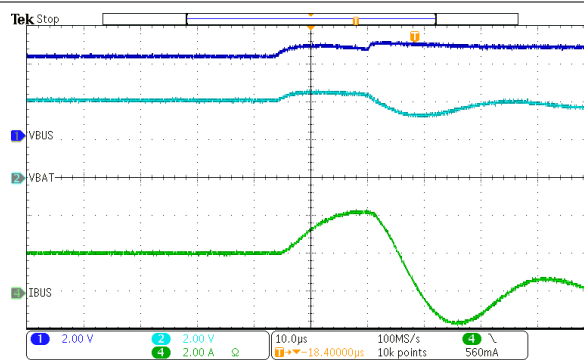


図 9-8. VBUSOVP in Bypass Mode

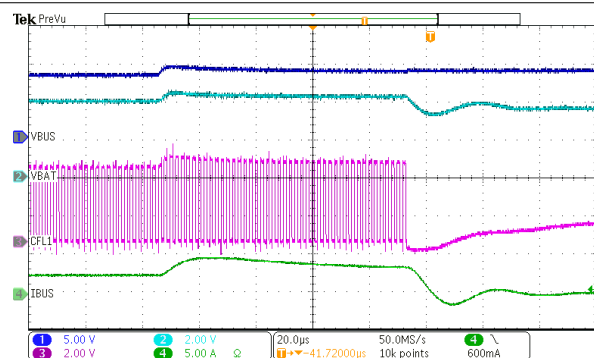


図 9-9. IBUSOCP in Switched Cap Mode

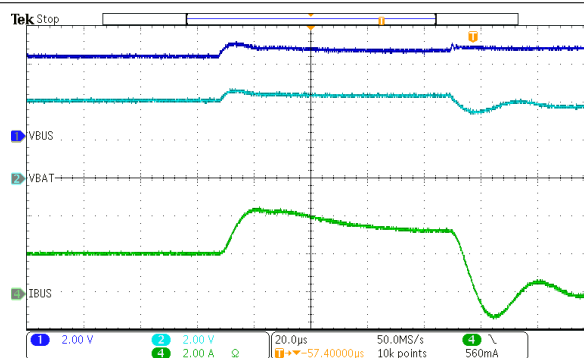


図 9-10. IBUSOCP in Bypass Mode

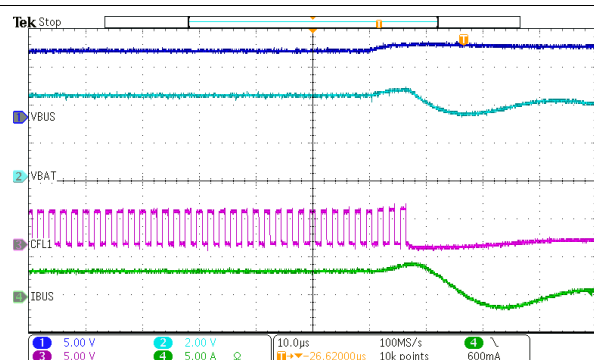


図 9-11. VBATOVP in Switched Cap Mode

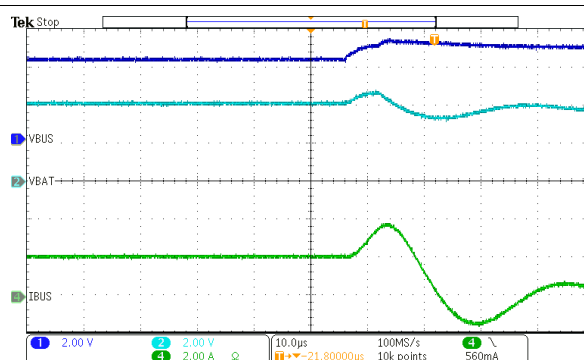


図 9-12. VBATOVP in Bypass Mode

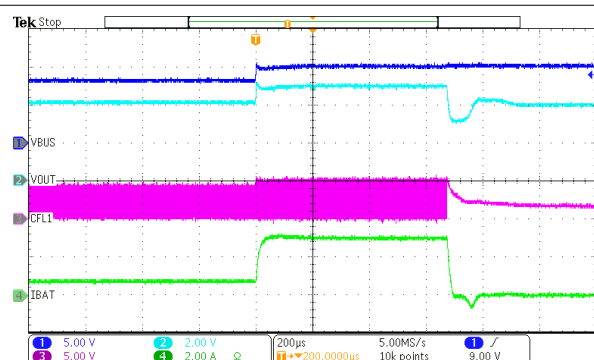


図 9-13. IBATOCP in Switched Cap Mode

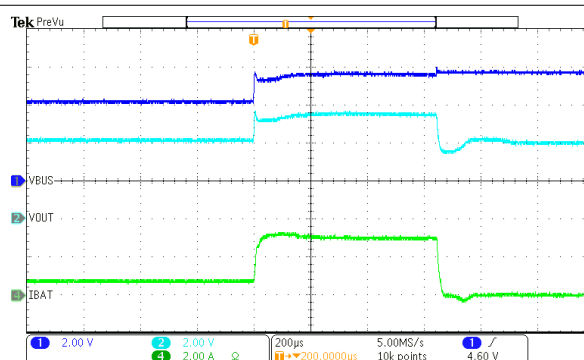
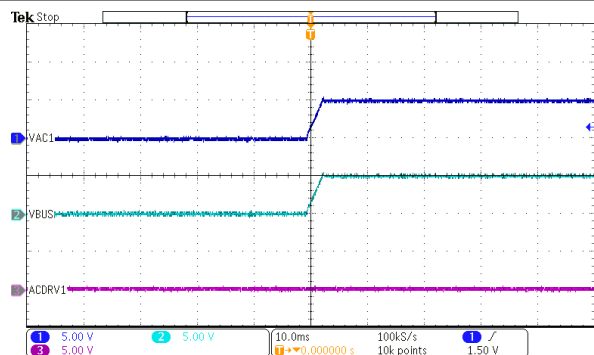
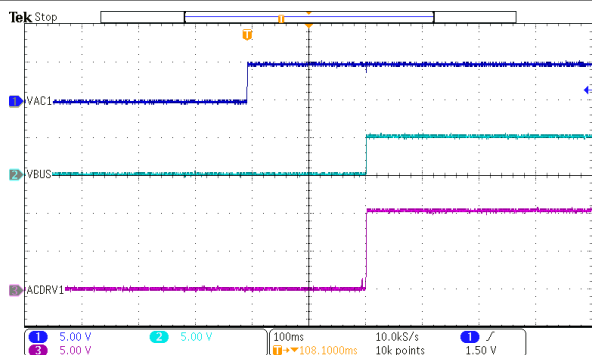


図 9-14. IBATOCP in Bypass Mode



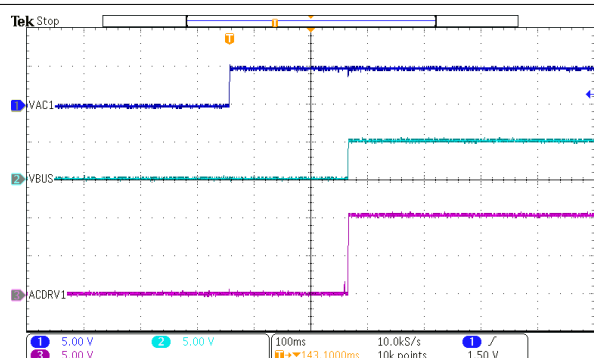
VAC1 and VAC2 short to VBUS, ACDRV1 and ACDRV2 short to ground

**図 9-15. Power Up without AC-RFFET**



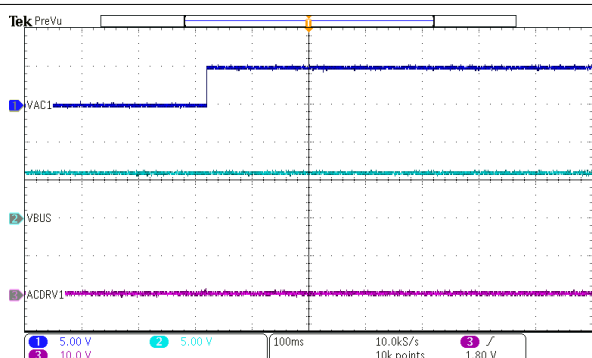
VAC1 connected to input source, VAC2 short to VBUS, ACDRV1 active, ACDRV2 short to ground

**図 9-16. Power Up from VAC1 with Single ACFET1**



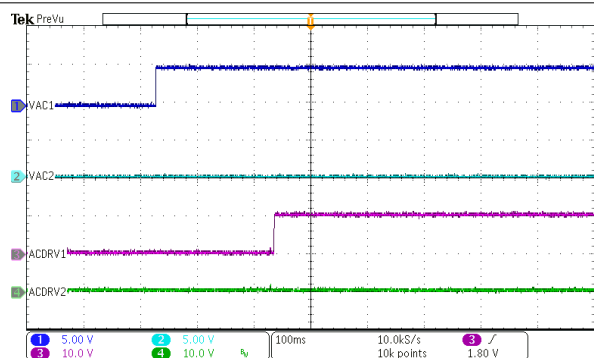
VAC1 connected to input source 1, VBUS connected to input source 2, VAC2 short to VBUS, ACDRV1 active, ACDRV2 short to ground

**図 9-17. Power Up from VAC1 with ACFET1-RBFET1**



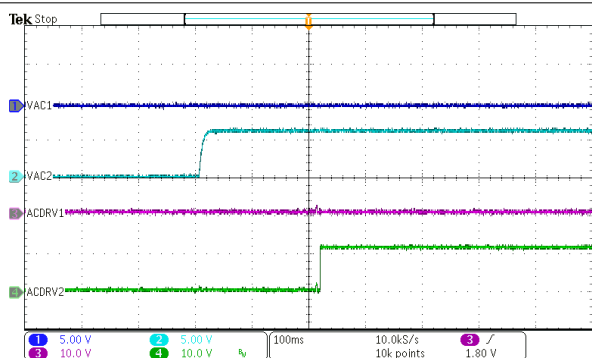
VAC1 connected to input source 1, VBUS connected to input source 2, VAC2 short to VBUS, ACDRV1 active, ACDRV2 short to ground

**図 9-18. Plugin VAC1 When Device is Power Up From VBUS with ACFET1-RBFET1**



VAC1 connected to input source 1, VAC2 connected to input source 2, ACDRV1 and ACDRV2 active

**図 9-19. Power Up from VAC1 with ACFET1-RBFET1 and ACFET2-RBFET2**



VAC1 connected to input source 1, VAC2 connected to input source 2, ACDRV1 and ACDRV2 active

**図 9-20. Power Up from VAC2 with ACFET1-RBFET1 and ACFET2-RBFET2**

## 10 Power Supply Recommendations

The BQ25960H can be powered by a standard power supply capable of meeting the input voltage and current requirements for evaluation. In the actual application, it must be used with a wall adapter that supports USB Power Delivery (PD) Programmable Power Supply (PPS) specifications.

## 11 Layout

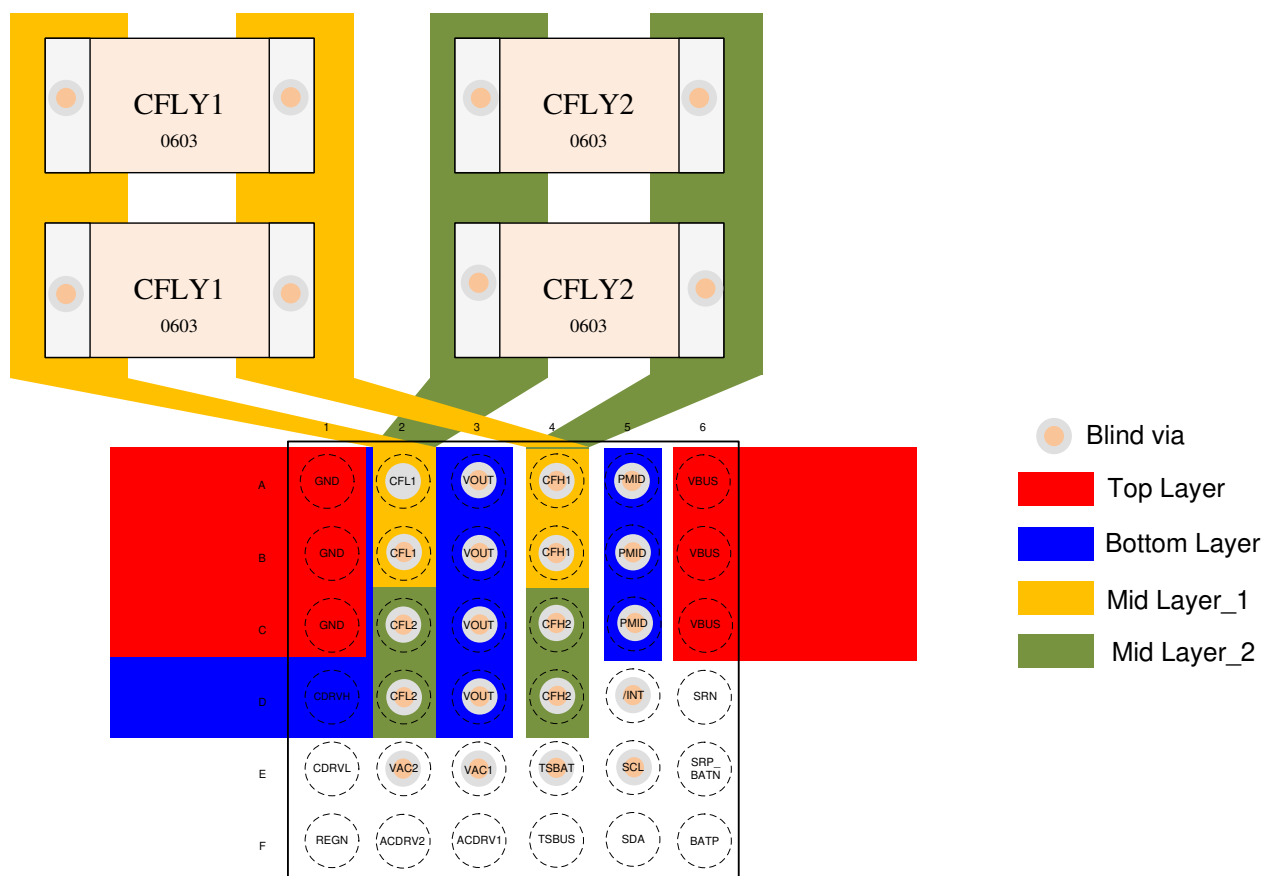
### 11.1 Layout Guidelines

Layout is very important to maximize the electrical and thermal performance of the total system. General guidelines are provided, but the form factor, board stack-up, and proximity of other components also need to be considered to maximize the performance.

1. VBUS and VOUT traces should be as short and wide as possible to accommodate for high current.
2. Copper trace of VBUS and VOUT should run at least 150 mil (3.81 mm) straight (perpendicular to WCSP ball array) before making turns.
3. CFLY caps should be placed as close as possible to the device and CFLY trace should be as wide as possible until close to the IC.
4. CLFY pours should be as symmetrical between CFH pads and CFL pads as possible.
5. Place low ESR bypass capacitors to ground for VBUS, PMID, and VOUT. The capacitor should be placed as close to the device pins as possible.
6. The CFLY pads should be as small as possible, and the CFLY caps placed as close as possible to the device, as these are switching pins and this will help reduce EMI.
7. Do not route so the power planes are interrupted by signal traces.

Refer to the EVM design and more information in the [BQ25960EVM \(BMS041\) Evaluation Module User's Guide](#) for the recommended component placement with trace and via locations.

### 11.2 Layout Example



11-1. BQ25960H Layout Example

## 12 Device and Documentation Support

### 12.1 Device Support

#### 12.1.1 サード・パーティ製品に関する免責事項

サード・パーティ製品またはサービスに関するテキサス・インスツルメンツの出版物は、単独またはテキサス・インスツルメンツの製品、サービスと一緒に提供される場合に関係なく、サード・パーティ製品またはサービスの適合性に関する是認、サード・パーティ製品またはサービスの是認の表明を意味するものではありません。

### 12.2 Documentation Support

#### 12.2.1 Related Documentation

For related documentation see the following:

- [BQ25960EVM \(BMS041\) Evaluation Module User's Guide](#)

### 12.3 ドキュメントの更新通知を受け取る方法

ドキュメントの更新についての通知を受け取るには、[www.tij.co.jp](http://www.tij.co.jp) のデバイス製品フォルダを開いてください。[通知] をクリックして登録すると、変更されたすべての製品情報に関するダイジェストを毎週受け取ることができます。変更の詳細については、改訂されたドキュメントに含まれている改訂履歴をご覧ください。

### 12.4 サポート・リソース

テキサス・インスツルメンツ **E2E™ サポート・フォーラム** は、エンジニアが検証済みの回答と設計に関するヒントをエキスパートから迅速かつ直接得ることができる場所です。既存の回答を検索したり、独自の質問をしたりすることで、設計に必要な支援を迅速に得ることができます。

リンクされているコンテンツは、各寄稿者により「現状のまま」提供されるものです。これらはテキサス・インスツルメンツの仕様を構成するものではなく、必ずしもテキサス・インスツルメンツの見解を反映したものではありません。テキサス・インスツルメンツの[使用条件](#)を参照してください。

### 12.5 Trademarks

テキサス・インスツルメンツ E2E™ is a trademark of Texas Instruments.

すべての商標は、それぞれの所有者に帰属します。

### 12.6 静電気放電に関する注意事項



この IC は、ESD によって破損する可能性があります。テキサス・インスツルメンツは、IC を取り扱う際には常に適切な注意を払うことを推奨します。正しい取り扱いおよび設置手順に従わない場合、デバイスを破損するおそれがあります。

ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

### 12.7 用語集

[テキサス・インスツルメンツ用語集](#) この用語集には、用語や略語の一覧および定義が記載されています。

## 13 Revision History

資料番号末尾の英字は改訂を表しています。その改訂履歴は英語版に準じています。

DATE	REVISION	NOTES
December 2023	*	Initial release.



## 14 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

## 14.1 Package Option Addendum

### Packaging Information

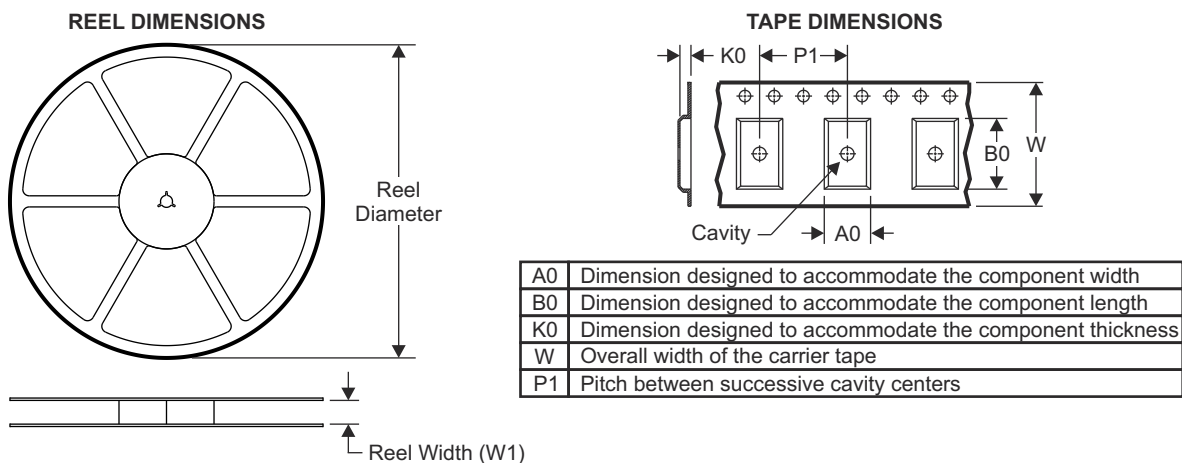
Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	Eco Plan <sup>(2)</sup>	Lead/Ball Finish <sup>(6)</sup>	MSL Peak Temp <sup>(3)</sup>	Op Temp (°C)	Device Marking <sup>(4)</sup> (5)
BQ25960HYBGR	ACTIVE	DSBGA	YBG	36	6000	RoHS & Green	SNAGCU	Level-1-260 C-UNLIM	–40 to 85	BQ25960H

- (1) The marketing status values are defined as follows:  
**ACTIVE:** Product device recommended for new designs.  
**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.  
**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.  
**PRE\_PROD** Unannounced device, not in production, not available for mass market, nor on the web, samples not available.  
**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.  
**OBSOLETE:** TI has discontinued the production of the device.
- (2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check [www.ti.com/productcontent](http://www.ti.com/productcontent) for the latest availability information and additional product content details.  
**TBD:** The Pb-Free/Green conversion plan has not been defined.  
**Pb-Free (RoHS):** TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.  
**Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.  
**Green (RoHS & no Sb/Br):** TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material).
- (3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

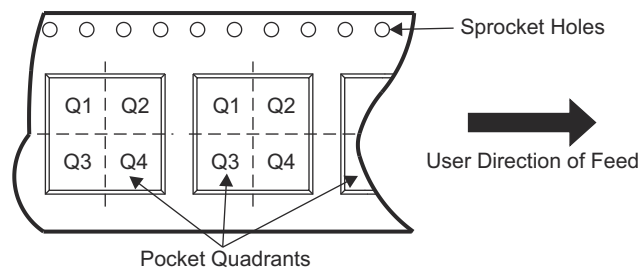
**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

## 14.2 Tape and Reel Information

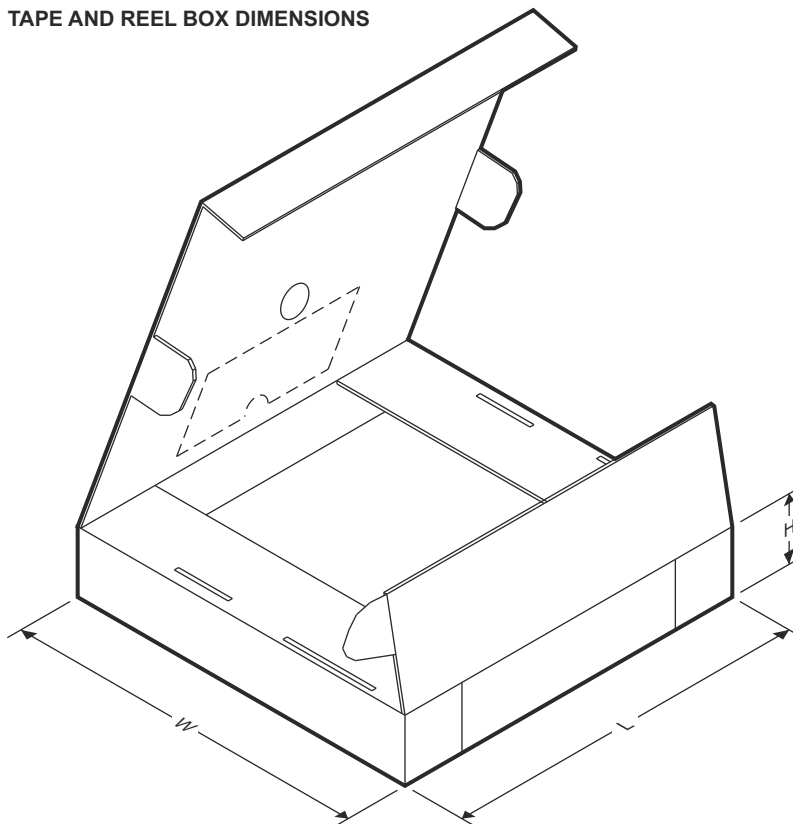


### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
BQ25960HYBGR	DSBGA	YBG	36	6000	330.0	12.4	2.73	2.73	0.68	4.0	12.0	Q1

## TAPE AND REEL BOX DIMENSIONS



Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
BQ25960HYBGR	DSBGA	YBG	36	6000	360.0	360.0	36.0
BQ25960HYBGR	DSBGA	YBG	36	6000	367.0	367.0	35.0

## PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package   Pins	Package qty   Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
<a href="#">BQ25960HYBGR</a>	Active	Production	DSBGA (YBG)   36	6000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25960H
BQ25960HYBGR.A	Active	Production	DSBGA (YBG)   36	6000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25960H
BQ25960HYBGR.B	Active	Production	DSBGA (YBG)   36	6000   LARGE T&R	Yes	SNAGCU	Level-1-260C-UNLIM	-40 to 85	BQ25960H

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

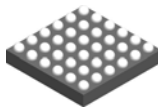
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

**Important Information and Disclaimer:** The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

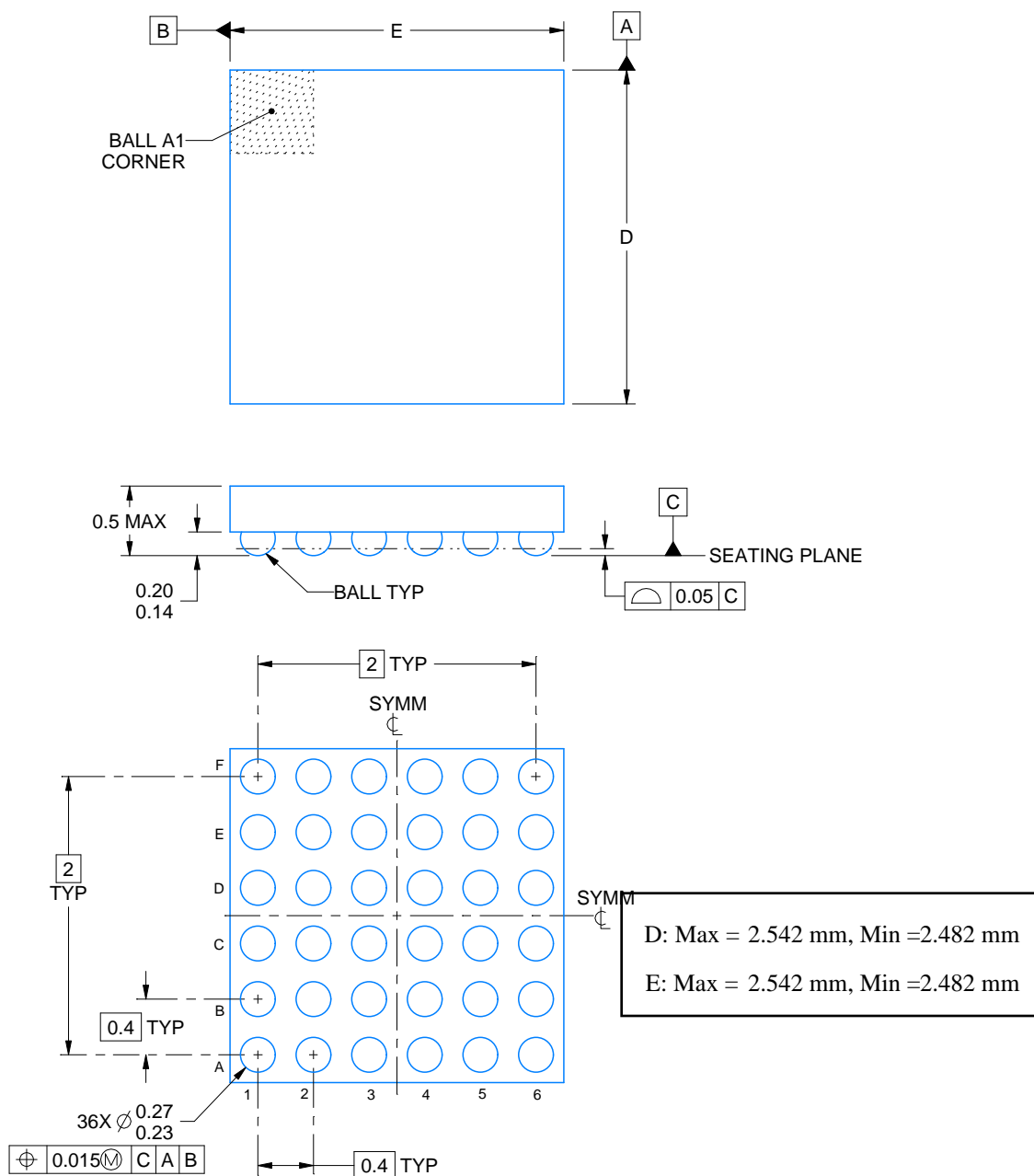
YBG0036



## PACKAGE OUTLINE

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



4224846/A 03/2019

### NOTES:

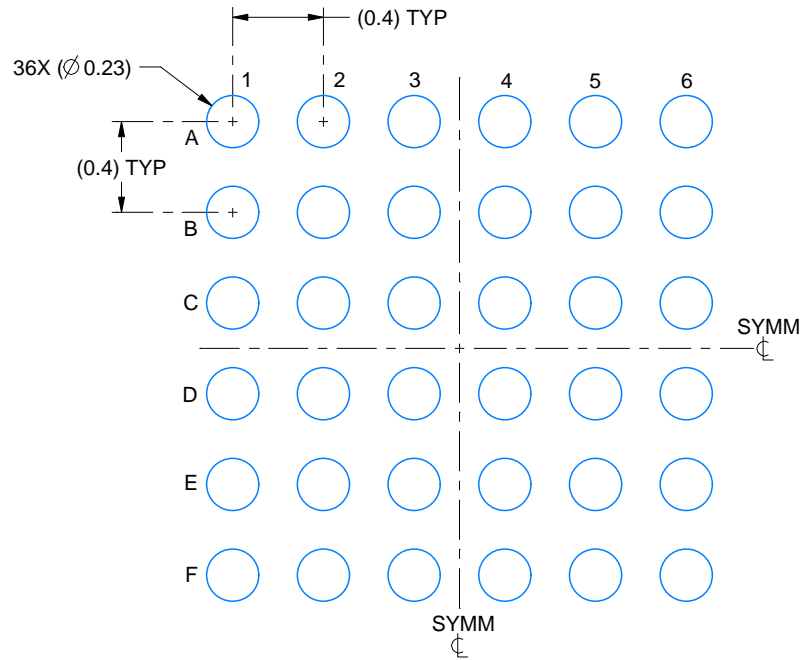
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.

# EXAMPLE BOARD LAYOUT

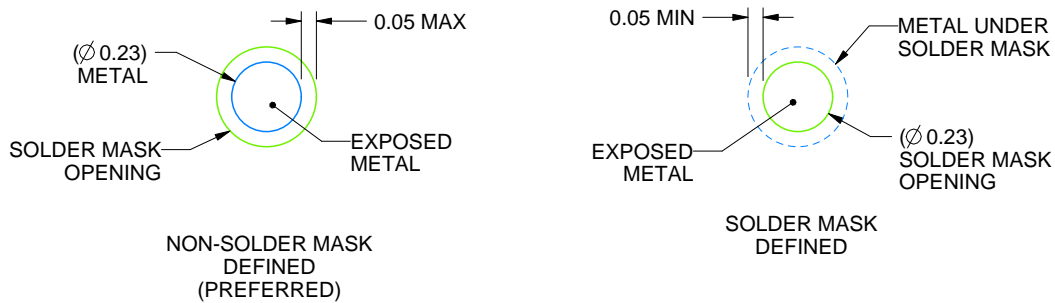
YBG0036

DSBGA - 0.5 mm max height

DIE SIZE BALL GRID ARRAY



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 30X



SOLDER MASK DETAILS  
NOT TO SCALE

4224846/A 03/2019

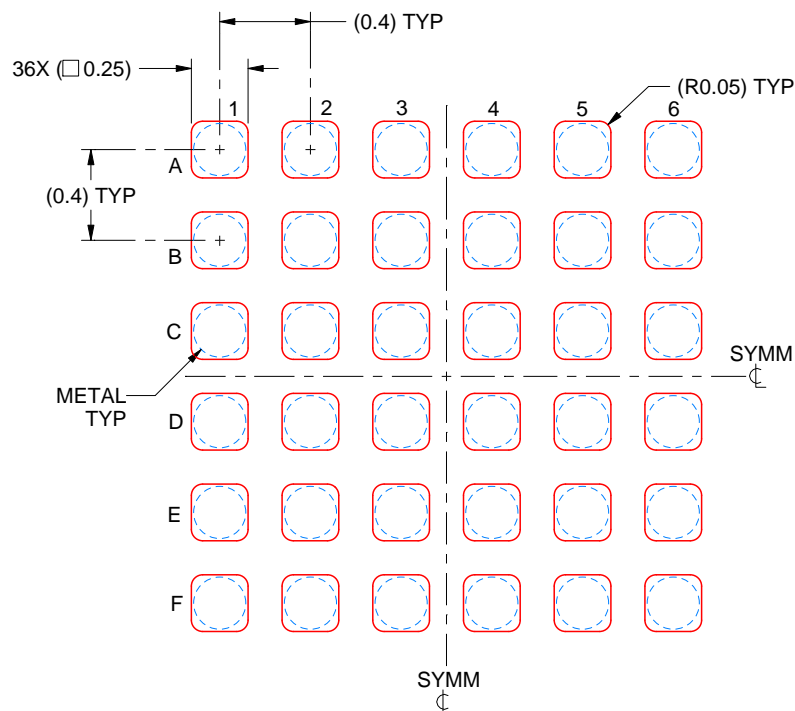
NOTES: (continued)

- Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. See Texas Instruments Literature No. SNVA009 ([www.ti.com/lit/snva009](http://www.ti.com/lit/snva009)).

**YBG0036**

### DSBGA - 0.5 mm max height

## DIE SIZE BALL GRID ARRAY



**SOLDER PASTE EXAMPLE  
BASED ON 0.1 mm THICK STENCIL  
SCALE: 30X**

4224846/A 03/2019

NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.



## 重要なお知らせと免責事項

TI は、技術データと信頼性データ (データシートを含みます)、設計リソース (リファレンス デザインを含みます)、アプリケーションや設計に関する各種アドバイス、Web ツール、安全性情報、その他のリソースを、欠陥が存在する可能性のある「現状のまま」提供しており、商品性および特定目的に対する適合性の黙示保証、第三者の知的財産権の非侵害保証を含むいかなる保証も、明示的または黙示的にかかわらず拒否します。

これらのリソースは、TI 製品を使用する設計の経験を積んだ開発者への提供を意図したものです。(1) お客様のアプリケーションに適した TI 製品の選定、(2) お客様のアプリケーションの設計、検証、試験、(3) お客様のアプリケーションに該当する各種規格や、その他のあらゆる安全性、セキュリティ、規制、または他の要件への確実な適合に関する責任を、お客様のみが単独で負うものとし、TI は一切の責任を拒否します。

上記の各種リソースは、予告なく変更される可能性があります。これらのリソースは、リソースで説明されている TI 製品を使用するアプリケーションの開発の目的でのみ、TI はその使用をお客様に許諾します。これらのリソースに関して、他の目的で複製することや掲載することは禁止されています。TI や第三者の知的財産権のライセンスが付与されている訳ではありません。お客様は、これらのリソースを自身で使用した結果発生するあらゆる申し立て、損害、費用、損失、責任について、TI およびその代理人を完全に補償するものとし、TI は一切の責任を拒否します。

TI の製品は、[TI の販売条件](#)、[TI の総合的な品質ガイドライン](#)、[ti.com](#) または TI 製品などに関連して提供される他の適用条件に従い提供されます。TI がこれらのリソースを提供することは、適用される TI の保証または他の保証の放棄の拡大や変更を意味するものではありません。TI がカスタム、またはカスタマー仕様として明示的に指定していない限り、TI の製品は標準的なカタログに掲載される汎用機器です。

お客様がいかなる追加条項または代替条項を提案する場合も、TI はそれらに異議を唱え、拒否します。

Copyright © 2025, Texas Instruments Incorporated

最終更新日：2025 年 10 月